

AFE7906 具有 3GSPS ADC 的 6 通道、5MHz 至 12GHz 射频采样接收器

1 特性

- [申请完整数据表](#)
- 六个射频采样 14 位、3 GSPS ADC
- 最大射频信号带宽：
 - 4 个 ADC：每个 ADC 为 1200 MHz
 - 6 个 ADC：每个 ADC 为 600 MHz
- 射频频率范围：5 MHz 至 12 GHz
- 数字步进衰减器 (DSA)：25 dB 范围，0.5 dB 步进
- 单频带 DDC (在 6 个通道上) 和双频带 DDC (在 4 个通道上)
- 每个 DDC 通道 16 个 NCO
- 可选内部 PLL/VCO，提供 ADC 采样率下的 ADC 时钟或外部时钟
- Sysref 对齐检测器
- 串行器/解串器数据接口：
 - 可兼容 JESD204B 和 JESD204C
 - 8 个高达 29.5 Gbps 的串行器/解串器发送器
 - 子类 1 多器件同步
- 封装：17mm × 17mm FCBGA，间距 0.8 mm

2 应用

- [雷达](#)
- [导引头前端](#)
- [国防无线电](#)
- [无线通信测试](#)

3 说明

AFE7906 是一款高性能、高带宽、多通道接收器，集成了六个射频采样 ADC。此器件具有高达 12GHz 的工作频率，支持直接在 L、S、C 和 X 带频率范围内进行射频采样，无需额外的频率转换级。密度和灵活性提高后可支持高通道数、多任务系统。

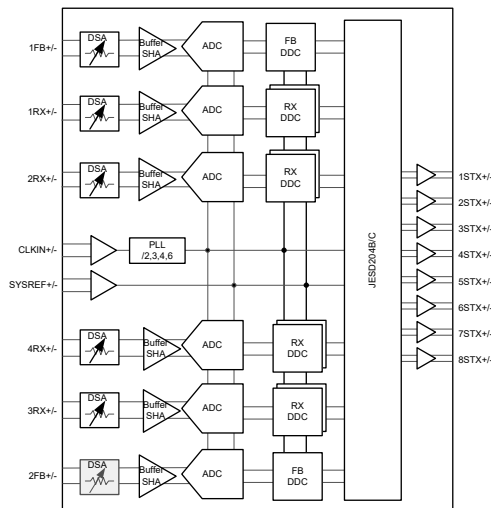
每个接收器链均包含一个 25dB 范围的数字步进衰减器 (DSA)，后跟一个 3GSPS 模数转换器 (ADC)。四个接收器通道都有模拟峰值功耗检测器和各种数字功耗检测器，可辅助进行外部或内部自主自动增益控制器，另外还具有射频过载检测器，用于提供器件可靠性保护。灵活的抽取选项提供高达 1200MHz (对于四个 RX) 或 600MHz 的数据带宽优化。

该器件包含一个 SYSREF 时序检测器，用于优化相对于器件时钟的 SYSREF 输入时序。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
AFE7906	FC-BGA	17.00mm × 17.00mm

- (1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。
- (2) 封装尺寸 (长 × 宽) 为标称值，并包括引脚 (如适用)。



功能方框图



Table of Contents

1 特性	1	6.7 Digital Electrical Characteristics.....	14
2 应用	1	6.8 Power Supply Electrical Characteristics.....	15
3 说明	1	6.9 Timing Requirements.....	17
4 说明 (续)	3	6.10 Switching Characteristics.....	18
5 Revision History	3	6.11 Typical Characteristics.....	19
6 Specifications	4	7 Device and Documentation Support	70
6.1 Absolute Maximum Ratings.....	4	7.1 接收文档更新通知.....	70
6.2 ESD Ratings.....	4	7.2 支持资源.....	70
6.3 Recommended Operating Conditions.....	5	7.3 Trademarks.....	70
6.4 Thermal Information.....	5	7.4 静电放电警告.....	70
6.5 RF ADC Electrical Characteristics.....	6	7.5 术语表.....	70
6.6 PLL/VCO/Clock Electrical Characteristics.....	12	8 Mechanical, Packaging, and Orderable Information..	70

4 说明 (续)

每个接收器链均包含一个 25dB 范围的数字步进衰减器 (DSA)，后跟一个 3GSPS 模数转换器 (ADC)。每个接收器通道都有多个模拟峰值功耗检测器和各种数字功耗检测器，可辅助进行外部或内部自主自动增益控制器，另外还具有一个射频过载检测器，用于提供器件可靠性保护。灵活的抽取选项可为数据带宽提供高达 1200MHz 的优化（对于四条不带 FB 路径的 RX），或为带两条 FB 路径（每条 1200MHz 带宽）提供 600MHz 的优化。

该器件包含一个 SYSREF 时序检测器，用于优化相对于器件时钟的 SYSREF 输入时序。

5 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from July 9, 2022 to May 30, 2023 (from Revision B (July 2022) to Revision C (May 2023))

	Page
• 将“器件信息”更改为封装信息表.....	1
• Changed I _{IH} and I _{IL} units to μ A.....	14

Changes from March 11, 2022 to July 8, 2022 (from Revision A (March 2022) to Revision B (July 2022))

	Page
• Deleted ABJ from the Thermal Information table. The table applies to both ABJ and the ALK packages.....	4
• Changed 0RX - 3RX to 1RX - 4RX in several plots.....	42
• Changed 0RX - 3RX to 1RX - 4RX in several plots.....	47

Changes from Revision * (January 2022) to Revision A (March 2022)

	Page
• 向“申请完整数据表”添加了特性	1
• Added the Specification tables to the data sheet.....	4
• Changed Power Mode 4 to $f_{RX} = 2.25$ GHz.....	15
• Added the Typical Characteristics section to the data sheet.....	19

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply Voltage Range	DVDD0P9, VDDT0P9	– 0.3	1.2	V
	VDD1P2RX, VDD1P2TXCLK, VDD1P2TXENC, VDD1P2PLL, VDD1P2PLLCLKREF, VDD1P2FB, VDD1P2FBCML, VDD1P2RXCML	– 0.3	1.4	V
	VDD1P8RX, VDD1P8RXCLK, VDD1P8TX, VDD1P8TXDAC, VDD1P8TXENC, VDD1P8PLL, VDD1P8PLLVC0, VDD1P8FB, VDD1P8FBCLK, VDD1P8GPIO, VDDA1P8	– 0.5	2.1	V
Pin Voltage Range	{1/2/3/4}RXIN+/-	– 0.5	VDDR1P8+0.3	V
	1FBIN+/-, 2FB+/-	– 0.5	VDDFB1P8+0.3	V
	REFCLK+/-, SYSREF+/-	– 0.3	1.4	V
	{1:8}STX+/-	– 0.3	1.4	V
	GPIO{B/C/D/E}x, SPICLK, SPISDIO, SPISDO, SPISEN, RESETZ, BISTB0, BISTB1	– 0.5	VDD1P8GPIO + 0.3	V
	IFORCE, VSENSE	– 0.3	VDDCLK1P8 + 0.3	V
	SRDAMUX1, SRDAMUX2	– 0.3	VDDA1P8+0.3	V
Peak Input Current	any input		20	mA
T _J	Junction temperature		150	°C
T _{stg}	Storage temperature	– 65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Conditions](#). Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	1000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins ⁽²⁾	150	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible if necessary precautions are taken.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
DVDD0P9, VDDT0P9	Supply voltage 0.9V	0.9	0.925	0.95	V
VDD1P2{RX/TXCLK/TXENC/FB/PLL/ PLLCLKREF/FBCML/RXCML}	Supply voltage 1.2V	1.15	1.2	1.25	V
VDD1P8{RX/RXCLK/TX/TXDAC/ TXENC/PLL/PLLVCO/FB/FBCLK/ GPIO}, VDDA1P8	Supply voltage 1.8V	1.75	1.8	1.85	V
T _A	Ambient temperature	– 40		85	°C
T _J	Operating Junction Temperature			110 ⁽¹⁾	°C
	Maximum Operating Junction Temperature	125			°C

- (1) Prolonged use at or above this junction temperature can increase the device failure-in-time (FIT) rate. Refer to [SBAA403 application note](#) for additional details

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		AFE7906	UNIT
		FC-BGA	
		400 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	16.2	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	0.42	°C/W
R _{θJB}	Junction-to-board thermal resistance	4.85	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	0.12	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	4.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 RF ADC Electrical Characteristics

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting = 3dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADC _{RES}	ADC resolution			14		bits
F _{RFin}	RF input frequency range		5		12000	MHz
P _{FS,CW,min}	Min Full scale input power, at device pins ⁽¹⁾	$f_{\text{IN}} = 5\text{ MHz}$, DSA=0dB, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-0.4		dBm
		$f_{\text{IN}} = 30\text{ MHz}$, DSA=0dB, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		-2.2		
		$f_{\text{IN}} = 410\text{ MHz}$, DSA=0dB, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 12		-2.5		
		$f_{\text{IN}} = 830\text{ MHz}$, DSA=0dB		-2.9		
		$f_{\text{IN}} = 1760\text{ MHz}$, DSA=0dB		-2.8		
		$f_{\text{IN}} = 2610\text{ MHz}$, DSA=0dB		-1.8		
		$f_{\text{IN}} = 3610\text{ MHz}$, DSA=0dB		-0.4		
		$f_{\text{IN}} = 4910\text{ MHz}$, DSA=0dB		0.1		
		$f_{\text{IN}} = 8150\text{ MHz}$, DSA=0dB		2.1		
		$f_{\text{IN}} = 9610\text{ MHz}$, DSA=0dB		4.3		
P _{FS,CW,MAX}	MAX Full scale input power - reliability limited, at device pins	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		19.7		dBm
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		17.8		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		17.6		
		$f_{\text{IN}} = 830\text{ MHz}$		16.7		
		$f_{\text{IN}} = 1760\text{ MHz}$		17.0		
		$f_{\text{IN}} = 2610\text{ MHz}$		18		
		$f_{\text{IN}} = 3610\text{ MHz}$		18.5		
		$f_{\text{IN}} = 4910\text{ MHz}$		19.3		
		$f_{\text{IN}} = 8150\text{ MHz}$		21.3		
		$f_{\text{IN}} = 9610\text{ MHz}$		23.5		
R _{TERM}	Input reference impedance			100.0		Ω
ATT _{range}	DSA Attenuation range			25.0		dB
ATT _{step}	DSA Attenuation step			0.5		dB
	DSA Attenuation step accuracy	Delta=Gatt(X)-Gatt(X-1), $F_{\text{in}}=3610\text{MHz}$, after calibration		0.1		
	DSA Gain Steps Phase accuracy any 8dB range	$F_{\text{in}}=3610\text{MHz}$, after calibration		0.9		deg
	DSA Gain Steps Phase accuracy any 8dB range	$F_{\text{in}}=4910\text{MHz}$, after calibration		1.8		
G _{flat}	Gain flatness	Measured Over 80MHz BW		0.2		dB
		Measured Over 200MHz BW		0.5		
		Measured Over 400MHz BW		1.1		

6.5 RF ADC Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
NSD	Noise Density (small signal = -30dBFS)	$f_{\text{IN}} = 5\text{ MHz}$, DSA = 3dB, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48	-147.1		dBFS/Hz
		$f_{\text{IN}} = 30\text{ MHz}$, DSA = 3dB, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24	-150.7		
		$f_{\text{IN}} = 410\text{ MHz}$, DSA = 3dB, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24	-155.4		
		$f_{\text{IN}} = 830\text{ MHz}$, DSA = 3dB ⁽³⁾	-156.2		
		$f_{\text{IN}} = 1760\text{ MHz}$, DSA = 3dB ⁽³⁾	-156.0		
		$f_{\text{IN}} = 2610\text{ MHz}$, DSA = 3dB ⁽³⁾	-155.4		
		$f_{\text{IN}} = 3610\text{ MHz}$, DSA = 3dB ⁽³⁾	-155.1		
		$f_{\text{IN}} = 4910\text{ MHz}$, DSA = 3dB ⁽³⁾	-155.1		
		$f_{\text{IN}} = 8110\text{ MHz}$, DSA = 3dB ⁽³⁾	-152		
		$f_{\text{IN}} = 9610\text{ MHz}$, DSA = 3dB ⁽³⁾	-151		
		$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48, 3<=Atten<=22	-147.8		
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24, 3<=Atten<=22	-151.5		
		$f_{\text{IN}} = 410\text{ MHz}$, 3<=Atten<=22, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24	-156.6		
		$f_{\text{IN}} = 830\text{ MHz}$, 3<=Atten<=22	-156.0		
		$f_{\text{IN}} = 1760\text{ MHz}$, 3<=Atten<=25	-155.8		
		$f_{\text{IN}} = 2610\text{ MHz}$, 3<=Atten<=25	-155.7		
		$f_{\text{IN}} = 3610\text{ MHz}$, 3<=Atten<=25	-155.4		
		$f_{\text{IN}} = 4910\text{ MHz}$, 3<=Atten<=25	-155.8		
		$f_{\text{IN}} = 8150\text{ MHz}$, 3<=Atten<=25	-152.5		
		$f_{\text{IN}} = 9610\text{ MHz}$, 3<=Atten<=25	-152.5		
NF _{min}	Noise Figure min DSA Atten=0 - 3dB	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48	29.4		dB
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24	24.5		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24	19.3		
		$f_{\text{IN}} = 830\text{ MHz}$	19.1		
		$f_{\text{IN}} = 1760\text{ MHz}$	19.0		
		$f_{\text{IN}} = 2610\text{ MHz}$	20.9		
		$f_{\text{IN}} = 3610\text{ MHz}$	22.8		
		$f_{\text{IN}} = 4910\text{ MHz}$	22.4		
		$f_{\text{IN}} = 8150\text{ MHz}$	27.3		
		$f_{\text{IN}} = 9610\text{ MHz}$	30		

6.5 RF ADC Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting = 3dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
NF	Noise Figure ⁽⁴⁾ DSA Atten=4dB	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		30.6		dB
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		25.1		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		20.1		
		$f_{\text{IN}} = 830\text{ MHz}$		20.0		
		$f_{\text{IN}} = 1760\text{ MHz}$		20.6		
		$f_{\text{IN}} = 2610\text{ MHz}$		21.9		
		$f_{\text{IN}} = 3610\text{ MHz}$		23.5		
		$f_{\text{IN}} = 4910\text{ MHz}$		22.3		
		$f_{\text{IN}} = 8150\text{ MHz}$		27.9		
		$f_{\text{IN}} = 9610\text{ MHz}$		30.7		
NF _{max}	Noise Figure ⁽⁴⁾ DSA Atten=20dB	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		45.9		dB
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		40.2		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		35.0		
		$f_{\text{IN}} = 830\text{ MHz}$		34.7		
		$f_{\text{IN}} = 1760\text{ MHz}$		35.2		
		$f_{\text{IN}} = 2610\text{ MHz}$		36.0		
		$f_{\text{IN}} = 3610\text{ MHz}$		37.3		
		$f_{\text{IN}} = 4910\text{ MHz}$		37.6		
		$f_{\text{IN}} = 8150\text{ MHz}$		42.8		
		$f_{\text{IN}} = 9610\text{ MHz}$		45		
IMD3	3 rd order intermodulation 2 tones at at $f_{\text{IN}} \pm 10\text{MHz}$ -7dBFS each tone	$f_{\text{IN}} = 30 \pm 1\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		-82		dBc
		$f_{\text{IN}} = 400\text{MHz}$ and 405MHz , $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		-75		
		$f_{\text{IN}} = 840\text{ MHz}$, $3 \leq \text{Atten} \leq 12$		-82		
		$f_{\text{IN}} = 1770\text{ MHz}$, $3 \leq \text{Atten} \leq 12$		-84		
		$f_{\text{IN}} = 2610\text{ MHz}$, $3 \leq \text{Atten} \leq 12$		-74		
		$f_{\text{IN}} = 3610\text{ MHz}$, $3 \leq \text{Atten} \leq 12$		-77		
		$f_{\text{IN}} = 4920\text{ MHz}$, $3 \leq \text{Atten} \leq 12$		-76		
		$f_{\text{IN}} = 8150\text{ MHz}$, $3 \leq \text{Atten} \leq 12$, 25MHz tone spacing		-59		
		$f_{\text{IN}} = 9610\text{ MHz}$, $3 \leq \text{Atten} \leq 12$, 25MHz tone spacing		-60		

6.5 RF ADC Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting = 3dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SFDR	Spurious Free Dynamic Range within output bandwidth, $A_{\text{IN}} = -3\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		78		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		100		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		94		
		$f_{\text{IN}} = 830\text{ MHz}$		88		
		$f_{\text{IN}} = 1760\text{ MHz}$		81		
		$f_{\text{IN}} = 2610\text{ MHz}$		88		
		$f_{\text{IN}} = 3610\text{ MHz}$		84		
		$f_{\text{IN}} = 4910\text{ MHz}$		79		
		$f_{\text{IN}} = 8150\text{ MHz}$		78		
		$f_{\text{IN}} = 9610\text{ MHz}$		71		
HD2	2nd Harmonic Distortion $A_{\text{IN}} = -3\text{ dBFS}$ ⁽²⁾	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-84		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, Bypass Mode (TI only test mode)		-91		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, Bypass Mode (TI only test mode)		-90		
		$f_{\text{IN}} = 830\text{ MHz}$		-86		
		$f_{\text{IN}} = 1760\text{ MHz}$		-90		
		$f_{\text{IN}} = 2610\text{ MHz}$		-88		
		$f_{\text{IN}} = 3610\text{ MHz}$		-87		
		$f_{\text{IN}} = 4910\text{ MHz}$		-84		
		$f_{\text{IN}} = 8150\text{ MHz}$		-70		
HD3	3rd Harmonic Distortion $A_{\text{IN}} = -3\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-78		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, Bypass Mode (TI only test mode)		-96		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, Bypass Mode (TI only test mode)		-94		
		$f_{\text{IN}} = 830\text{ MHz}$		-80		
		$f_{\text{IN}} = 1760\text{ MHz}$		-85		
		$f_{\text{IN}} = 2610\text{ MHz}$		-86		
		$f_{\text{IN}} = 3610\text{ MHz}$		-78		
		$f_{\text{IN}} = 4910\text{ MHz}$		-75		
		$f_{\text{IN}} = 8150\text{ MHz}$		-70		
HD3	3rd Harmonic Distortion $A_{\text{IN}} = -3\text{ dBFS}$	$f_{\text{IN}} = 9610\text{ MHz}$		-70		dBFS

6.5 RF ADC Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{A,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting = 3dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
HDn, n>3	SFDR excl. HD2 and HD3 $A_{\text{IN}} = -3\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-94		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		-94		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		-94		
		$f_{\text{IN}} = 830\text{ MHz}$		-88		
		$f_{\text{IN}} = 1760\text{ MHz}$		-81		
		$f_{\text{IN}} = 2610\text{ MHz}$		-88		
		$f_{\text{IN}} = 3610\text{ MHz}$		-84		
		$f_{\text{IN}} = 4910\text{ MHz}$		-82		
		$f_{\text{IN}} = 8150\text{ MHz}$		-78		
		$f_{\text{IN}} = 9610\text{ MHz}$		-71		
SFDR	Spurious Free Dynamic Range $A_{\text{IN}} = -13\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		101		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		105		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		95		
		$f_{\text{IN}} = 830\text{ MHz}$		89		
		$f_{\text{IN}} = 1760\text{ MHz}$		89		
		$f_{\text{IN}} = 2610\text{ MHz}$		95		
		$f_{\text{IN}} = 3610\text{ MHz}$		87		
		$f_{\text{IN}} = 4910\text{ MHz}$		90		
		$f_{\text{IN}} = 8150\text{ MHz}$		83		
HD2	2nd Harmonic Distortion ⁽²⁾ $A_{\text{IN}} = -13\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-104		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, Bypass Mode (TI only test mode)		-91		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, Bypass Mode (TI only test mode)		-104		
		$f_{\text{IN}} = 830\text{ MHz}$, with board trim		-79		
		$f_{\text{IN}} = 1760\text{ MHz}$, with board trim		-102		
		$f_{\text{IN}} = 2610\text{ MHz}$, with board trim		-100		
		$f_{\text{IN}} = 3610\text{ MHz}$, with board trim		-101		
		$f_{\text{IN}} = 4910\text{ MHz}$, with board trim		-99		
		$f_{\text{IN}} = 8150\text{ MHz}$, with board trim		-107		
		$f_{\text{IN}} = 9610\text{ MHz}$, with board trim		-107		

6.5 RF ADC Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{A,\text{MAX}} = +110^\circ\text{C}$; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, $f_{\text{ADC}} = 2949.12\text{MSPS}$; PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$ below 6GHz input frequency and External clock mode with $f_{\text{CLK}} = 2949.12\text{MHz}$ above 6GHz input frequency; nominal power supplies; DSA Setting = 3dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
HD3	3rd Harmonic Distortion $A_{\text{IN}} = -13\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-103		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, Bypass Mode (TI only test mode)		-84		
		$f_{\text{IN}} = 381\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, Bypass Mode (TI only test mode)		-91		
		$f_{\text{IN}} = 830\text{ MHz}$		-95		
		$f_{\text{IN}} = 1760\text{ MHz}$		-95		
		$f_{\text{IN}} = 2610\text{ MHz}$		-98		
		$f_{\text{IN}} = 3610\text{ MHz}$		-97		
		$f_{\text{IN}} = 4910\text{ MHz}$		-94		
		$f_{\text{IN}} = 8150\text{ MHz}$		-100		
		$f_{\text{IN}} = 9610\text{ MHz}$		-102		
HDn, n>3	SFDR excl. HD2 and HD3 $A_{\text{IN}} = -13\text{ dBFS}$	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-104		dBFS
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		-105		
		$f_{\text{IN}} = 410\text{ MHz}$, $f_{\text{ADC}} = 3000\text{MSPS}$, $f_{\text{NCO}} = 400\text{MHz}$, Decimate by 24		-95		
		$f_{\text{IN}} = 830\text{ MHz}$		-89		
		$f_{\text{IN}} = 1760\text{ MHz}$		-89		
		$f_{\text{IN}} = 2610\text{ MHz}$		-95		
		$f_{\text{IN}} = 3610\text{ MHz}$		-90		
		$f_{\text{IN}} = 4910\text{ MHz}$		-90		
		$f_{\text{IN}} = 8150\text{ MHz}$		-83		
RX-RX/FB Isolation	Near Channel: 1RXIN to 2RXIN 3RXIN to 4RXIN 1FBIN to 1RXIN 2FBIN to 3RXIN	$f_{\text{IN}} = 5\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 17\text{MHz}$, Decimate by 48		-98		dB
		$f_{\text{IN}} = 30\text{ MHz}$, $f_{\text{ADC}} = 1500\text{MSPS}$, $f_{\text{NCO}} = 30\text{MHz}$, Decimate by 24		-98		
		$f_{\text{IN}} = 400\text{ MHz}$		-88		
		$f_{\text{IN}} = 830\text{ MHz}$		-77		
		$f_{\text{IN}} = 1760\text{ MHz}$		-71		
		$f_{\text{IN}} = 2610\text{ MHz}$		-74		
		$f_{\text{IN}} = 3610\text{ MHz}$		-77		
		$f_{\text{IN}} = 4910\text{ MHz}$		-65		
		$f_{\text{IN}} = 8150\text{ MHz}$		-68		
		$f_{\text{IN}} = 9610\text{ MHz}$		-68		

- (1) The input fullscale at minimum attenuation can be reduce by adding a digital gain range to the DSA, extending the useful range of the DSA. The noise figure remains constant over the digital gain range.
- (2) After HD2 trim on specific printed circuit board.
- (3) From DSA = 3dB down to 0dB, NSD increases 1dB per DSA dB
- (4) NF increase 1dB per DSA 1dB above DSA = 3dB

6.6 PLL/VCO/Clock Electrical Characteristics

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{A,\text{MAX}} = +110^\circ\text{C}$; Reference clock input frequency 491.52MHz (unless otherwise noted), phase noise normalized to f_{VCO} .

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{VCO1}	VCO1 min frequency				7.2	GHz
	VCO1 max frequency		7.68			GHz
f_{VCO2}	VCO2 min frequency				8.848	GHz
	VCO2 max frequency		9.216			GHz
f_{VCO3}	VCO3 min frequency				9.8304	GHz
	VCO3 max frequency		10.24			GHz
f_{VCO4}	VCO4 min frequency				11.7965	GHz
	VCO4 max frequency		12.288			GHz
$\text{DIV}_{\text{FBADC}}$	ADC sample rate divider from VCO rate			1, 2, 3, 4, 6 or 8		
$\text{DIV}_{\text{RXADC}}$	ADC sample rate divider			1, 2, 3, 4, 6 or 8		
PN_{VCO}	Closed Loop Phase Noise $F_{\text{PLL}} = 11.79848 \text{ GHz}$ $F_{\text{REF}} = 491.52 \text{ MHz}$	600kHz		-113		dBc/Hz
		800kHz		-116		dBc/Hz
		1MHz		-119		dBc/Hz
		1.8MHz		-125		dBc/Hz
		5MHz		-133		dBc/Hz
		50MHz		-141		dBc/Hz
	Closed Loop Phase Noise $F_{\text{PLL}} = 8.84736 \text{ GHz}$ $F_{\text{REF}} = 491.52 \text{ MHz}$	600kHz		-114		dBc/Hz
		800kHz		-118		dBc/Hz
		1MHz		-120		dBc/Hz
		1.8MHz		-127		dBc/Hz
		5MHz		-135		dBc/Hz
		50MHz		-142		dBc/Hz
	Closed Loop Phase Noise $F_{\text{PLL}} = 9.8403 \text{ GHz}$ $F_{\text{REF}} = 491.52 \text{ MHz}$	600kHz		-113		dBc/Hz
		800kHz		-116		dBc/Hz
		1MHz		-119		dBc/Hz
		1.8MHz		-125		dBc/Hz
		5MHz		-134		dBc/Hz
		50MHz		-140		dBc/Hz
	Closed Loop Phase Noise $F_{\text{PLL}} = 7.86432 \text{ GHz}$ $F_{\text{REF}} = 491.52 \text{ MHz}$	600kHz		-116		dBc/Hz
		800kHz		-119		dBc/Hz
		1MHz		-122		dBc/Hz
		1.8MHz		-127		dBc/Hz
		5MHz		-136		dBc/Hz
		50MHz		-143		dBc/Hz
F_{rms}	Clock PLL integrated phase error ⁽¹⁾	$f_{\text{PLL}} = 11.79848 \text{ GHz}$, [1KHz, 100MHz]		-43.4		dBc/Hz
		$f_{\text{PLL}} = 8.8536 \text{ GHz}$, [1KHz, 100MHz]		-47.6		dBc/Hz
		$f_{\text{PLL}} = 9.8304 \text{ GHz}$, [1KHz, 100MHz]		-46.2		dBc/Hz
f_{PFD}	PFD frequency		100		500	MHz
$\text{PN}_{\text{pll_flat}}$	Normalized PLL flat Noise	$f_{\text{VCO}} = 11796.48 \text{ MHz}$		-226.5		dBc/Hz
F_{REF}	Input Clock frequency		0.1		12	GHz

6.6 PLL/VCO/Clock Electrical Characteristics (continued)

Typical values at $T_A = +25^{\circ}\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^{\circ}\text{C}$ to $T_{J,\text{MAX}} = +110^{\circ}\text{C}$; Reference clock input frequency 491.52MHz (unless otherwise noted), phase noise normalized to f_{VCO} .

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{SS}	Input Clock level		0.6		1.8	Vppdiff
Coupling				AC Coupling Only		
	REFCLK input impedance ⁽²⁾	Parallel resistance		100		Ω
		Parallel capacitance		0.5		pF

(1) Single Sideband, not including the reference clock contribution

(2) Refer to S11 data available from TI for impedance vs frequency

6.7 Digital Electrical Characteristics

Typical values at TA = +25°C, full temperature range is T_{A,MIN} = -40°C to T_{J,MAX} = +110°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
CML SerDes Outputs [8:1]STX+/-						
F _{SerDes}	SerDes Bit Rate	Full rate mode	19		29.5	Gbps
		Half rate mode	9.5		16.25	
		Quarter rate mode	4.75		8.125	
		1/8 th rate mode	2.375		4.062	
		1/16 th rate mode	1.1875		2.031	
T _J	Total Jitter Tolerance				0.42	UI
V _{STDIFF}	SerDes Transmitter Output Amplitude	differential	500		1000	mVpp
V _{STCOM}	SerDes Output Common Mode		0.4	0.45	0.55	V
Z _{STdiff}	SerDes Output Impedance			100		Ω
TRF	Output rise and fall time	20-80%	8			ps
TTJ	Output total jitter				0.21	UI
CMOS I/O: GPIO{B/C/D/E}x, SPICLK, SPISDIO, SPISDO, SPISEN, RESETZ, BISTB0, BISTB1						
V _{IH}	High-Level Input Voltage		0.6×VDD1 P8GPIO			V
V _{IL}	Low-Level Input Voltage			0.4×VDD1 P8GPIO		V
I _{IH}	High-Level Input Current		- 250		250	μA
I _{IL}	Low-Level Input Current		- 250		250	μA
C _L	CMOS input capacitance			2		pF
V _{OH}	High-Level Output Voltage		VDD1P8G PIO - 0.2			V
V _{OL}	Low-Level Output Voltage				0.2	V
Differential Inputs: SYSREF+/- Mode A						
F _{SYSREFMAX}	SYSREF Input Frequency Maximum			40		MHz
V _{SWINGSRMAX}	SYSREF Input Swing Maximum			1.8		Vppdiff ⁽²⁾
V _{SWINGSRMIN}	SYSREF Input Swing Minimum	f _{REF} < 500MHz		0.3		Vppdiff ⁽²⁾
V _{SWINGSRMIN}	SYSREF Input Swing Minimum	f _{REF} > 500MHz		0.6		Vppdiff ⁽²⁾
V _{COMSRMAX}	SYSREF Input Common Mode Voltage Maximum			0.8		V
V _{COMSRMIN}	SYSREF Input Common Mode Voltage Minimum			0.6		V
Z _T	Input termination	differential		100 ⁽¹⁾		Ω
C _L	Input capacitance	Each pin to GND		0.5		pF
LVDS Inputs: 0SYNCIN+/- and 1SYNCIN+/-						
V _{ICOM}	Input Common Voltage			1.2		V
V _{ID}	Differential Input Voltage swing			450		Vppdiff ⁽²⁾
Z _T	Input termination	differential		100		Ω
LVDS Outputs: 0SYNCOUT+/- and 1SYNCOUT+/-						
V _{OCOM}	Output Common Voltage			1.2		V
V _{OD}	Differential Output Voltage swing			500		Vppdiff ⁽²⁾
Z _T	Internal Termination			100		Ω

(1) SYSREF termination is programmable between 100 Ω, 150 Ω and 300 Ω

(2) Vppdiff is the difference between the maximum differential voltage (positive value) and minimum differential voltage (negative value).

6.8 Power Supply Electrical Characteristics

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,MIN} = -40^\circ\text{C}$ to $T_{J,MAX} = +110^\circ\text{C}$; $f_{ADC} = 2949.12\text{MSPS}$; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation = 0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 1: 4R, $f_{ADC} = 3\text{ GSPS}$, $DDC_{RX} = 6\times$ Decimation, $f_{RX} = 1.85\text{ GHz}$, 8b/10b coding, 20 Gbps, RX: 4-8-4-1		673		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			376		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVC0			17.5		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			557		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			75		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			68		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			1582		mA
P_{diss}	Power Dissipation			4208		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 2: 4R2F, $f_{ADC} = 3\text{ GSPS}$, $DDC_{FB} = DDC_{RX} = 6\times$ Decimation, $f_{RX} = 1.85\text{ GHz}$, 8b/10b coding, 20 Gbps, RX: 4-8-4-1, FB: 2-4-4-1		1006		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			548		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVC0			17.5		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			839		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			92		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			68		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2174		mA
P_{diss}	Power Dissipation			5996		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 4: 4R, $f_{ADC} = 3\text{ GSPS}$, $DDC_{RX} = 2\times$ Decimation, $f_{RX} = 2.25\text{ GHz}$, 64/66 coding, 24.75 Gbps, RX: 8-8-2-1		672		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			506		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVC0			17.5		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			552		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			76		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			68		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			1613		mA
P_{diss}	Power Dissipation			4468		mW

6.8 Power Supply Electrical Characteristics (continued)

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{A,\text{MAX}} = +110^\circ\text{C}$; $f_{\text{ADC}} = 2949.12\text{MSPS}$; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation = 0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 5: 4R2F, $f_{\text{ADC}} = 3\text{GSPS}$, $\text{DDC}_{\text{RX}} = 12\text{x Decimation Dual Channel}$, $\text{DDC}_{\text{FB}} = 3\text{x Decimation}$, $f_{\text{RX}} = 1.85$ and 2.65GHz , 8b/10b coding, 20 Gbps, RX: 4-16-8-1, FB: 4-4-4-1		1005		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			562		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLCO			17.5		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			837		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			92		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			68		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2359		mA
P_{diss}	Power Dissipation			6195		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 6: 4R, $f_{\text{ADC}} = 3\text{GSPS}$, $\text{DDC}_{\text{RX}} = 12\text{x Decimation Dual Channel}$, $f_{\text{RX}} = 1.85$ and 2.65GHz , 8b/10b coding, 20 Gbps, RX: 4-16-8-1		671		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			374		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLCO			17.5		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			555		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			75		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			67		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			1702		mA
P_{diss}	Power Dissipation			4305		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 7: same configuration as mode 2, Sleep Mode. SLEEP pin is pull high.		16		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC + VDD1P8GPIO + VDDA1P8			295		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLCO			12		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			4		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			24		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			45		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			156		mA
P_{diss}	Power Dissipation			818		mW

6.9 Timing Requirements

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; $f_{\text{ADC}} = 2949.12\text{MSPS}$; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation = 0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

		MIN	NOM	MAX	UNIT
Timing: SYSREF+/-					
$t_{\text{s}}(\text{SYSREF})$	Setup Time, SYSREF+/- Valid to Rising Edge of CLK+/-		50		ps
$t_{\text{h}}(\text{SYSREF})$	Hold Time, SYSREF+/- Valid after Rising Edge of CLK+/-		50		ps
Timing: Serial ports					
$t_{\text{s}}(\text{SENB})$	Setup Time, SENB to Rising Edge of SCLK		15		ns
$t_{\text{h}}(\text{SENB})$	Hold Time, SENB after last Rising Edge of SCLK ⁽¹⁾		$5 + t_{\text{SCLK}}$		ns
$t_{\text{s}}(\text{SDIO})$	Setup Time, SDIO valid to Rising Edge of SCLK		15		ns
$t_{\text{h}}(\text{SDIO})$	Hold Time, SDIO valid after Rising Edge of SCLK		5		ns
$t_{\text{SCLK_W}}$	Minimum SCLK period: registers write		25		ns
$t_{\text{SCLK_R}}$	Minimum SCLK period: registers read		50		ns
$t_{\text{d}}(\text{data_out})$	Minimum Data Output delay after Falling Edge of SCLK		0		ns
	Maximum Data Output delay after Falling Edge of SCLK		15		ns
t_{RESET}	Minimum RESETZ Pulse Width		1		ms

(1) SDEN\ need to be held one more extra clock cycle with the last SCLK edge

6.10 Switching Characteristics

Typical values at $T_A = +25^\circ\text{C}$, full temperature range is $T_{A,\text{MIN}} = -40^\circ\text{C}$ to $T_{J,\text{MAX}} = +110^\circ\text{C}$; $f_{\text{ADC}} = 2949.12\text{MSPS}$; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation = 0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
RX Channel Latency						
t _{JESDRX}	RX input to JESD output Latency	LMFS=2-16-16-1, 122.88 MSPS, 24x Decimation, Serdes rate = 16.22Gbps (JESD204C)		92		interface clock cycles ⁽¹⁾
		LMFS=4-16-8-1, 245.76 MSPS, 12x Decimation, Serdes rate = 16.22Gbps (JESD204C)		108		
		LMFS=2-8-8-1, 368.64 MSPS, 8x Decimation, Serdes rate = 16.22Gbps (JESD204C)		118		
		LMFS=4-8-4-1, 491.52 MSPS, 6x Decimation, Serdes rate = 16.22Gbps (JESD204C)		153		
FB Channel Latency						
	SerDes Transmitter Analog Delay			3.6		ns
t _{JESDFB}	FB input to JESD output Latency	LMFS=1-2-8-1, 368.64 MSPS, 8x Decimation		151		interface clock cycles ⁽¹⁾
		LMFS=2-4-4-1, 491.52 MSPS, 6x Decimation		177		

(1) Interface clock cycles is the period of the digital interface clock rate, e.g. 1GSPS = 1ns.

6.11.1 RX Typical Characteristics 30 MHz and 400 MHz

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.

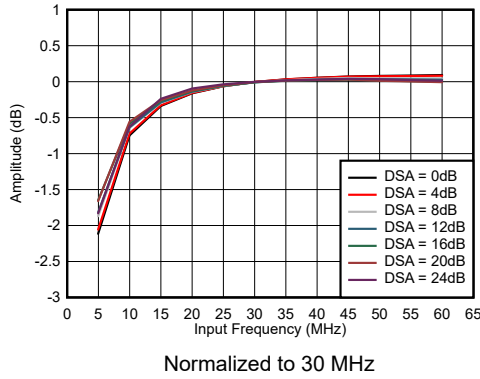
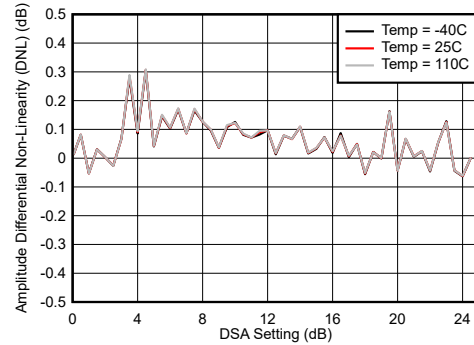
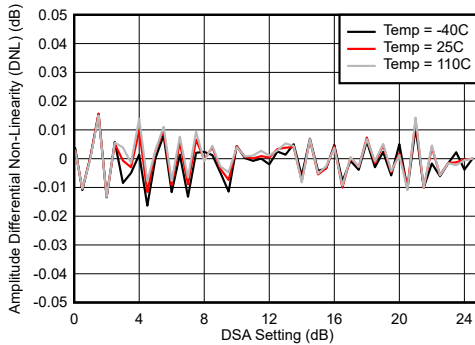


图 6-1. RX In-Band Gain Flatness, $f_{\text{IN}} = 30\text{ MHz}$



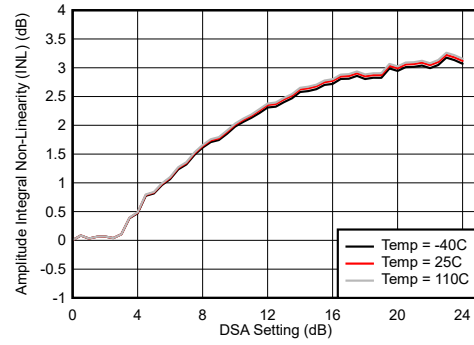
$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-2. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 30 MHz



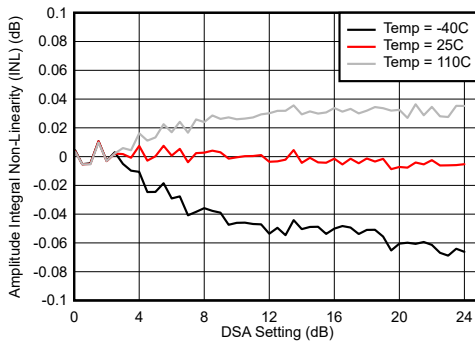
$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-3. RX Calibrated Differential Amplitude Error vs DSA Setting at 30 MHz



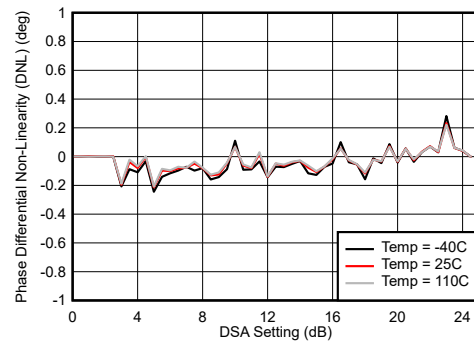
$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-4. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 30 MHz



$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-5. RX Calibrated Integrated Amplitude Error vs DSA Setting at 30 MHz

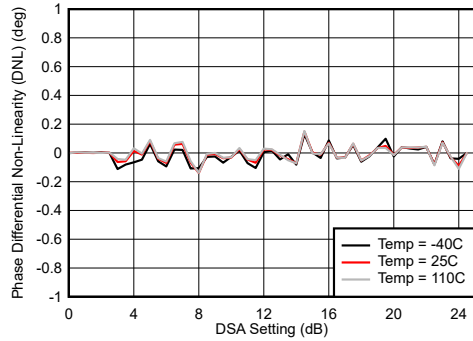


$$\text{Differential Phase Error} = \text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$$

图 6-6. RX Uncalibrated Differential Phase Error vs DSA Setting at 30 MHz

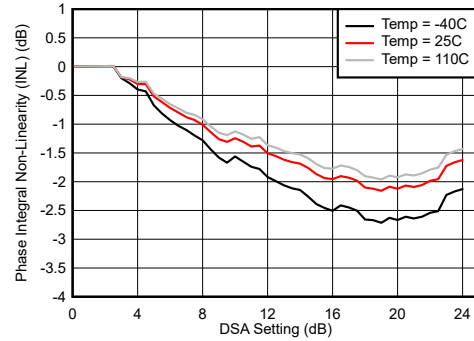
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



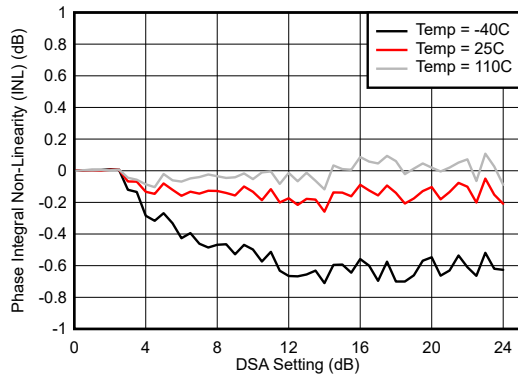
$$\text{Differential Phase Error} = \text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$$

图 6-7. RX Calibrated Differential Phase Error vs DSA Setting at 30 MHz



$$\text{Integrated Phase Error} = \text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$$

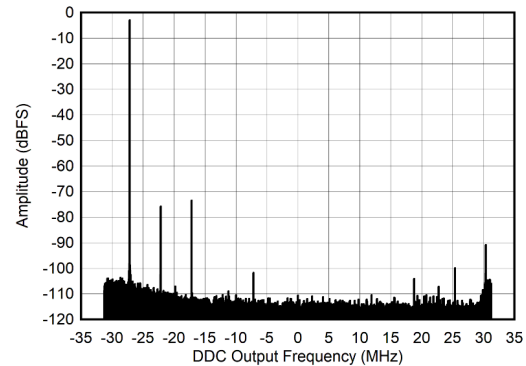
图 6-8. RX Uncalibrated Integrated Phase Error vs DSA Setting at 30 MHz



With 0.8 GHz matching

$$\text{Integrated Phase Error} = \text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$$

图 6-9. RX Calibrated Integrated Phase Error vs DSA Setting at 30 MHz

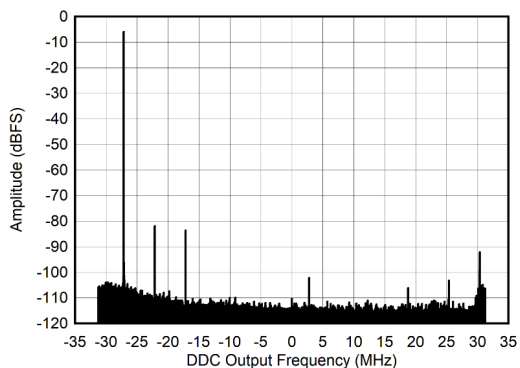


$A_{\text{IN}} = -3\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$,
Decimate by 24x

图 6-10. RX Output FFT at 5 MHz

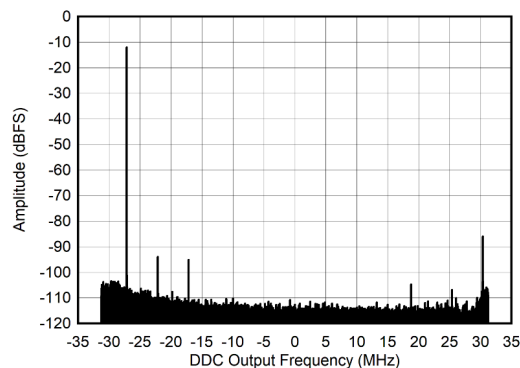
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



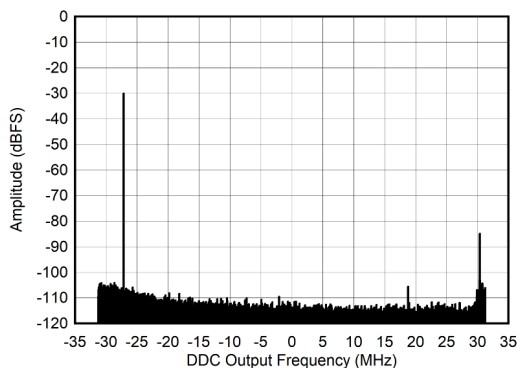
$A_{\text{IN}} = -6\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.$, Decimate by 24x

图 6-11. RX Output FFT at 5 MHz



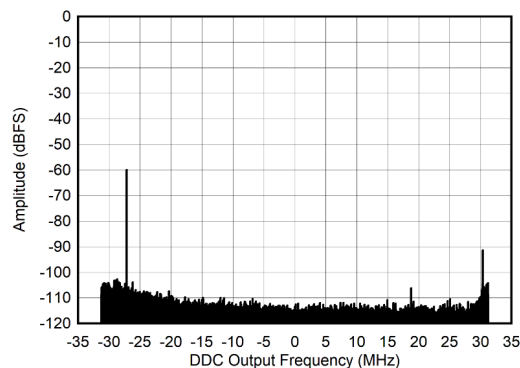
$A_{\text{IN}} = -12\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-12. RX Output FFT at 5 MHz



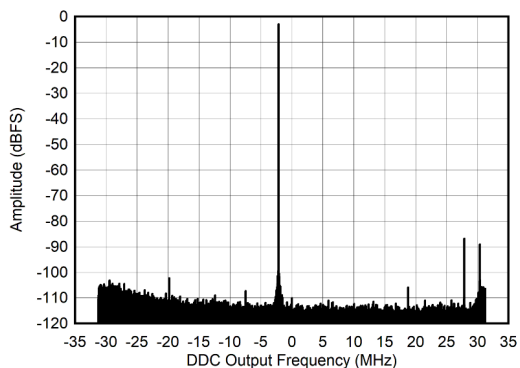
$A_{\text{IN}} = -30\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-13. RX Output FFT at 5 MHz



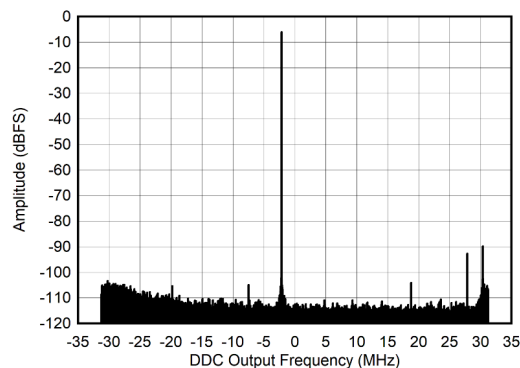
$A_{\text{IN}} = -60\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-14. RX Output FFT at 5 MHz



$A_{\text{IN}} = -3\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-15. RX Output FFT at 30 MHz

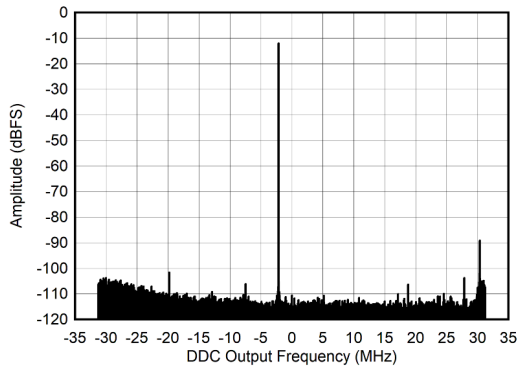


$A_{\text{IN}} = -6\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-16. RX Output FFT at 30 MHz

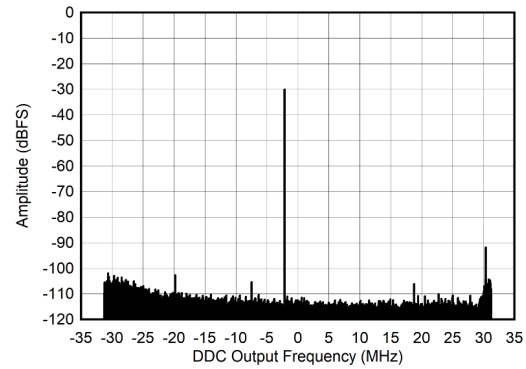
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



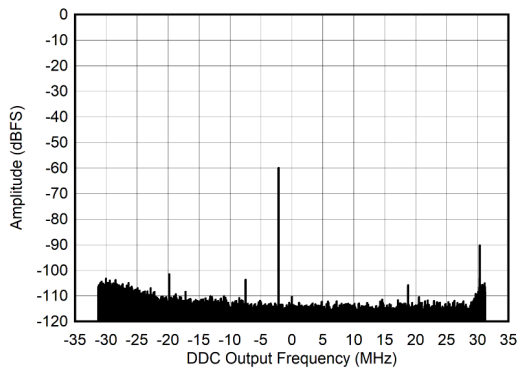
$A_{\text{IN}} = -12\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$,
Decimate by 24x

图 6-17. RX Output FFT at 30 MHz



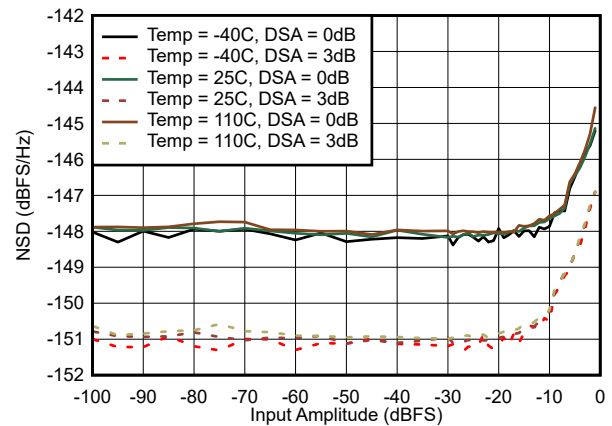
$A_{\text{IN}} = -30\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$,
Decimate by 24x

图 6-18. RX Output FFT at 30 MHz



$A_{\text{IN}} = -60\text{ dBFS}$, $f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$,
Decimate by 24x

图 6-19. RX Output FFT at 30 MHz

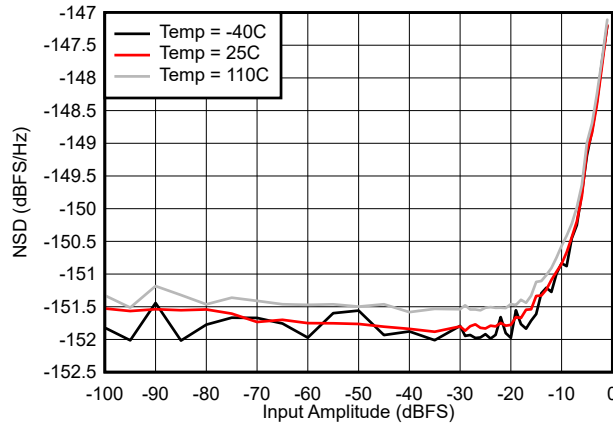


$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-20. NSD vs Input Amplitude at 30 MHz with DSA = 0 and 3dB

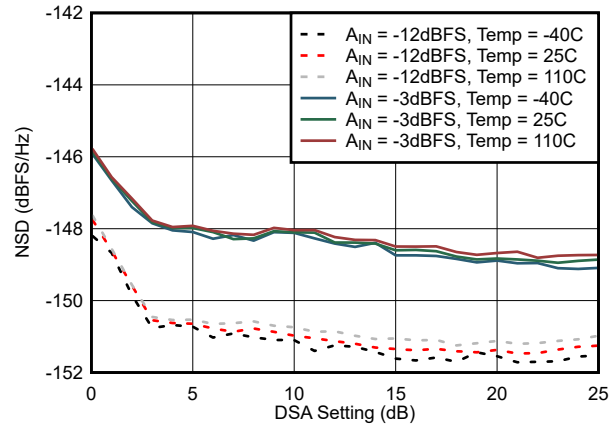
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



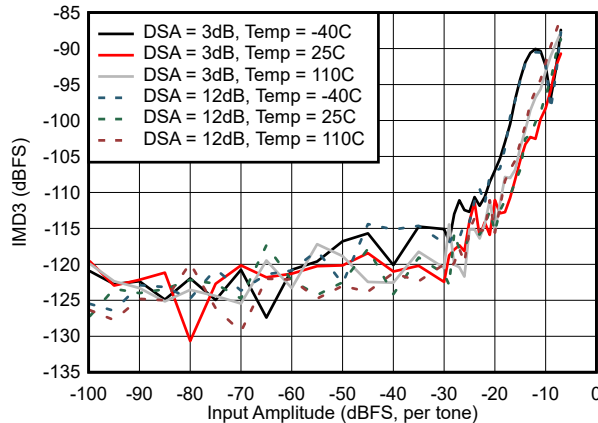
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-21. NSD vs Input Amplitude at 30 MHz with DSA = 12



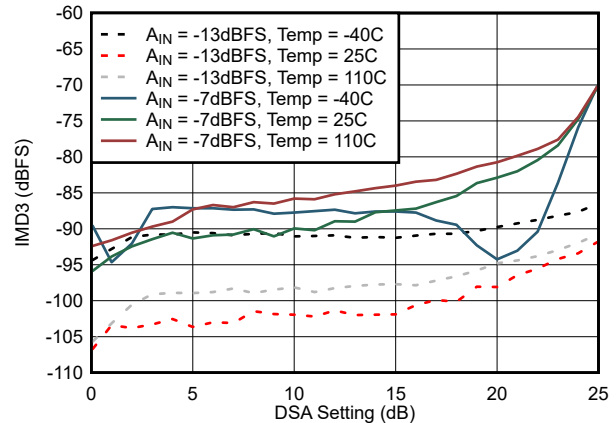
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-22. NSD vs DSA Attenuation at 30 MHz



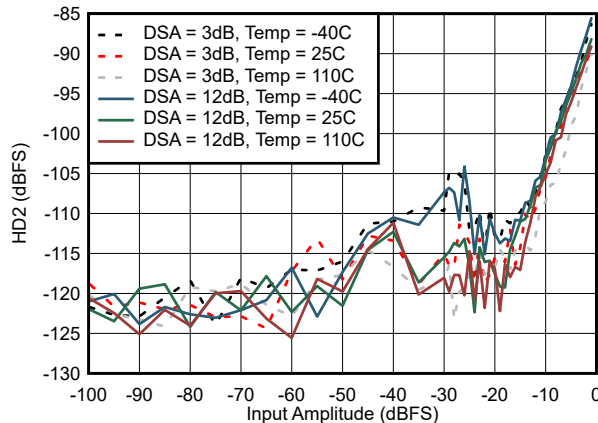
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-23. IMD3 vs Input Amplitude at 30 MHz



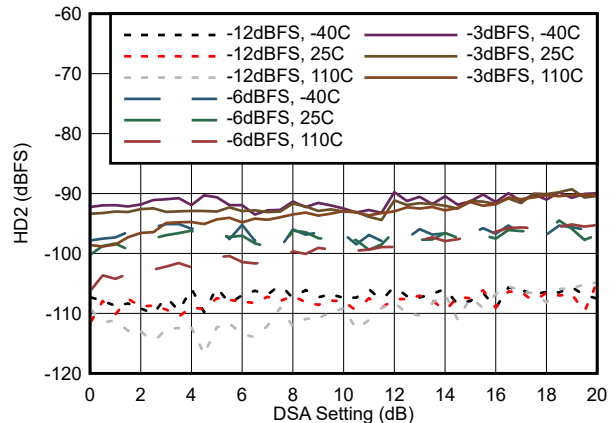
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-24. IMD3 vs DSA Setting at 30 MHz



$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-25. HD2 vs Input Amplitude at 30 MHz

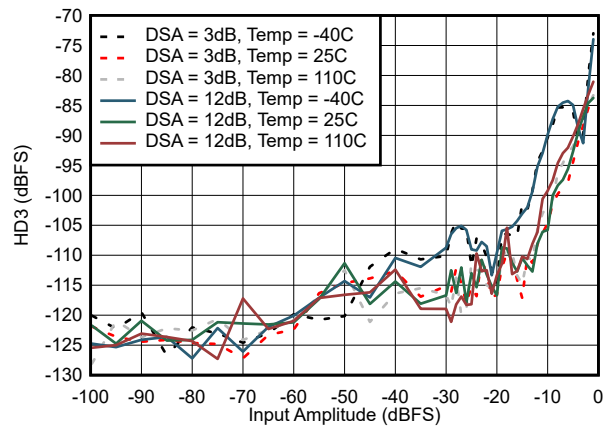


$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.$, Decimate by 24x

图 6-26. HD2 vs DSA Setting at 30 MHz

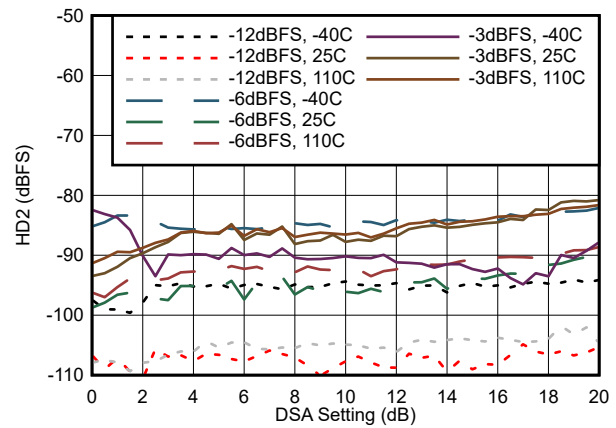
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



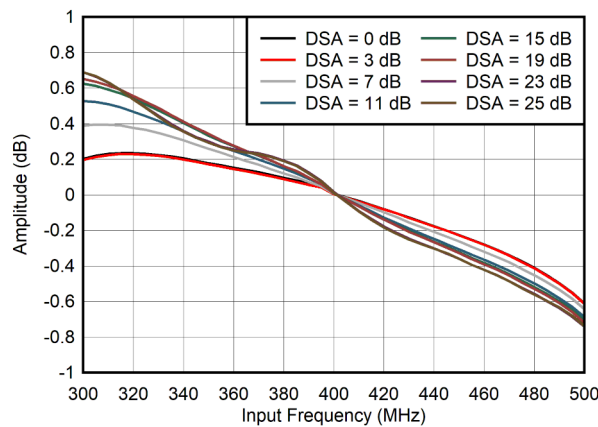
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-27. HD3 vs Input Amplitude at 30 MHz



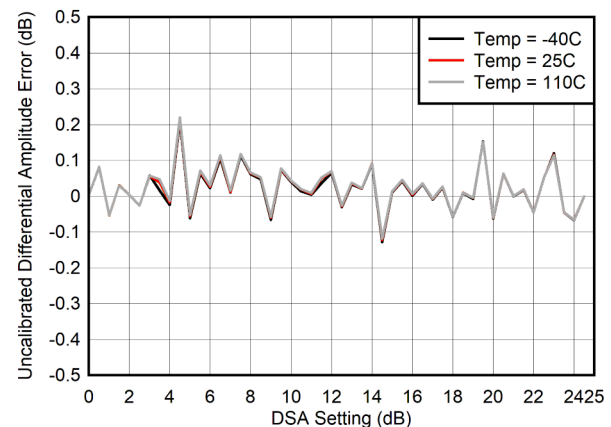
$f_{\text{ADC}} = 1500\text{ MSPS}$, $f_{\text{NCO}} = 32.13\text{ MHz}$, Decimate by 24x

图 6-28. HD3 vs DSA Setting at 30 MHz



Normalized to 4000 MHz

图 6-29. RX In-Band Gain Flatness, $f_{\text{IN}} = 400\text{ MHz}$

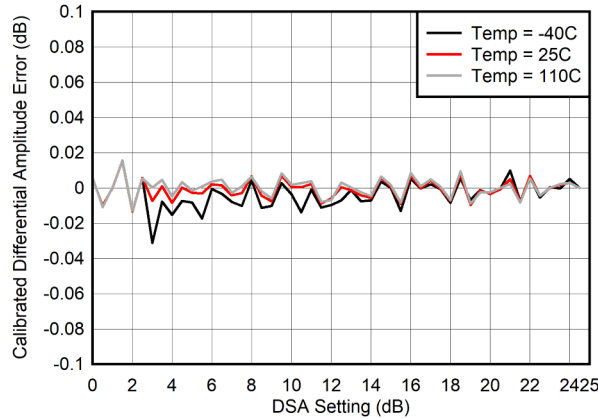


Differential Amplitude Error = $P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$

图 6-30. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 30 MHz

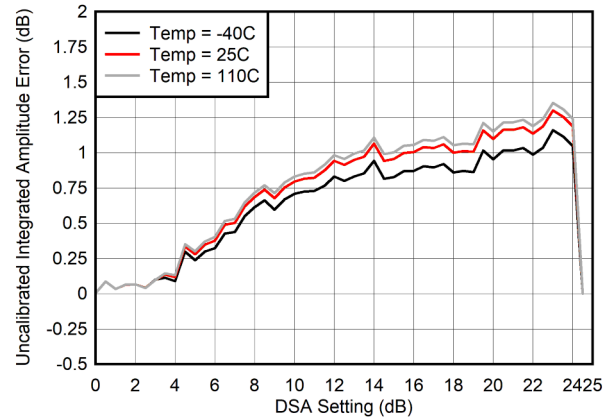
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



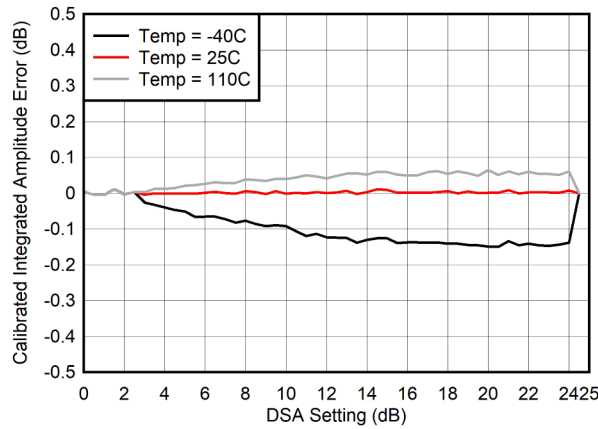
$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-31. RX Calibrated Differential Amplitude Error vs DSA Setting at 400 MHz



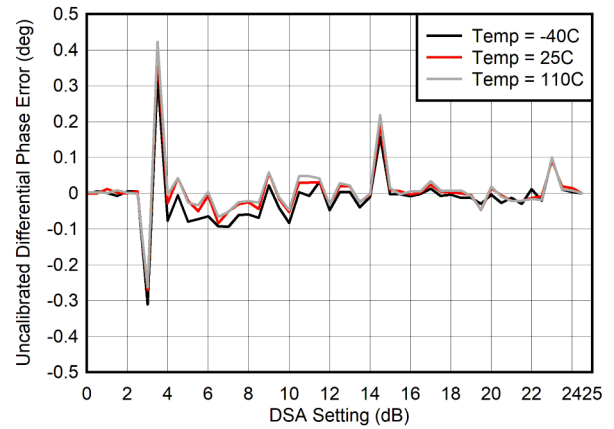
$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-32. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 400 MHz



$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-33. RX Calibrated Integrated Amplitude Error vs DSA Setting at 400 MHz



$$\text{Differential Phase Error} = \text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$$

图 6-34. RX Uncalibrated Differential Phase Error vs DSA Setting at 400 MHz

6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.

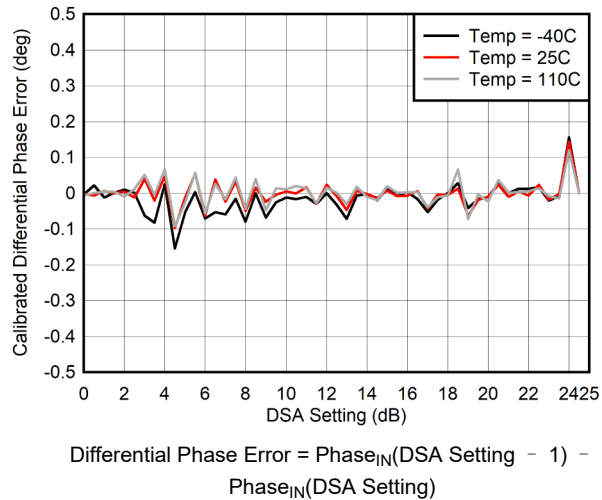


图 6-35. RX Calibrated Differential Phase Error vs DSA Setting at 400 MHz

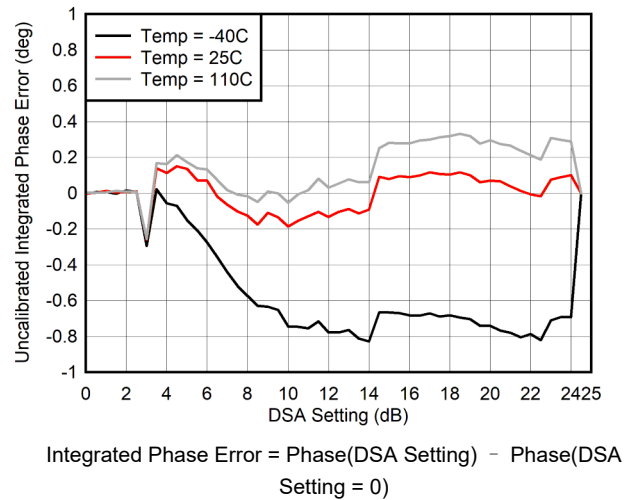


图 6-36. RX Uncalibrated Integrated Phase Error vs DSA Setting at 400 MHz

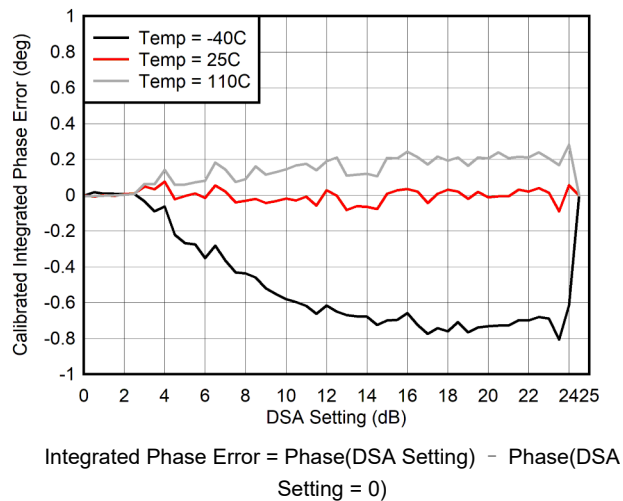


图 6-37. RX Calibrated Integrated Phase Error vs DSA Setting at 400 MHz

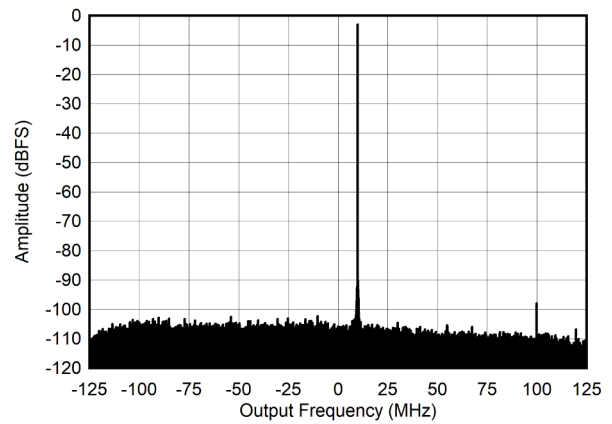
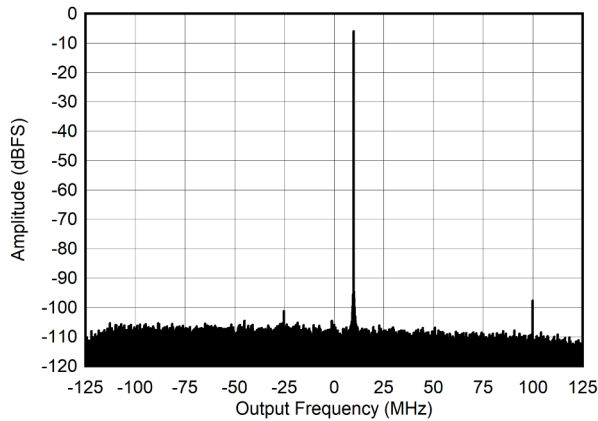


图 6-38. RX Output FFT at 405 MHz and -3dBFS

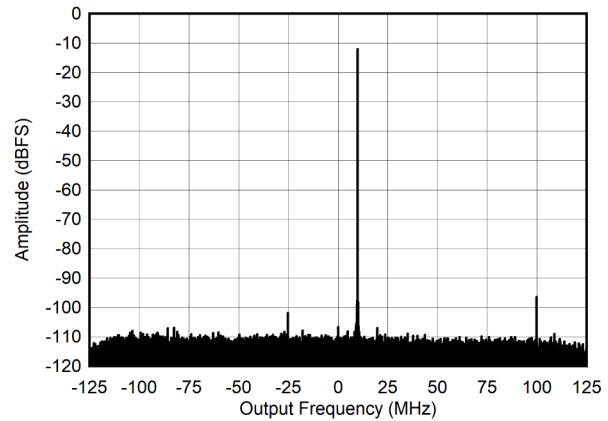
6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.



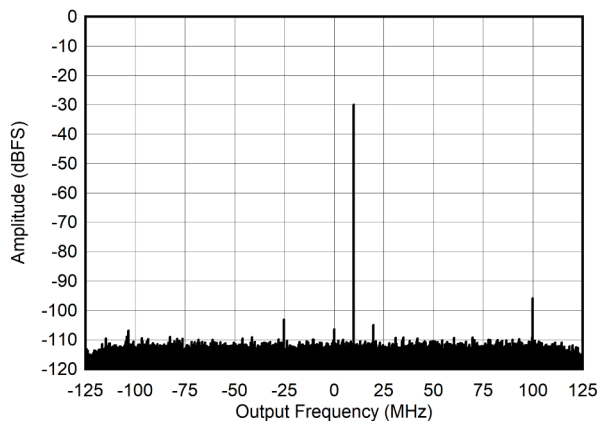
$f_{\text{NCO}} = 400\text{MHz}$

图 6-39. RX Output FFT at 405 MHz and -6dBFS



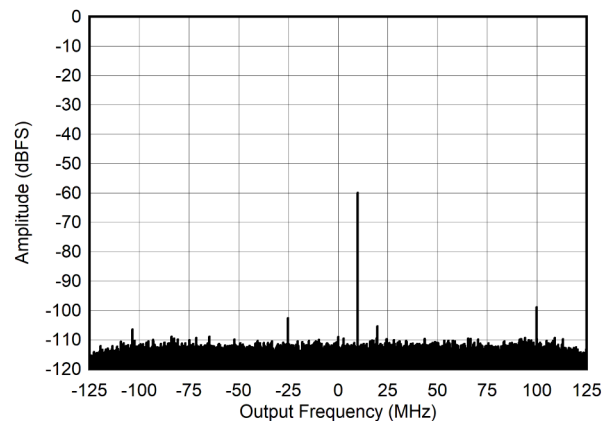
$f_{\text{NCO}} = 400\text{MHz}$

图 6-40. RX Output FFT at 405 MHz and -12dBFS



$f_{\text{NCO}} = 400\text{MHz}$

图 6-41. RX Output FFT at 405 MHz and -30dBFS



$f_{\text{NCO}} = 400\text{MHz}$

图 6-42. RX Output FFT at 405 MHz and -60dBFS

6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.

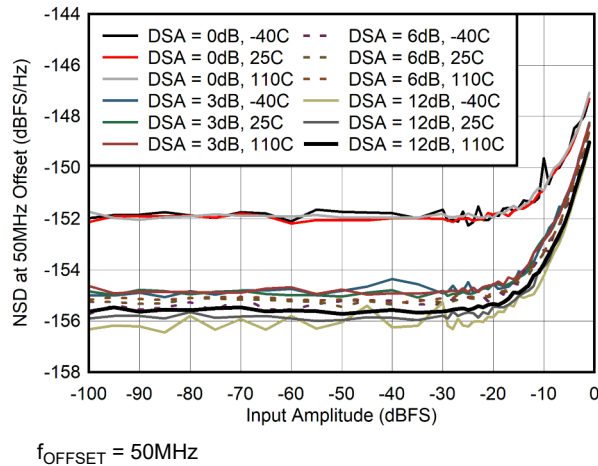


图 6-43. NSD vs Input Amplitude at 400MHz

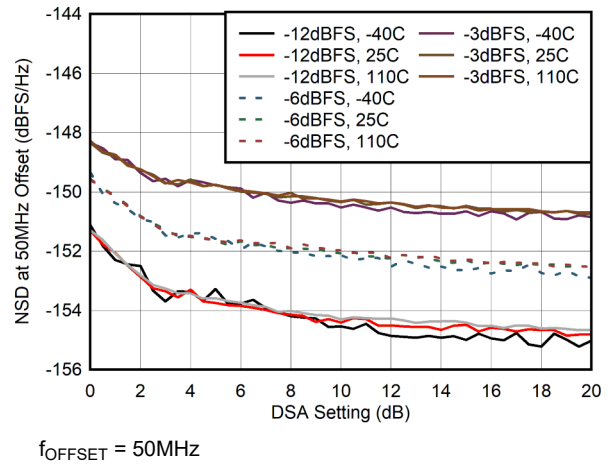


图 6-44. NSD vs DSA Setting at 400MHz

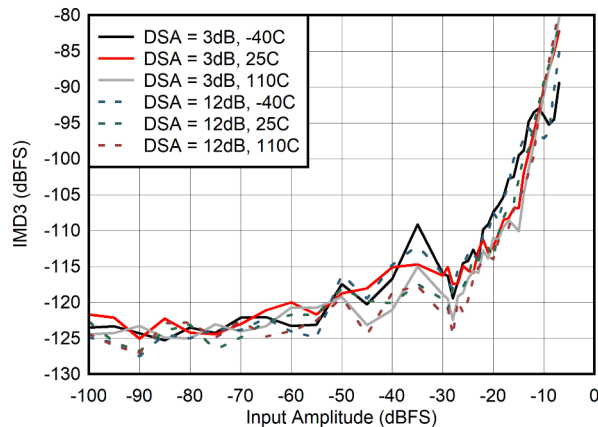


图 6-45. IMD3 vs Input Amplitude at 400MHz

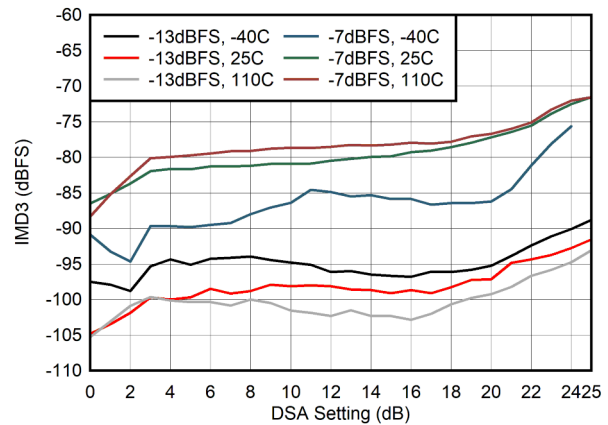


图 6-46. IMD3 vs DSA Setting at 400MHz

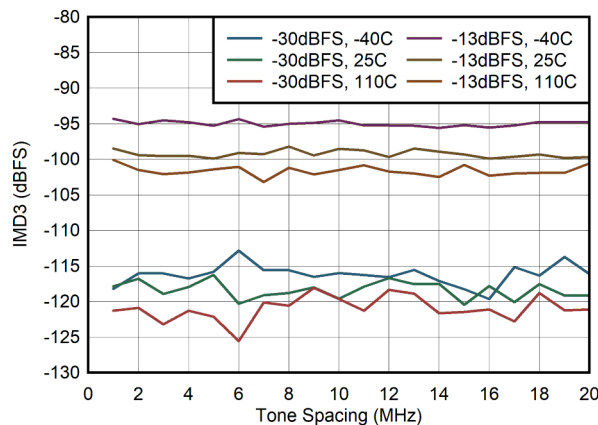


图 6-47. IMD3 vs Tone Spacing at 400MHz

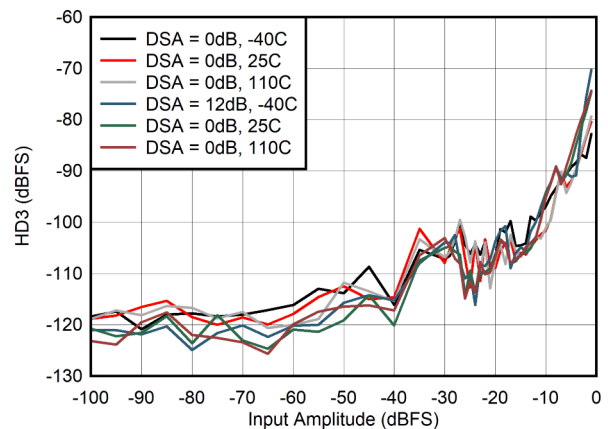


图 6-48. HD3 vs Input Amplitude at 400MHz

6.11.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with $f_{\text{REF}} = 500\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 3 dB.

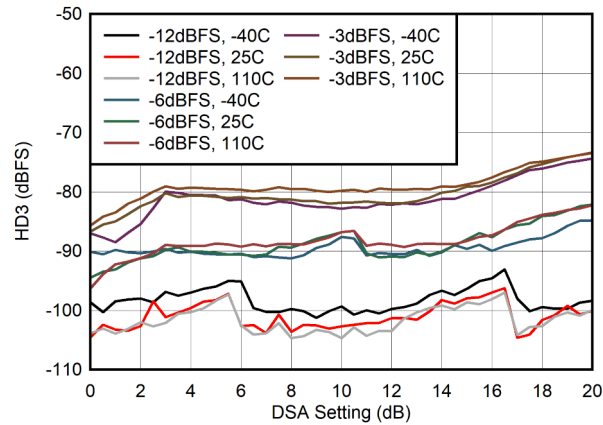
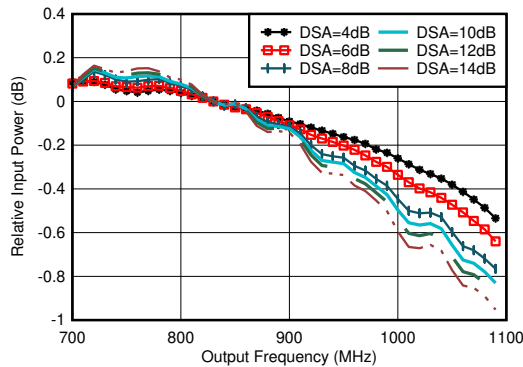


图 6-49. HD3 vs DSA Setting at 400MHz

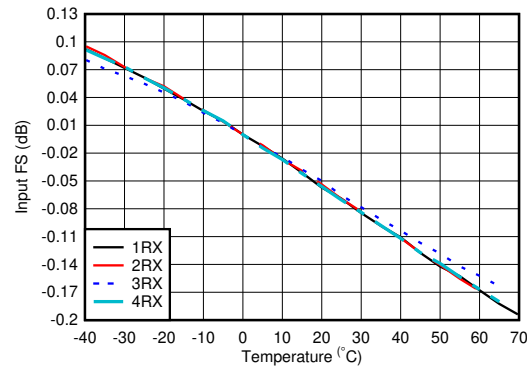
6.11.2 RX Typical Characteristics at 800MHz

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



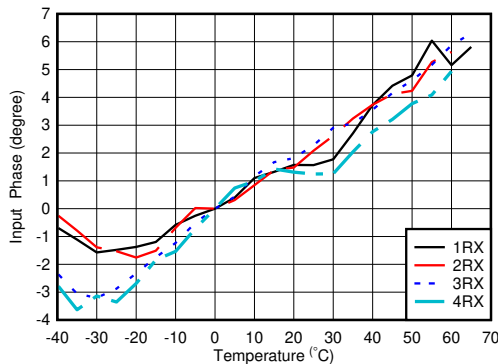
With 0.8 GHz matching, normalized to 830 MHz

图 6-50. RX In-Band Gain Flatness for Channel 1RX, $f_{\text{IN}} = 830\text{ MHz}$



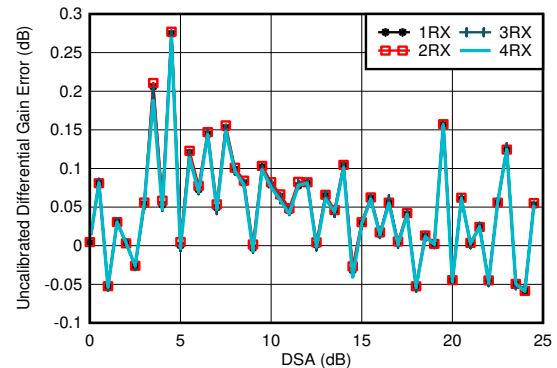
With 0.8 GHz matching, normalized to fullscale at 25°C for each channel

图 6-51. RX Input Fullscale vs Temperature and Channel at 800MHz



With 0.8 GHz matching, normalized to phase at 25°C

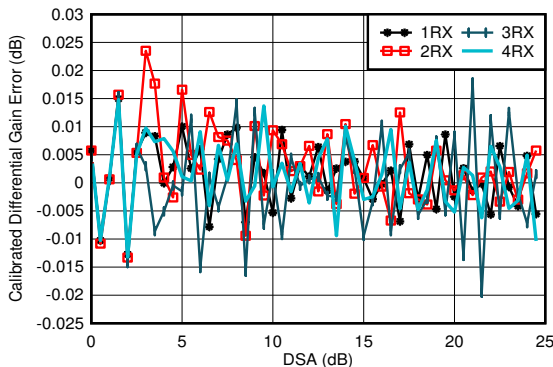
图 6-52. RX Input Phase vs Temperature and DSA at $f_{\text{OUT}} = 0.8\text{ GHz}$



With 0.8 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

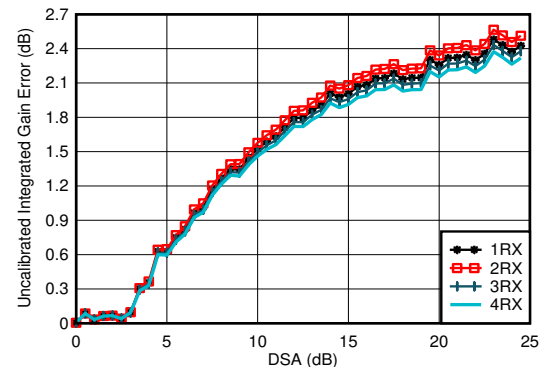
图 6-53. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-54. RX Calibrated Differential Amplitude Error vs DSA Setting at 0.8 GHz



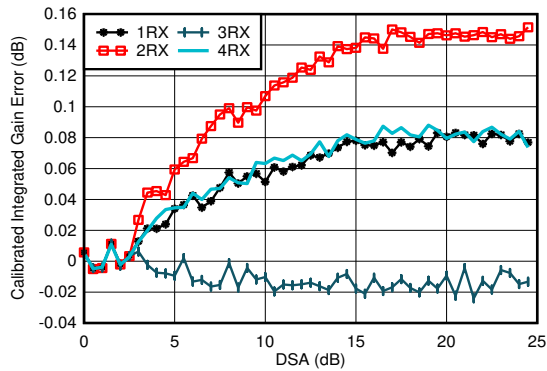
With 0.8 GHz matching

$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-55. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 0.8 GHz

6.11.2 RX Typical Characteristics at 800MHz (continued)

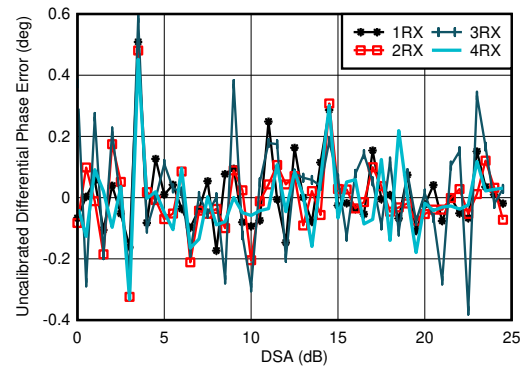
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



With 0.8 GHz matching

Integrated Amplitude Error = $P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$

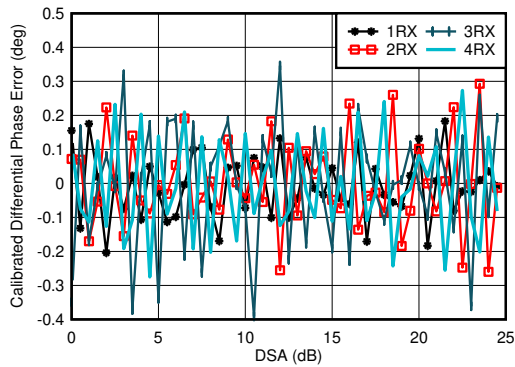
图 6-56. RX Calibrated Integrated Amplitude Error vs DSA Setting at 2.6 GHz



With 0.8 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

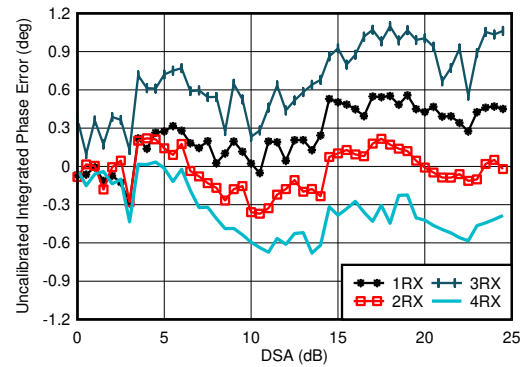
图 6-57. RX Uncalibrated Differential Phase Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

图 6-58. RX Calibrated Differential Phase Error vs DSA Setting at 0.8 GHz



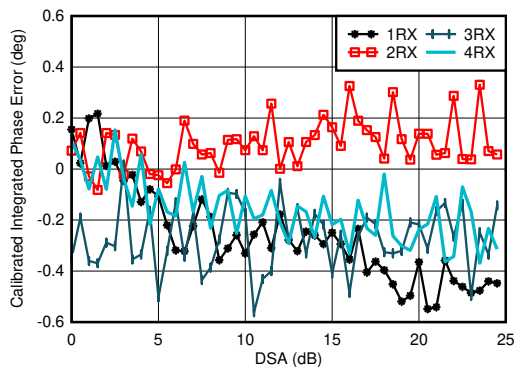
With 0.8 GHz matching

Integrated Phase Error = $\text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$

图 6-59. RX Uncalibrated Integrated Phase Error vs DSA Setting at 0.8 GHz

6.11.2 RX Typical Characteristics at 800MHz (continued)

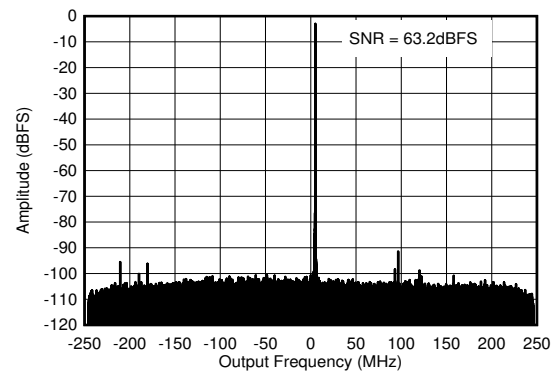
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 0.8 GHz matching

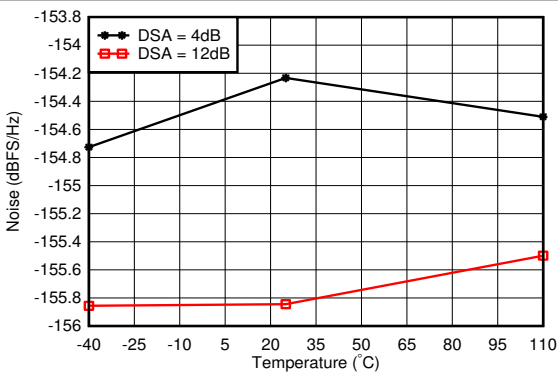
Integrated Phase Error = Phase(DSA Setting) - Phase(DSA Setting = 0)

图 6-60. RX Calibrated Integrated Phase Error vs DSA Setting at 0.8 GHz



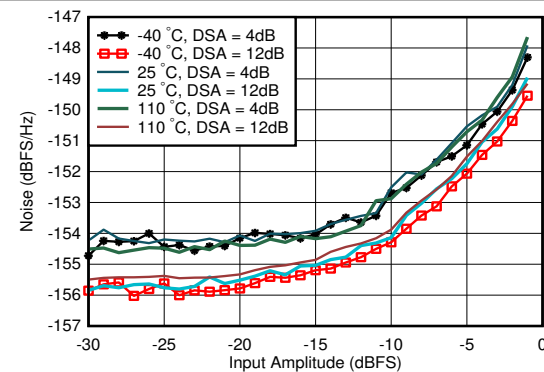
With 0.8 GHz matching, $f_{\text{IN}} = 840\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$

图 6-61. RX Output FFT at 0.8 GHz



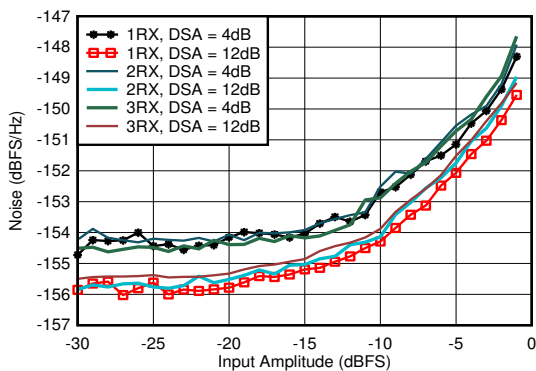
With 0.8 GHz matching, 12.5-MHz offset from tone

图 6-62. RX Noise Spectral Density vs Temperature at 0.8 GHz



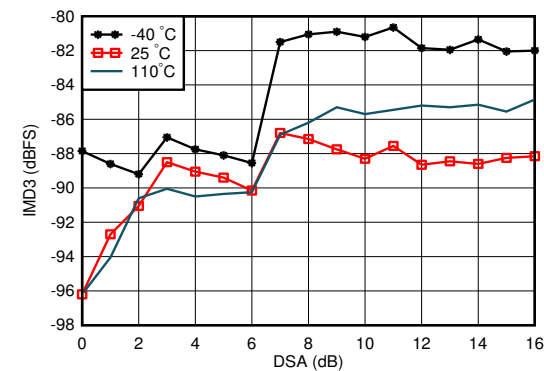
With 0.8 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 6-63. RX Noise Spectral Density vs Input Amplitude and Temperature at 0.8 GHz



With 0.8 GHz matching, 12.5-MHz offset from tone

图 6-64. RX Noise Spectral Density vs Input Amplitude and Channel at 0.8 GHz

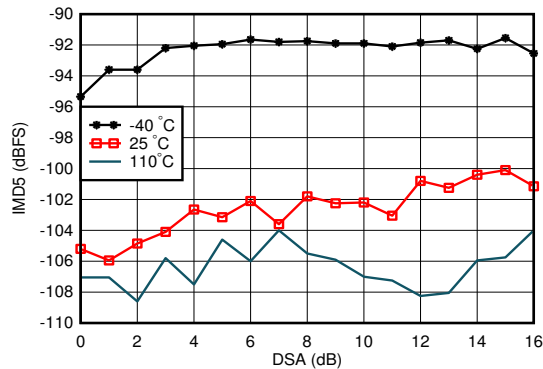


A. With 0.8 GHz matching, each tone -7 dBFS , tone spacing = 20 MHz

图 6-65. RX IMD3 vs DSA Setting and Temperature at 0.8 GHz

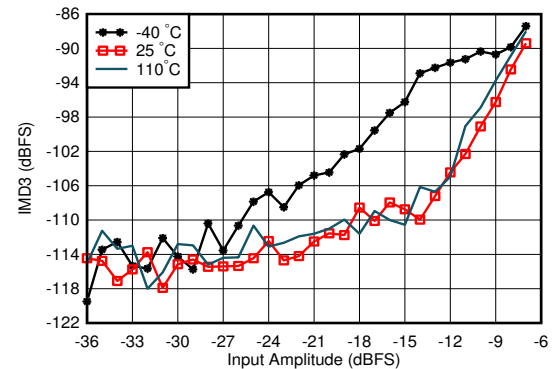
6.11.2 RX Typical Characteristics at 800MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



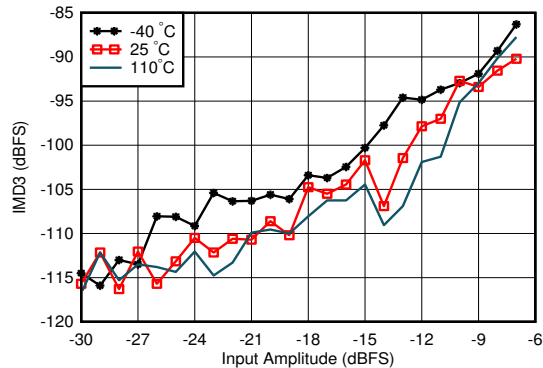
With 0.8 GHz matching, each tone -7 dBFS , tone spacing = 20 MHz

图 6-66. RX IMD5 vs DSA Setting and Temperature at 0.8 GHz



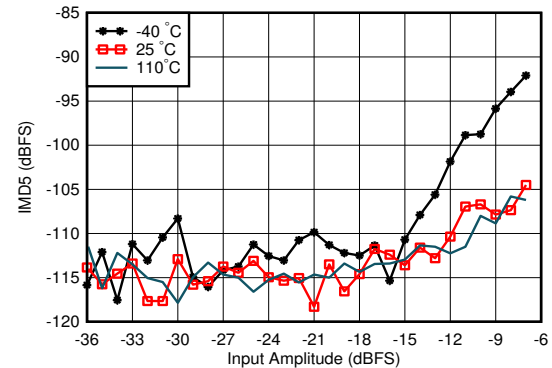
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 6-67. RX IMD3 vs Input Level and Temperature at 0.8 GHz



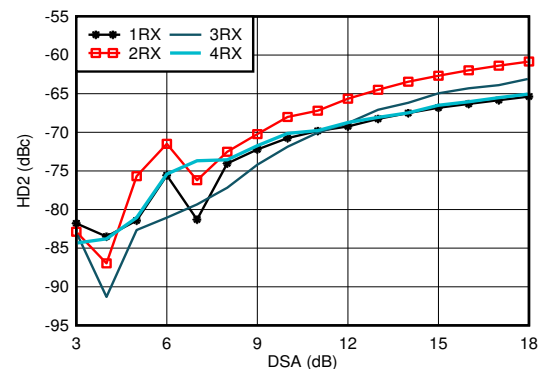
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 6-68. RX IMD3 vs Input Level and Temperature at 0.8 GHz



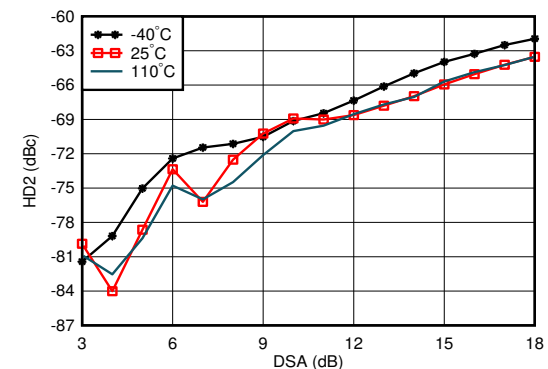
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 6-69. RX IMD5 vs Input Level and Temperature at 0.8 GHz



With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-70. RX HD2 vs DSA Setting and Channel at 0.8 GHz

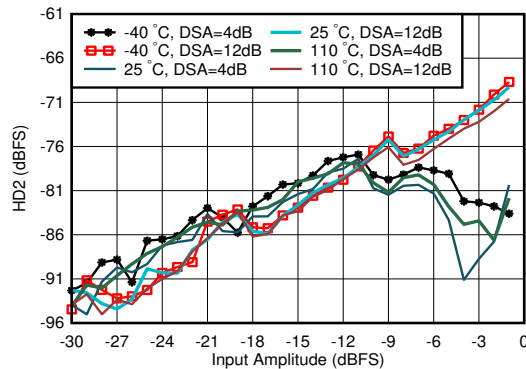


With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-71. RX HD2 vs DSA Setting and Temperature at 0.8 GHz

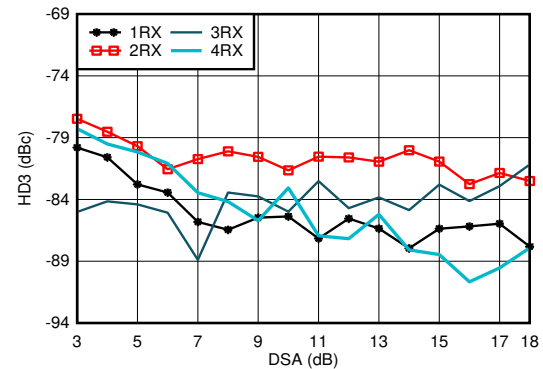
6.11.2 RX Typical Characteristics at 800MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



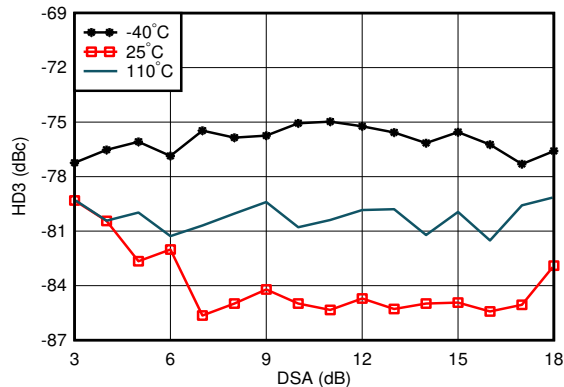
With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-72. RX HD2 vs Input Level and Temperature at 0.8 GHz



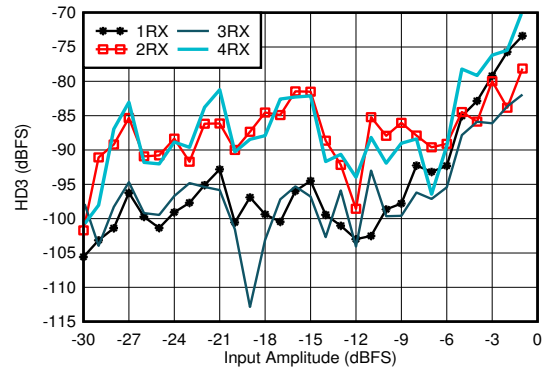
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-73. RX HD3 vs DSA Setting and Channel at 0.8 GHz



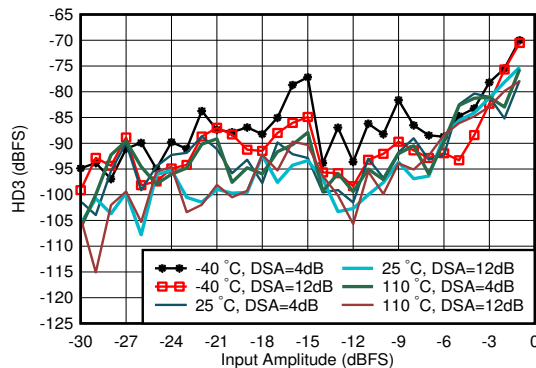
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-74. RX HD3 vs DSA Setting and Temperature at 0.8 GHz



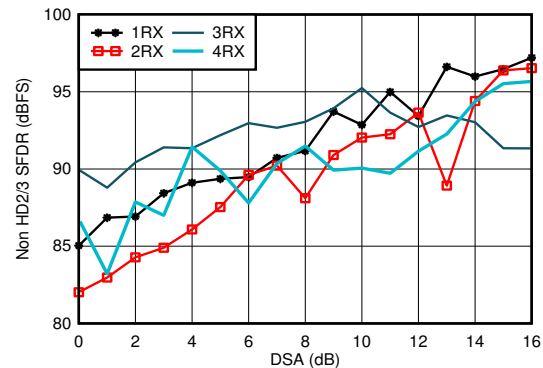
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-75. RX HD3 vs Input Level and Channel at 0.8 GHz



With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-76. RX HD3 vs Input Level and Temperature at 0.8 GHz

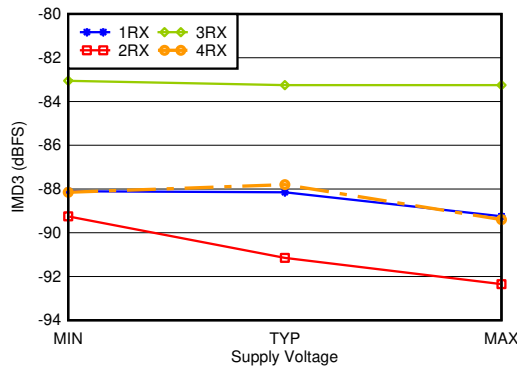


With 0.8 GHz matching

图 6-77. RX Non-HD2/3 vs DSA Setting at 0.8 GHz

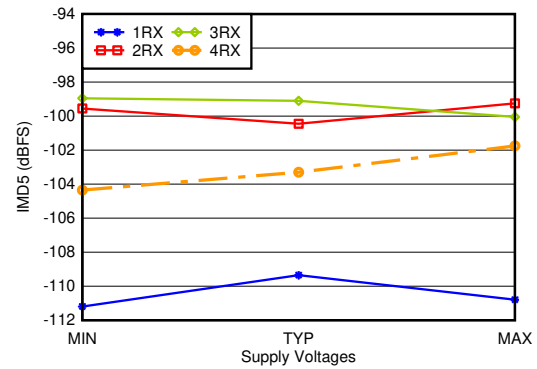
6.11.2 RX Typical Characteristics at 800MHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



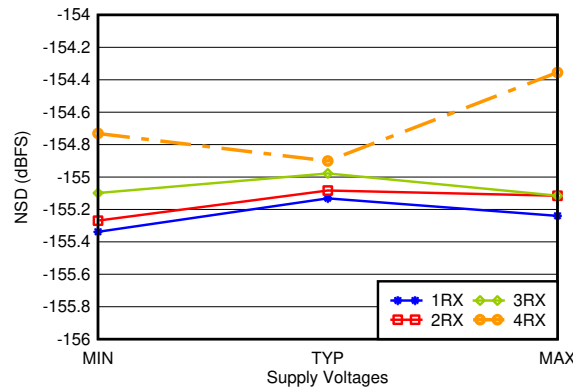
With 0.8 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-78. RX IMD3 vs Supply and Channel at 0.8 GHz



With 0.8 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-79. RX IMD5 vs Supply and Channel at 0.8 GHz

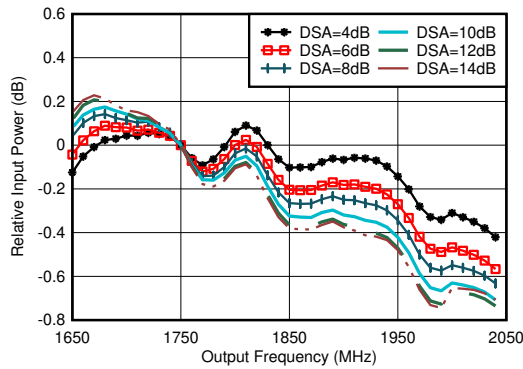


With 0.8 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-80. RX Noise Spectral Density vs Supply and Channel at 0.8 GHz

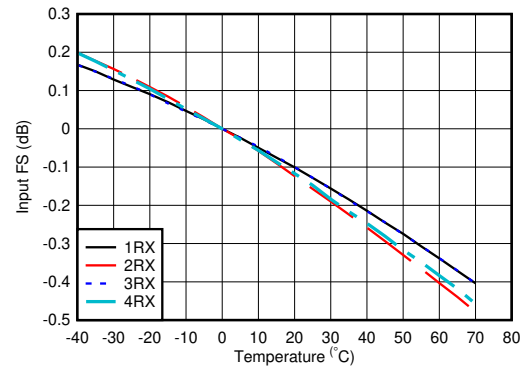
6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



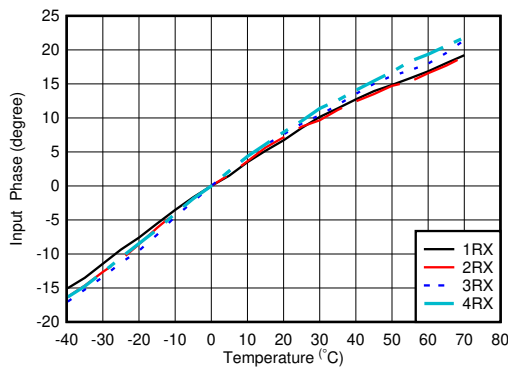
With 1.8 GHz matching, normalized to 1.75 GHz

图 6-81. RX In-Band Gain Flatness, $f_{\text{IN}} = 1750\text{ MHz}$



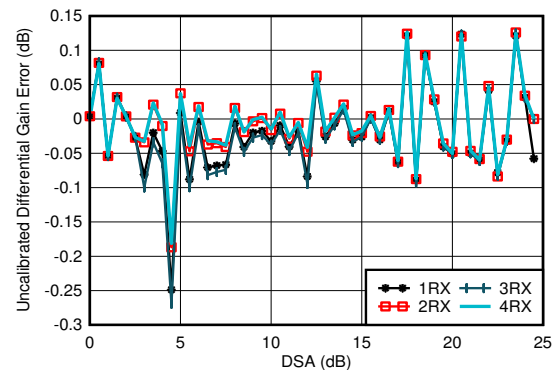
With 1.8 GHz matching, normalized to fullscale at 25°C for each channel

图 6-82. RX Input Fullscale vs Temperature and Channel at 1.75 GHz



With 2.6 GHz matching, normalized to phase at 25°C

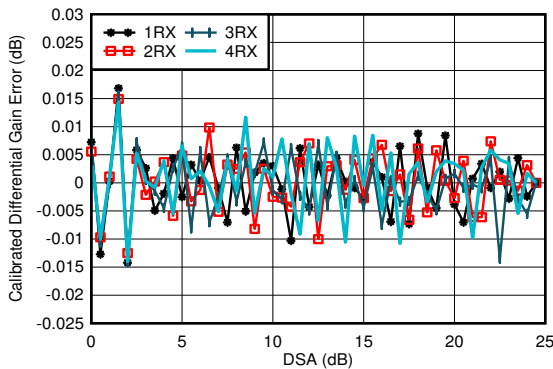
图 6-83. RX Input Phase vs Temperature and DSA at $f_{\text{IN}} = 1.75\text{ GHz}$



With 1.8 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

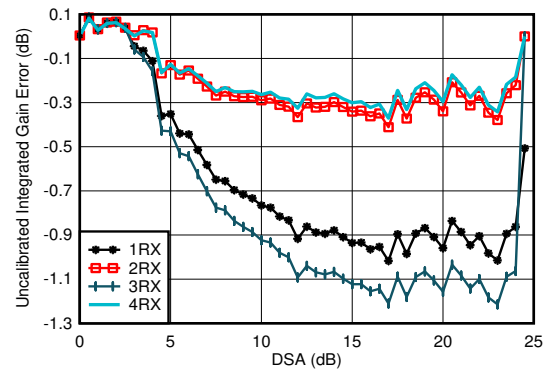
图 6-84. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-85. RX Calibrated Differential Amplitude Error vs DSA Setting at 1.75 GHz



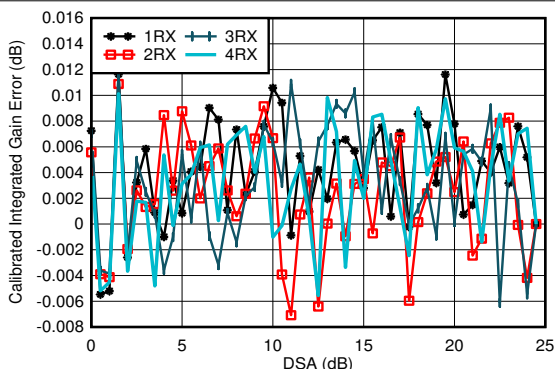
With 1.8 GHz matching

$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-86. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 1.75 GHz

6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

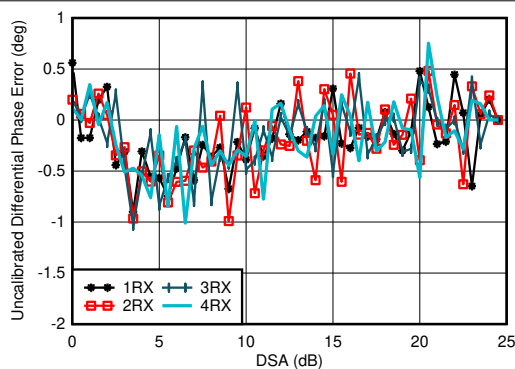
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 1.8 GHz matching

Integrated Amplitude Error = $P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$

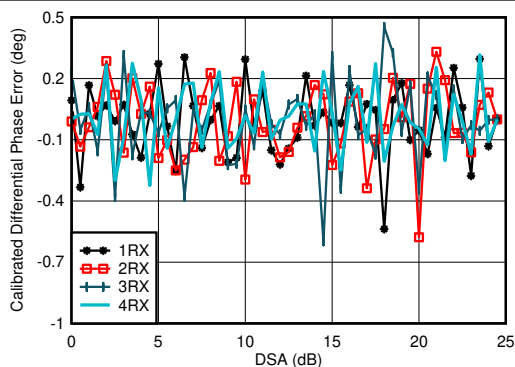
图 6-87. RX Calibrated Integrated Amplitude Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

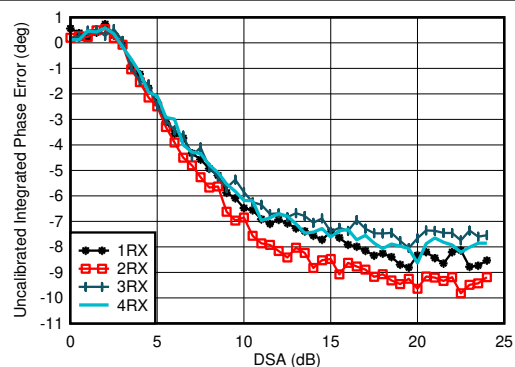
图 6-88. RX Uncalibrated Differential Phase Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

图 6-89. RX Calibrated Differential Phase Error vs DSA Setting at 1.75 GHz



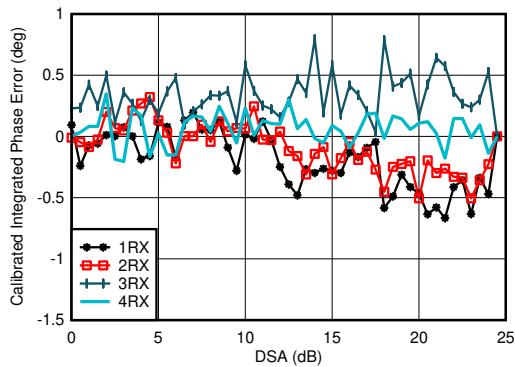
With 1.8 GHz matching

Integrated Phase Error = $\text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$

图 6-90. RX Uncalibrated Integrated Phase Error vs DSA Setting at 1.75 GHz

6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

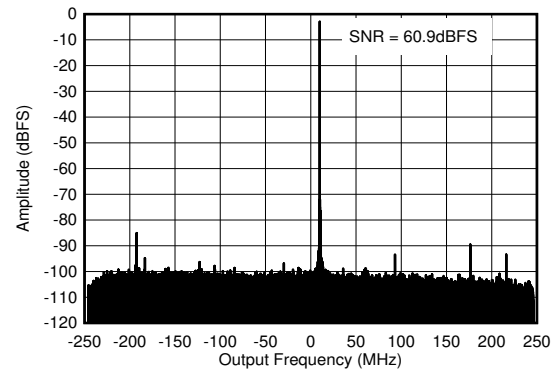
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 1.8 GHz matching

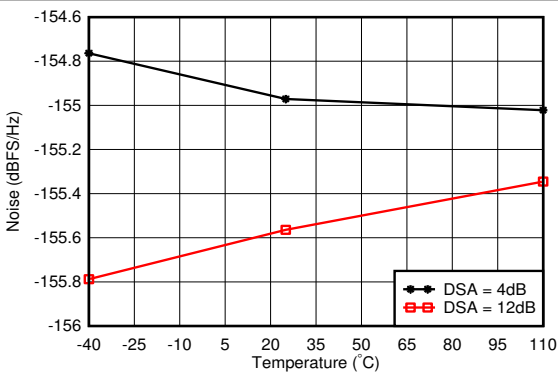
Integrated Phase Error = Phase(DSA Setting) - Phase(DSA Setting = 0)

图 6-91. RX Calibrated Integrated Phase Error vs DSA Setting at 1.75 GHz



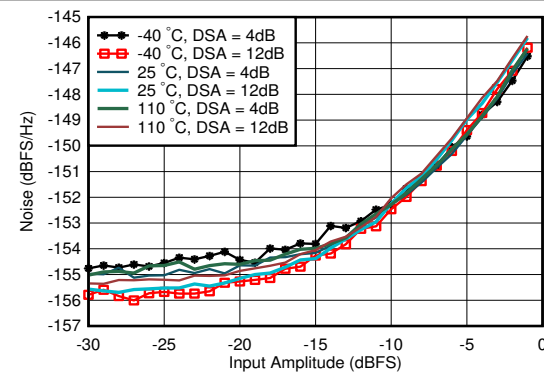
With 1.8 GHz matching, $f_{\text{IN}} = 2610\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$

图 6-92. RX Output FFT at 1.75 GHz



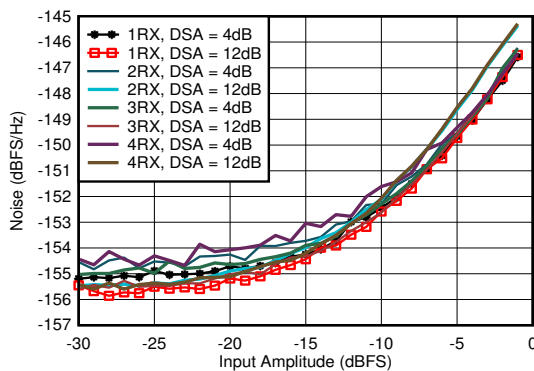
With 1.8 GHz matching, 12.5-MHz offset from tone

图 6-93. RX Noise Spectral Density vs Temperature at 1.75 GHz



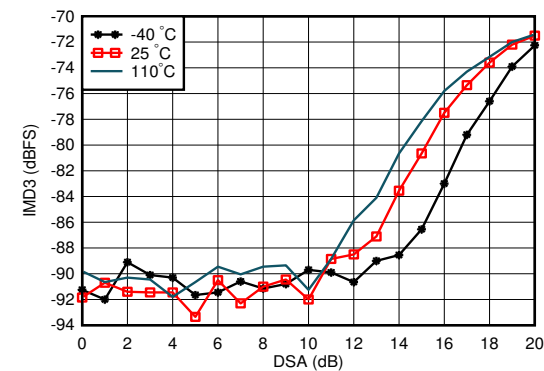
With 1.8 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 6-94. RX Noise Spectral Density vs Input Amplitude and Temperature at 1.75 GHz



With 1.8 GHz matching, 12.5-MHz offset from tone

图 6-95. RX Noise Spectral Density vs Input Amplitude and Channel at 1.75 GHz

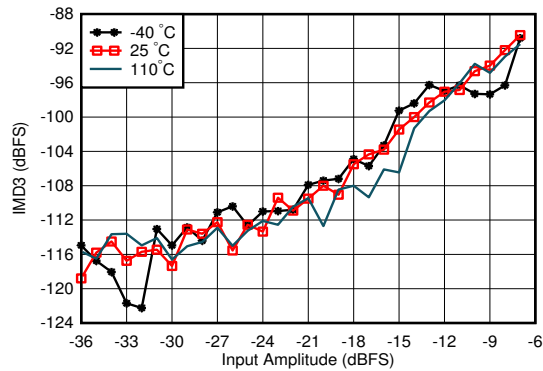


With 1.8 GHz matching, each tone -7 dBFS , tone spacing = 20 MHz

图 6-96. RX IMD3 vs DSA Setting and Temperature at 1.75 GHz

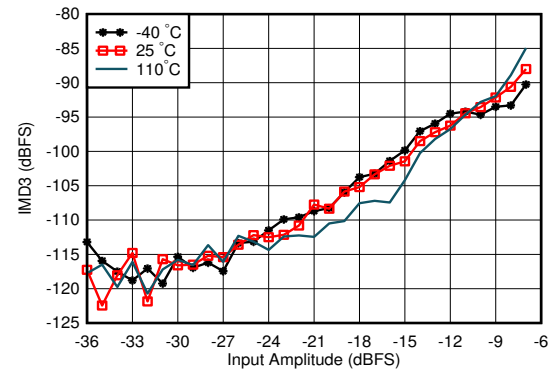
6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



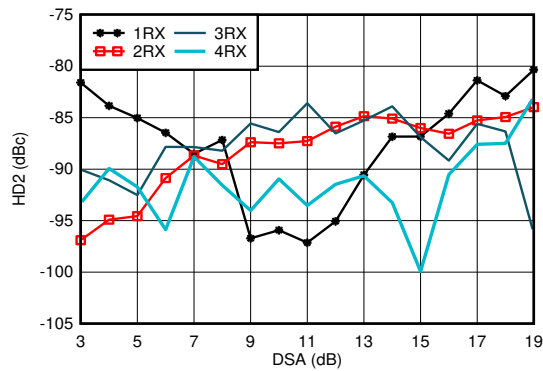
With 1.8 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 6-97. RX IMD3 vs Input Level and Temperature at 1.75 GHz



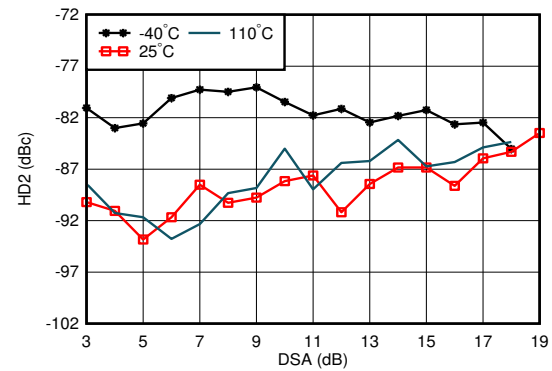
With 1.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 6-98. RX IMD3 vs Input Level and Temperature at 1.75 GHz



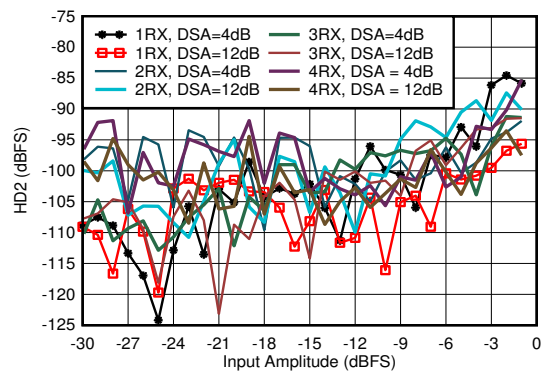
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-99. RX HD2 vs DSA Setting and Channel at 1.9 GHz



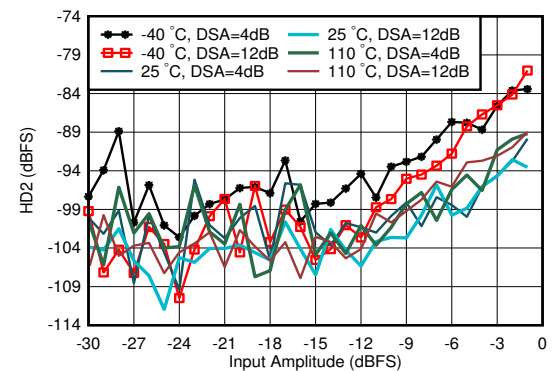
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-100. RX HD2 vs DSA Setting and Temperature at 1.9 GHz



With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-101. RX HD2 vs Input Amplitude and Channel at 1.9 GHz

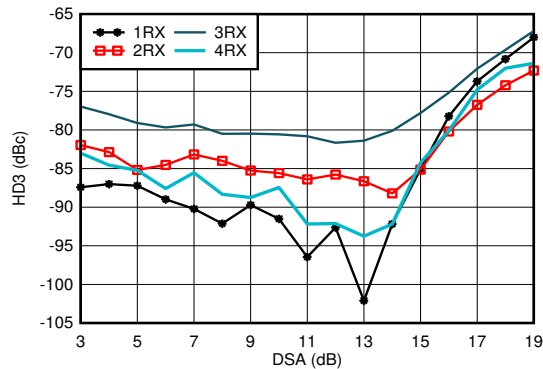


With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-102. RX HD2 vs Input Amplitude and Temperature at 1.9 GHz

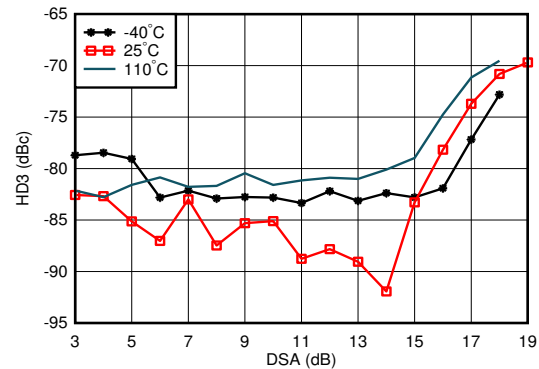
6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



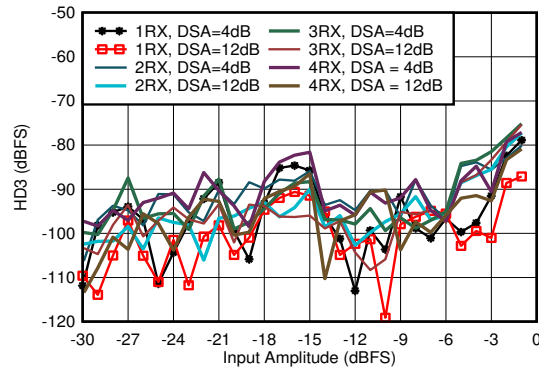
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, DDC bypass mode (TI only mode for characterization)

图 6-103. RX HD3 vs DSA Setting and Channel at 1.9 GHz



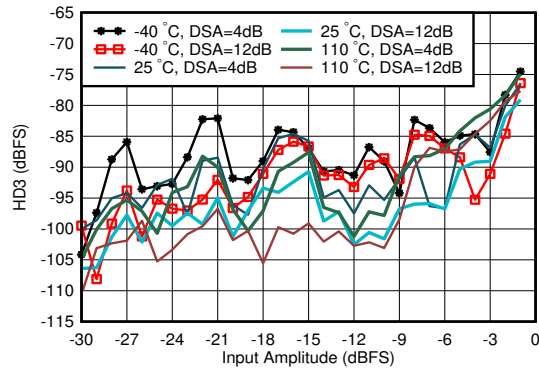
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, DDC bypass mode (TI only mode for characterization)

图 6-104. RX HD3 vs DSA Setting and Temperature at 1.9 GHz



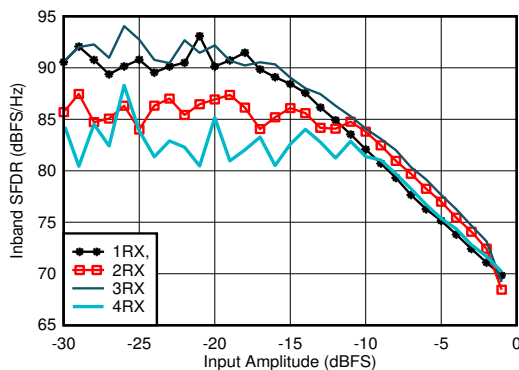
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, DDC bypass mode (TI only mode for characterization)

图 6-105. RX HD3 vs Input Level and Channel at 1.9 GHz



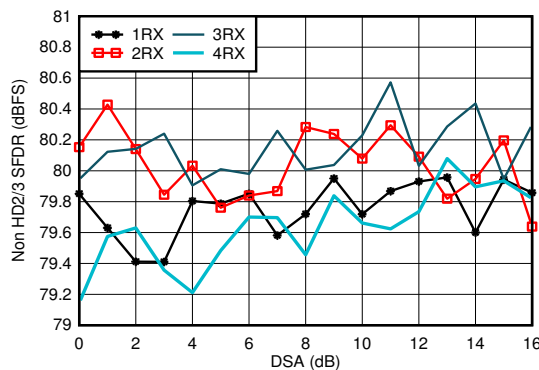
With 1.8 GHz matching, $f_{\text{in}} = 1900\text{MHz}$, DDC bypass mode (TI only mode for characterization)

图 6-106. RX HD3 vs Input Level and Temperature at 1.9 GHz



With 1.8 GHz matching, decimated by 3

图 6-107. RX In-Band SFDR ($\pm 400\text{ MHz}$) vs Input Amplitude at 1.75 GHz

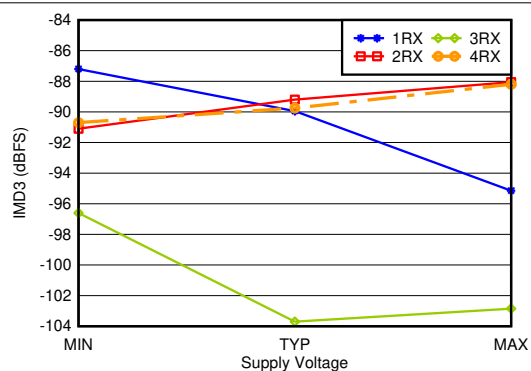


With 1.8 GHz matching

图 6-108. RX Non-HD2/3 vs DSA Setting at 1.75 GHz

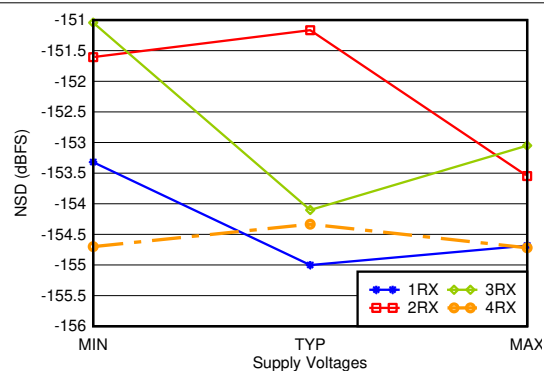
6.11.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 1.8 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-109. RX IMD3 vs Supply and Channel at 1.75 GHz

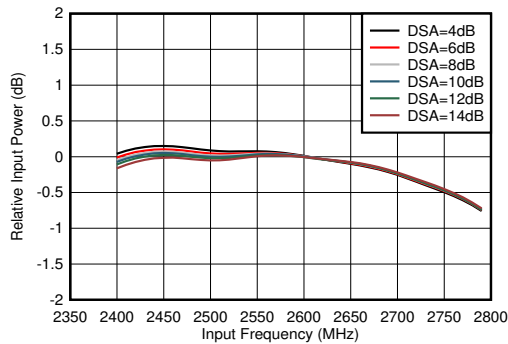


With 1.8 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-110. RX Noise Spectral Density vs Supply and Channel at 1.75 GHz

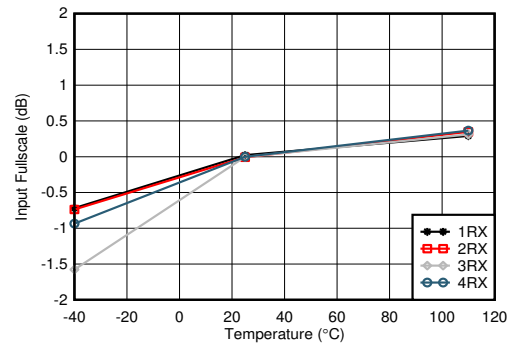
6.11.4 RX Typical Characteristics 2.6GHz

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



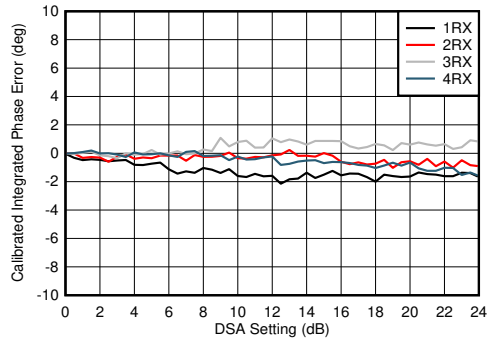
With matching, normalized to power at 2.6 GHz for each DSA setting

图 6-111. RX Inband Gain Flatness, $f_{\text{IN}} = 2600\text{ MHz}$



With 2.6 GHz matching, normalized to fullscale at 25°C for each channel

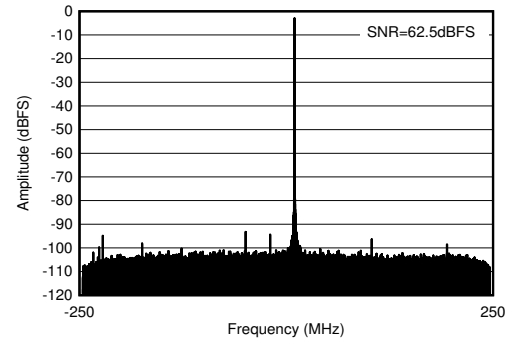
图 6-112. RX Input Fullscale vs Temperature and Channel at 2.6 GHz



With 2.6 GHz matching

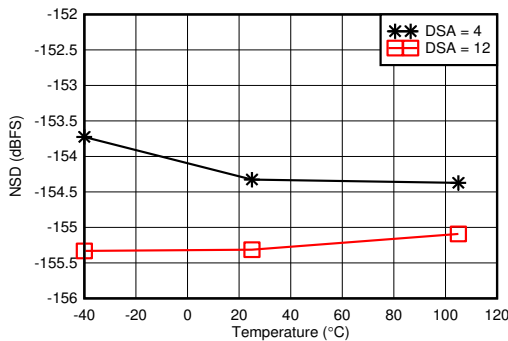
Integrated Phase Error = Phase(DSA Setting) - Phase(DSA Setting = 0)

图 6-113. RX Calibrated Integrated Phase Error vs DSA Setting at 2.6 GHz



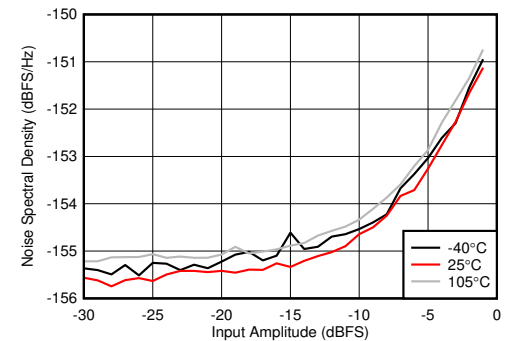
With 2.6 GHz matching, $f_{\text{IN}} = 2610\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$

图 6-114. RX Output FFT at 2.6 GHz



With 2.6 GHz matching, 12.5-MHz offset from tone

图 6-115. RX Noise Spectral Density vs Temperature at 2.6 GHz

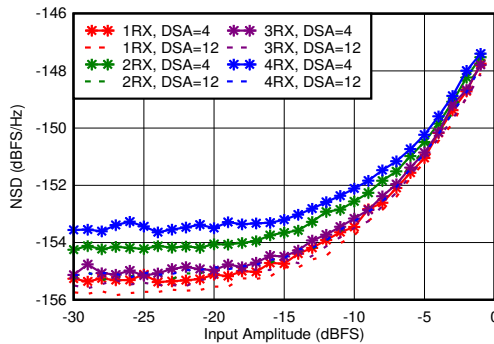


With 2.6 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 6-116. RX Noise Spectral Density vs Input Amplitude and Temperature at 2.6 GHz

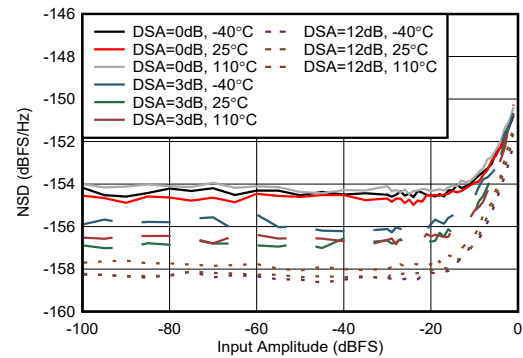
6.11.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



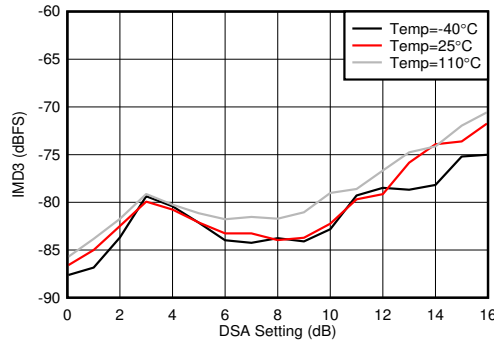
With 2.6 GHz matching, 12.5-MHz offset from tone

图 6-117. RX Noise Spectral Density vs Input Amplitude and Channel at 2.6 GHz



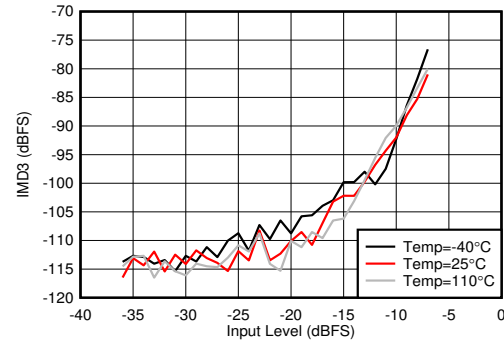
50-MHz offset from tone, external clock mode

图 6-118. RX Noise Spectral Density vs Input Amplitude at 2.61 GHz (Ext. Clock)



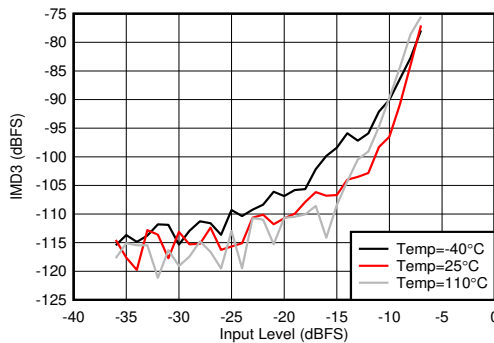
With 2.6 GHz matching, each tone - 7 dBFS, tone spacing = 20 MHz

图 6-119. RX IMD3 vs DSA Setting and Temperature at 2.6 GHz



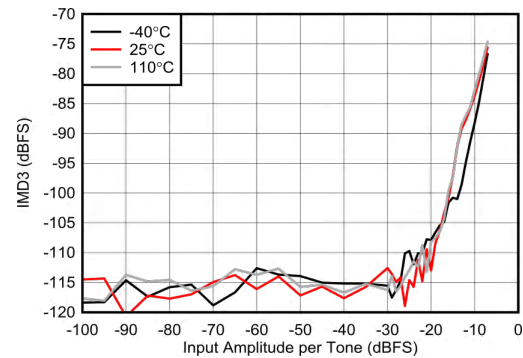
With 2.6 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 6-120. RX IMD3 vs Input Level and Temperature at 2.6 GHz



With 2.6 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 6-121. RX IMD3 vs Input Level and Temperature at 2.6 GHz

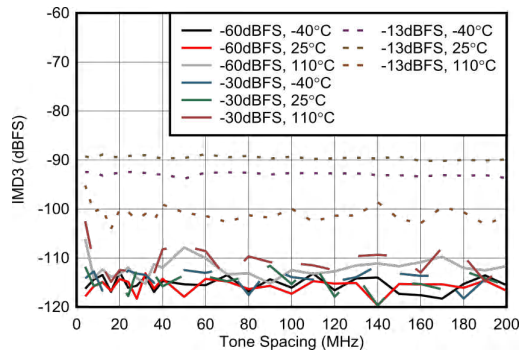


Tone spacing = 50 MHz, External clock mode

图 6-122. RX IMD3 vs Input Level at 2.6 GHz (Ext. Clock)

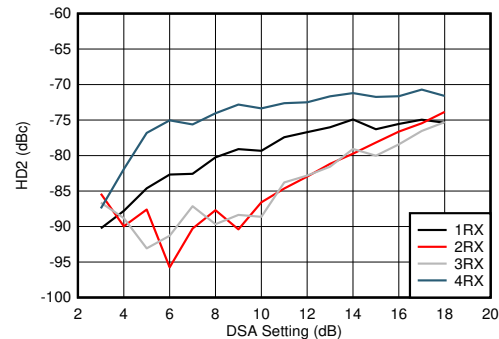
6.11.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



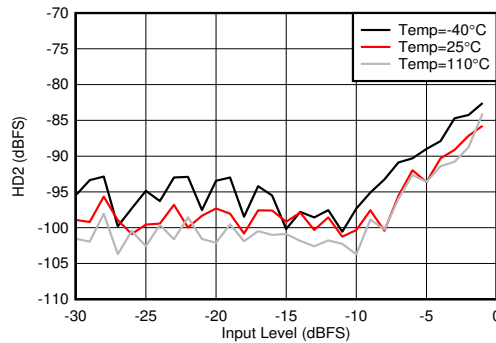
External clock mode

图 6-123. RX IMD3 vs Tone Spacing at 2.6 GHz (Ext. Clock)



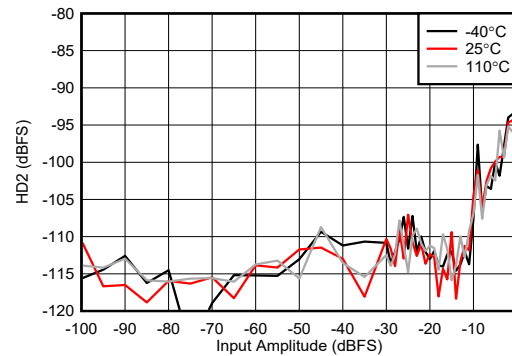
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-124. RX HD2 vs DSA Setting and Channel at 2.6 GHz



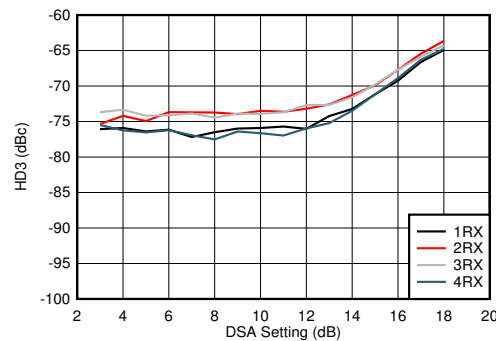
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-125. RX HD2 vs Input Level and Temperature at 2.6 GHz



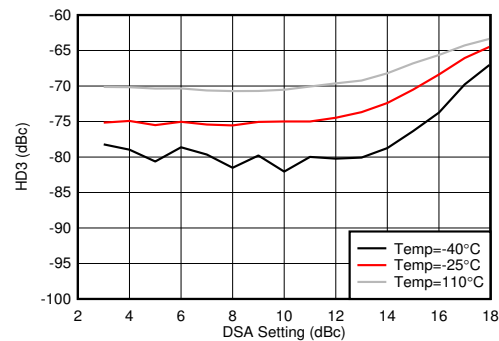
External clock mode

图 6-126. RX HD2 vs Input Level and Temperature at 2.6 GHz



With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-127. RX HD3 vs DSA Setting and Channel at 2.6 GHz

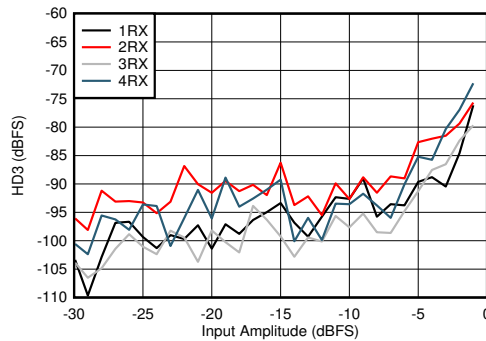


With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-128. RX HD3 vs DSA Setting and Temperature at 2.6 GHz

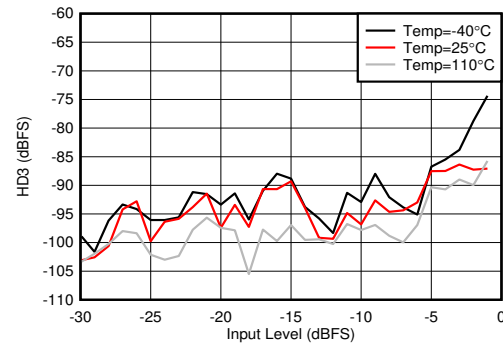
6.11.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



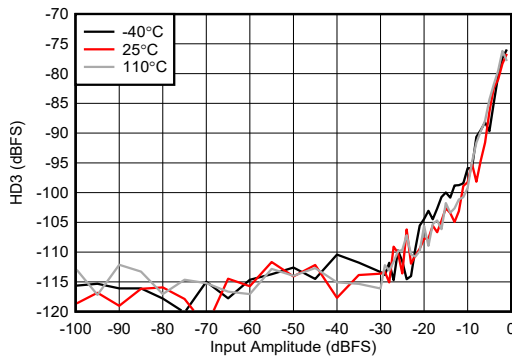
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-129. RX HD3 vs Input Level and Channel at 2.6 GHz



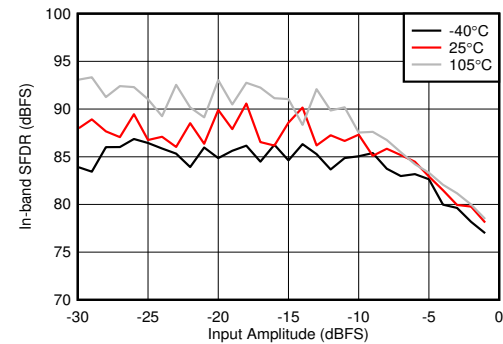
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-130. RX HD3 vs Input Level and Temperature at 2.6 GHz



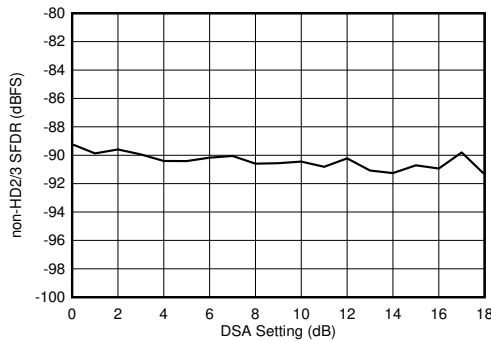
External clock mode

图 6-131. RX HD3 vs Input Level and Temperature at 2.6 GHz



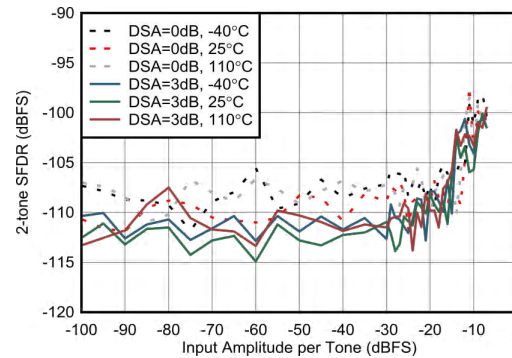
With 2.6 GHz matching, decimate by 4

图 6-132. RX In-Band SFDR ($\pm 300\text{ MHz}$) vs Input Amplitude and Temperature at 2.6 GHz



With 2.6 GHz matching

图 6-133. RX Non-HD2/3 vs DSA Setting at 2.6 GHz

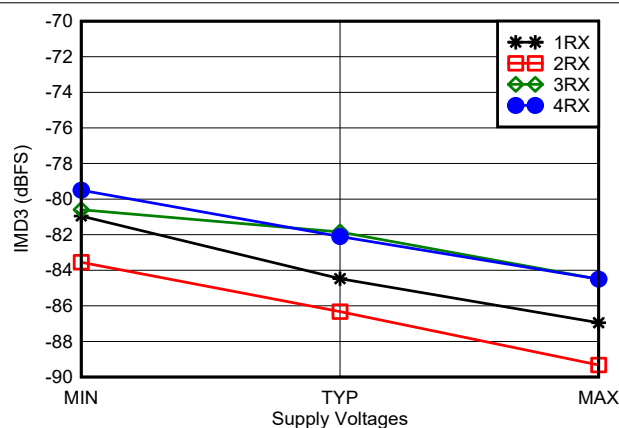


External clock mode, 50MHz tone spacing, excluding 3rd order distortion

图 6-134. RX 2-tone SFDR vs Input Amplitude at 2.6 GHz

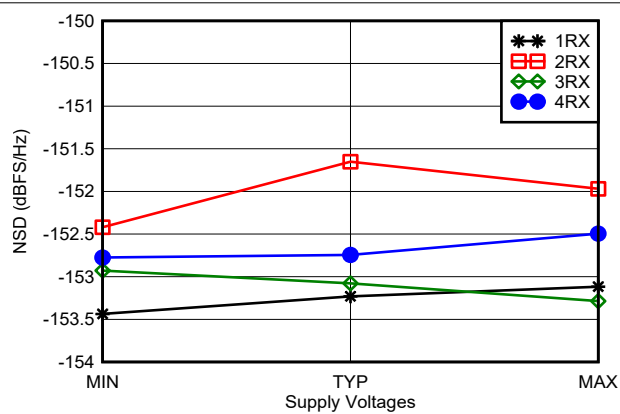
6.11.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



With 2.6 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-135. RX IMD3 vs Supply and Channel at 2.6 GHz

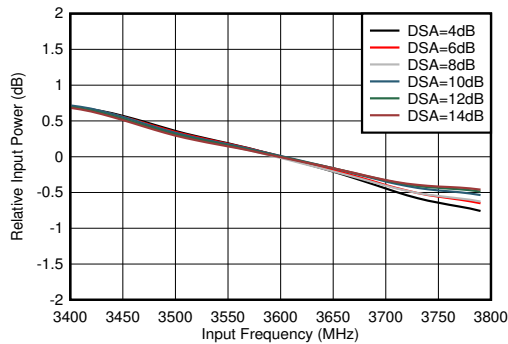


With 2.6 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-136. RX Noise Spectral Density vs Supply and Channel at 2.6 GHz

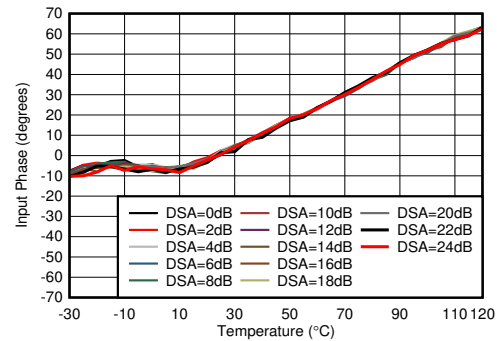
6.11.5 RX Typical Characteristics 3.5GHz

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



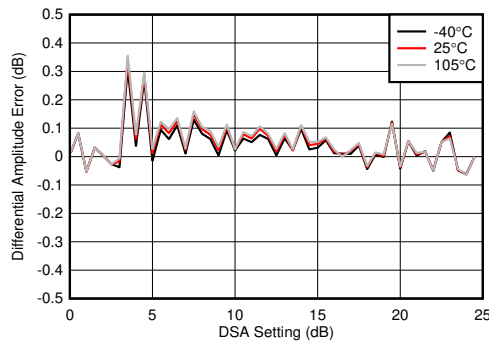
With 3.6 GHz matching, normalized to 3.6 GHz

图 6-137. RX In-Band Gain Flatness, $f_{\text{IN}} = 3600\text{ MHz}$



With 3.6 GHz matching, normalized to phase at 25°C

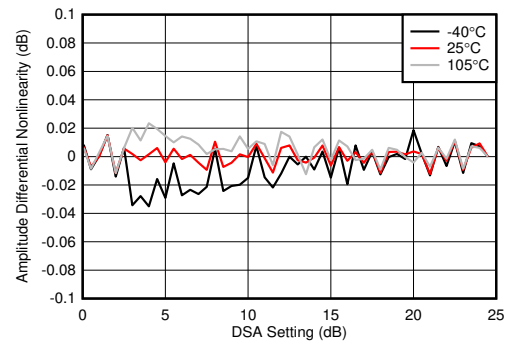
图 6-138. RX Input Phase vs Temperature at 3.6 GHz



With 3.6 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

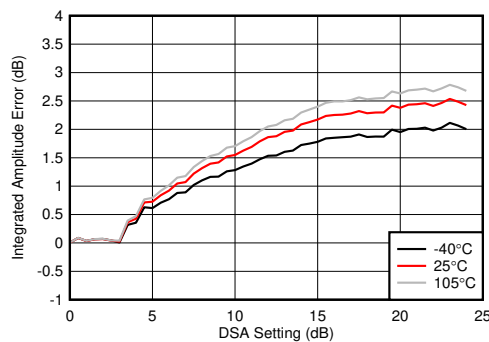
图 6-139. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

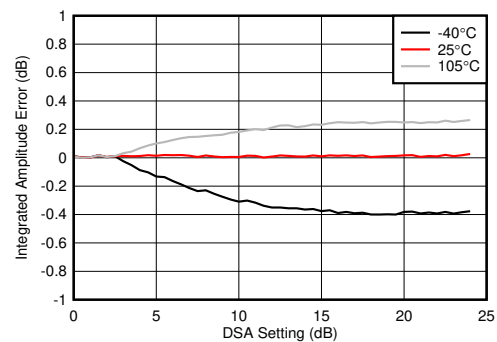
图 6-140. RX Calibrated Differential Amplitude Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-141. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 3.6 GHz



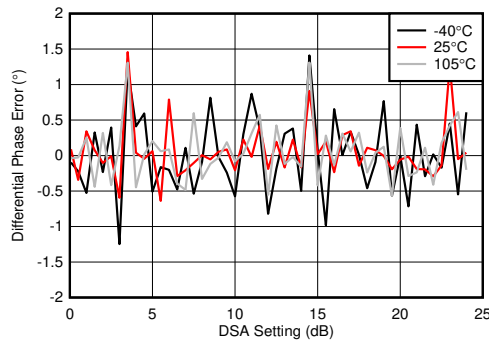
With 3.6 GHz matching

$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-142. RX Calibrated Integrated Amplitude Error vs DSA Setting at 3.6 GHz

6.11.5 RX Typical Characteristics 3.5GHz (continued)

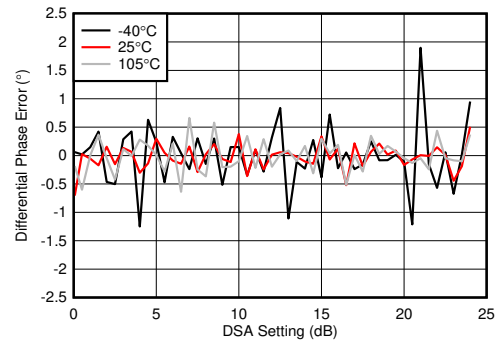
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 3.6 GHz matching

$$\text{Differential Phase Error} = \text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$$

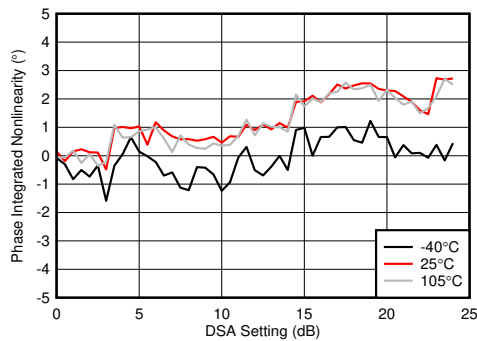
图 6-143. RX Uncalibrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

$$\text{Differential Phase Error} = \text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$$

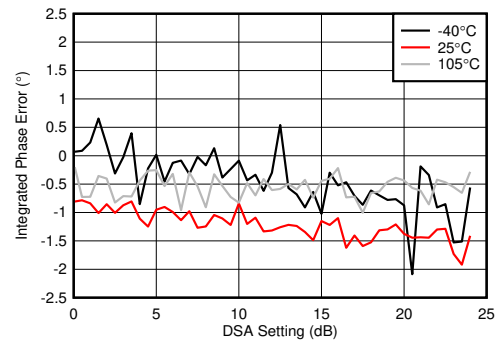
图 6-144. RX Calibrated Differential Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

$$\text{Integrated Phase Error} = \text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$$

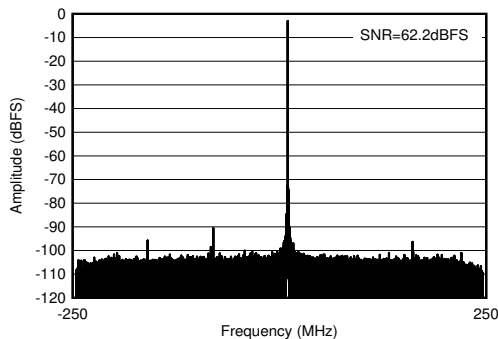
图 6-145. RX Uncalibrated Integrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

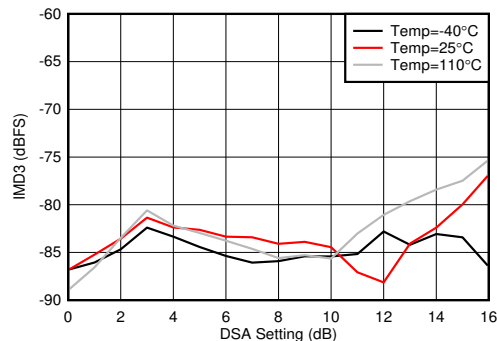
$$\text{Integrated Phase Error} = \text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$$

图 6-146. RX Calibrated Integrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching, $f_{\text{IN}} = 3610\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$

图 6-147. RX Output FFT at 3.6 GHz

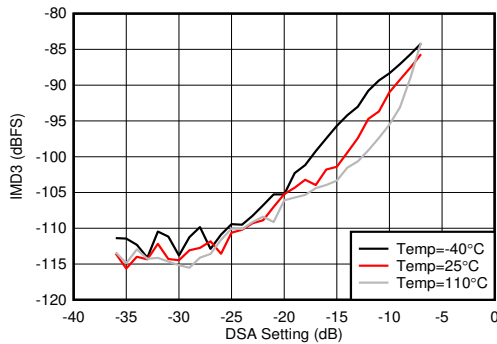


With 3.5 GHz matching, each tone at -7 dBFS , 20-MHz tone spacing

图 6-148. RX IMD3 vs DSA Setting and Temperature at 3.6 GHz

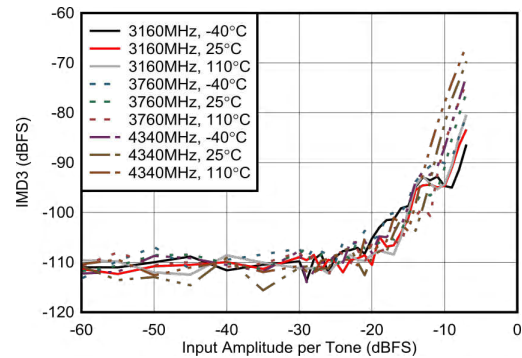
6.11.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



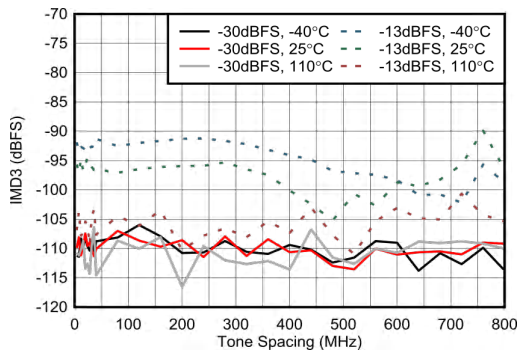
With 3.5 GHz matching, 20-MHz tone spacing

图 6-149. RX IMD3 vs Input Level and Temperature at 3.6 GHz



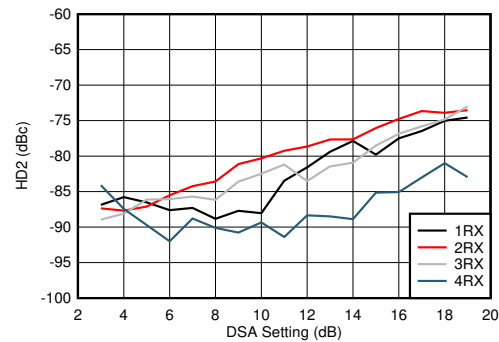
External clock mode, 20-MHz tone spacing, 2x Decimation

图 6-150. RX IMD3 vs Input Level



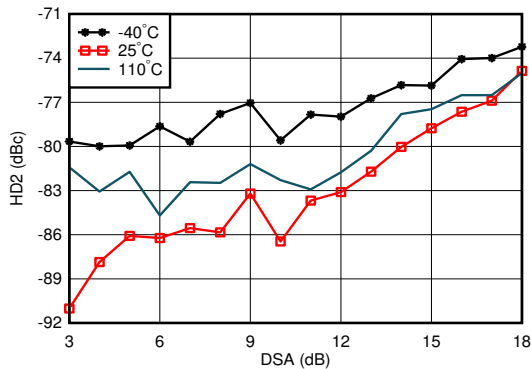
External clock mode, 2x Decimation

图 6-151. RX IMD3 vs Tone Spacing at 3.76GHz



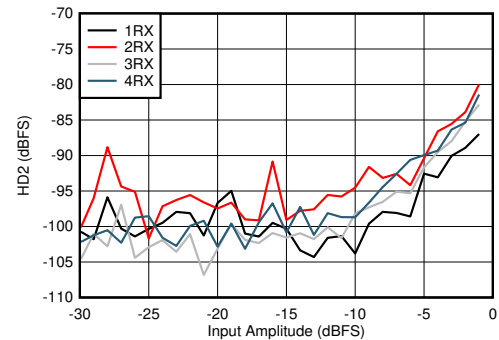
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-152. RX HD2 vs DSA Setting and Channel at 3.6 GHz



With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-153. RX HD2 vs DSA Setting and Temperature at 3.6 GHz

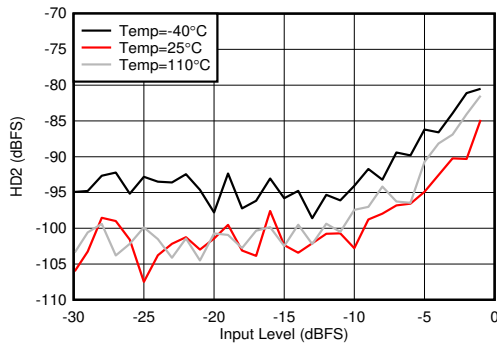


With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-154. RX HD2 vs Input Level and Channel at 3.6 GHz

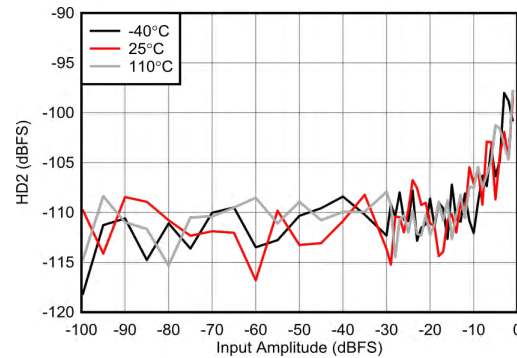
6.11.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



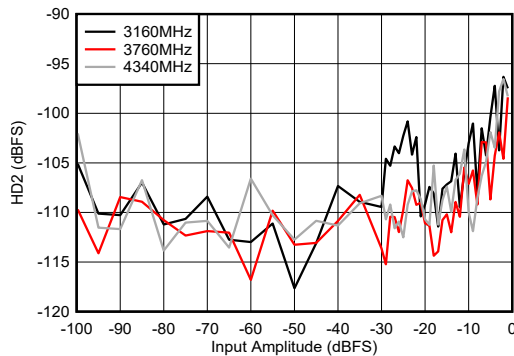
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-155. RX HD2 vs Input Level and Temperature at 3.6 GHz



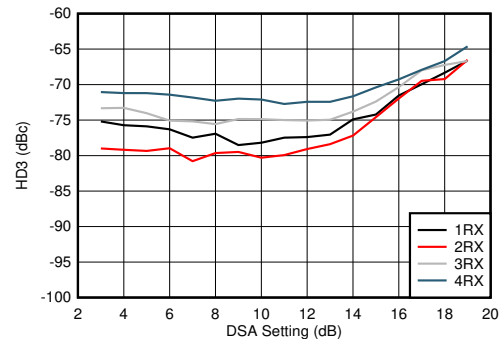
External clock mode, 2x Decimation

图 6-156. RX HD2 vs Input Level at 3.76 GHz



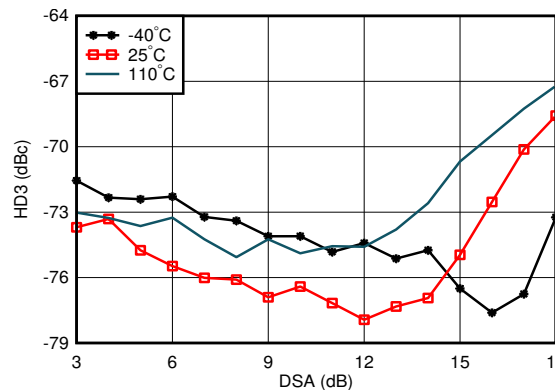
External clock mode, 25°C, 2x Decimation

图 6-157. RX HD2 vs Input Level



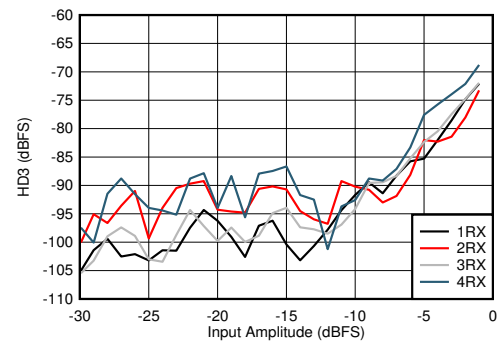
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-158. RX HD3 vs DSA Setting and Channel at 3.6 GHz



With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-159. RX HD3 vs DSA Setting and Temperature at 3.6 GHz

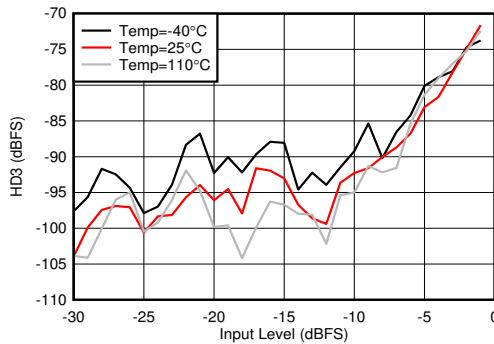


With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-160. RX HD3 vs Input Level and Channel at 3.6 GHz

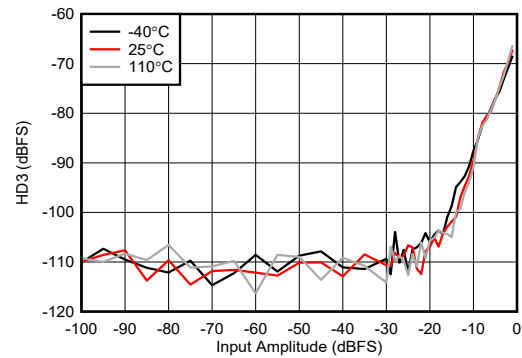
6.11.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



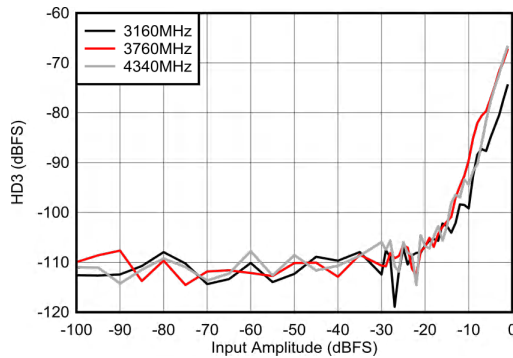
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-161. RX HD3 vs Input Level and Temperature at 3.6 GHz



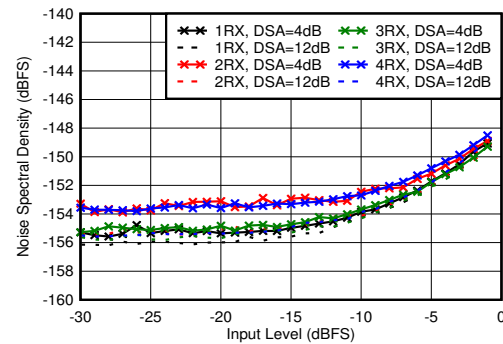
External clock mode, 2x Decimation

图 6-162. RX HD3 vs Input Level at 3.76GHz



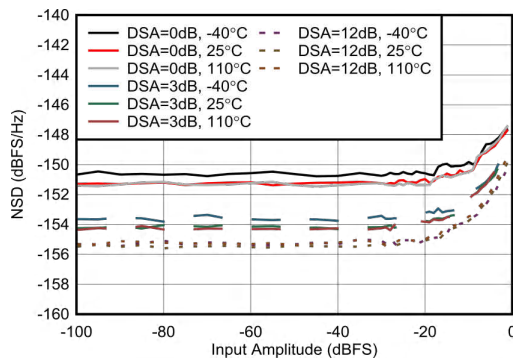
External clock mode, 25°C, 2x Decimation

图 6-163. RX HD3 vs Input Level



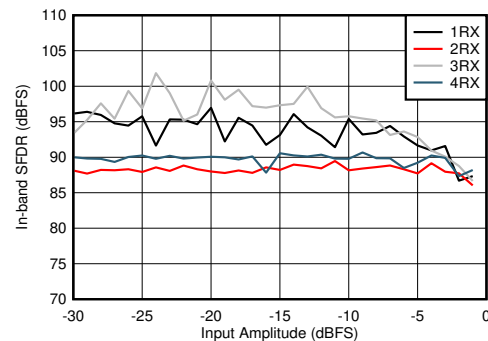
With 3.5 GHz matching, 12.5-MHz offset from tone

图 6-164. RX Noise Spectral Density vs Input Level and DSA Setting at 3.6 GHz



External clock mode, 25°C, 2x Decimation

图 6-165. RX Noise Spectral Density vs Input Level at 3.76GHz

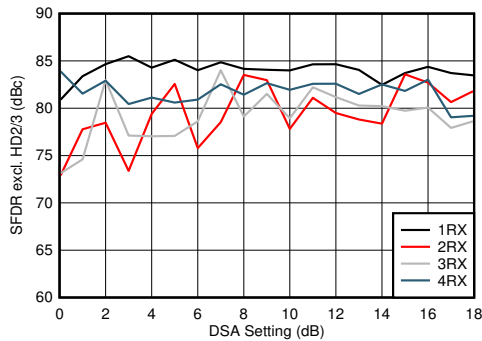


With 3.5 GHz matching

图 6-166. RX In-Band SFDR (±200 MHz) vs Input Level and Channel at 3.6 GHz

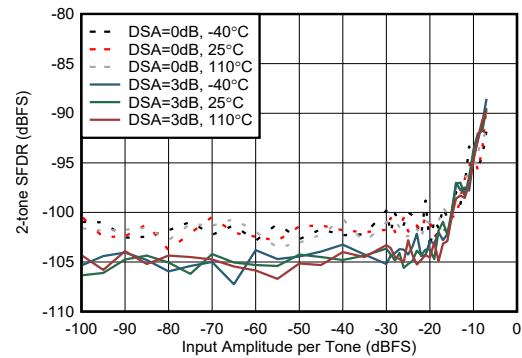
6.11.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



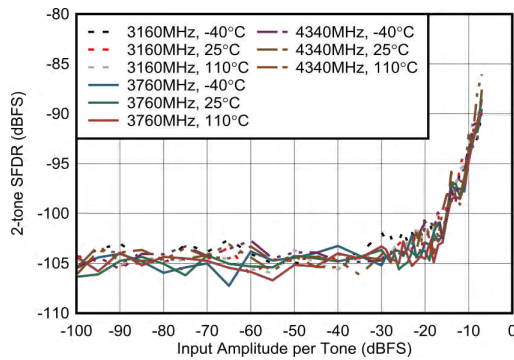
With 3.5 GHz matching

图 6-167. RX SFDR Excluding HD2/3 vs DSA Setting and Channel at 3.6 GHz



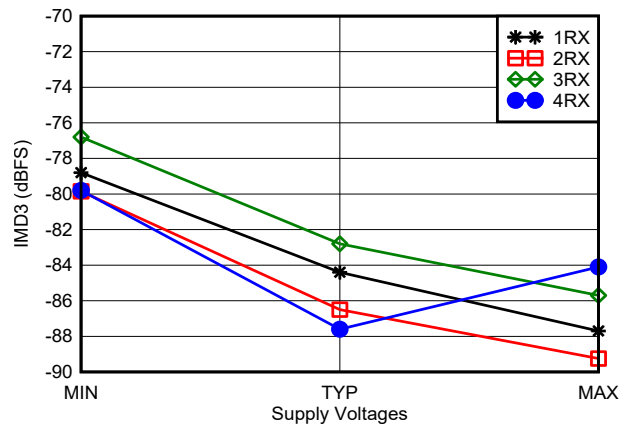
External clock mode, 20MHz tone spacing, excluding 3rd order distortion

图 6-168. RX 2-tone SFDR vs Input Amplitude and DSA Setting at 3.7 GHz



External clock mode, 20MHz tone spacing, excluding 3rd order distortion

图 6-169. RX 2-tone SFDR vs Input Amplitude and Frequency at 3.7 GHz

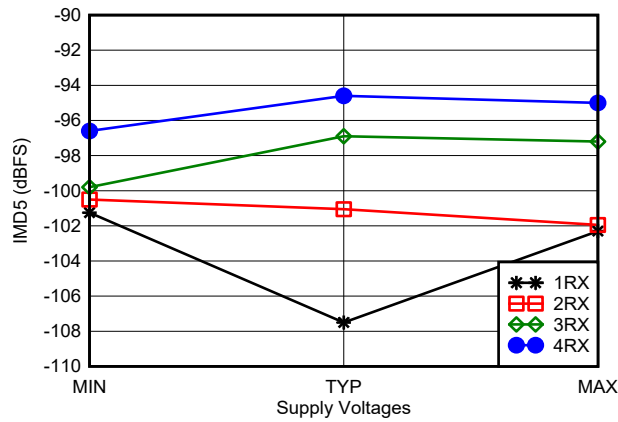


With 3.6 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-170. RX IMD3 vs Supply Voltage and Channel at 3.6 GHz

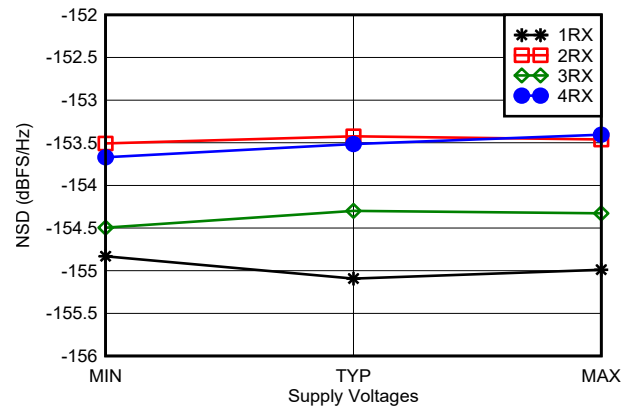
6.11.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



With 3.6 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-171. RX IMD5 vs Supply Voltage and Channel at 3.6 GHz

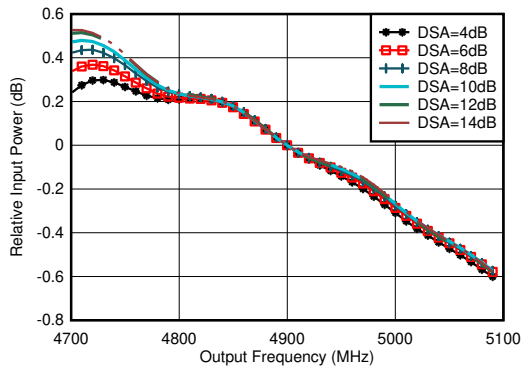


With 3.6 GHz matching, tone at -20 dBFS, 12.5-MHz offset frequency, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-172. RX Noise Spectral Density vs Supply Voltage and Channel at 3.6 GHz

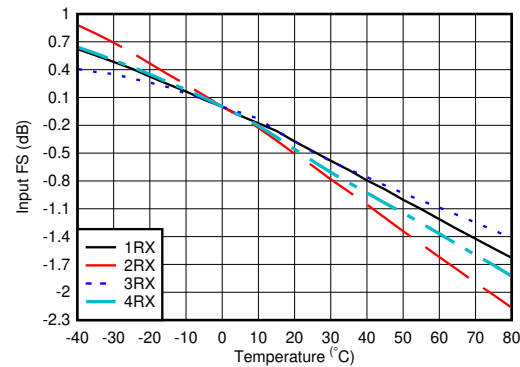
6.11.6 RX Typical Characteristics 4.9GHz

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



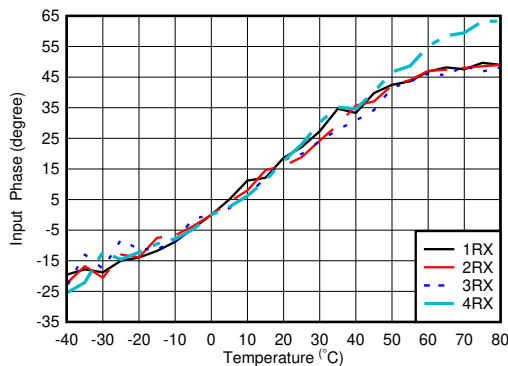
With matching, normalized to power at 4.9GHz for each DSA setting

图 6-173. RX Inband Gain Flatness, $f_{\text{IN}} = 4900\text{ MHz}$



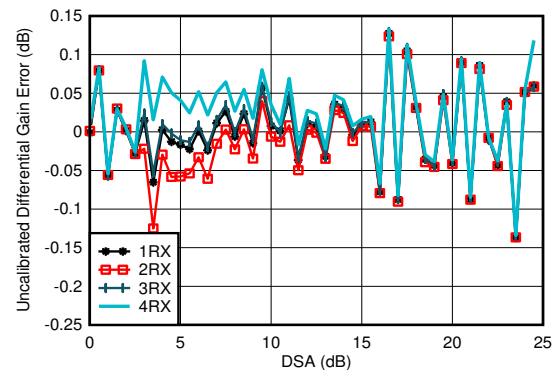
With 4.9 GHz matching, normalized to fullscale at 25°C for each channel

图 6-174. RX Input Fullscale vs Temperature and Channel at 4.9 GHz



With 4.9 GHz matching, normalized to phase at 25°C

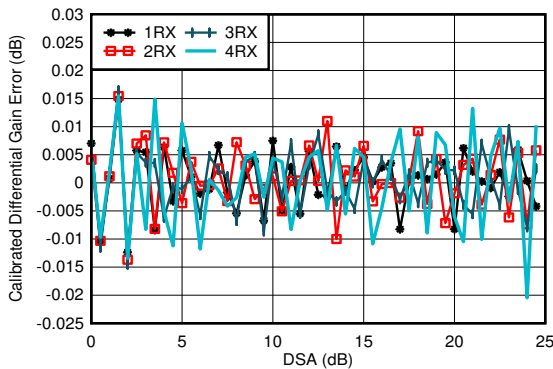
图 6-175. RX Input Phase vs Temperature and DSA at $f_{\text{OUT}} = 4.9\text{ GHz}$



With 4.9 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

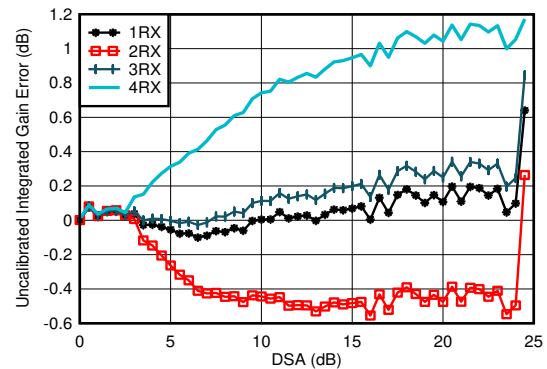
图 6-176. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

$$\text{Differential Amplitude Error} = P_{\text{IN}}(\text{DSA Setting} - 1) - P_{\text{IN}}(\text{DSA Setting}) + 1$$

图 6-177. RX Calibrated Differential Amplitude Error vs DSA Setting at 4.9 GHz



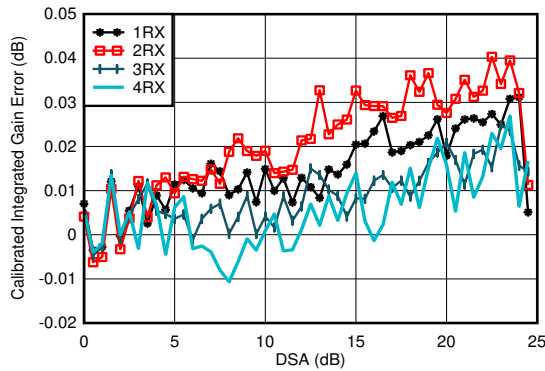
With 4.9 GHz matching

$$\text{Integrated Amplitude Error} = P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$$

图 6-178. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 4.9 GHz

6.11.6 RX Typical Characteristics 4.9GHz (continued)

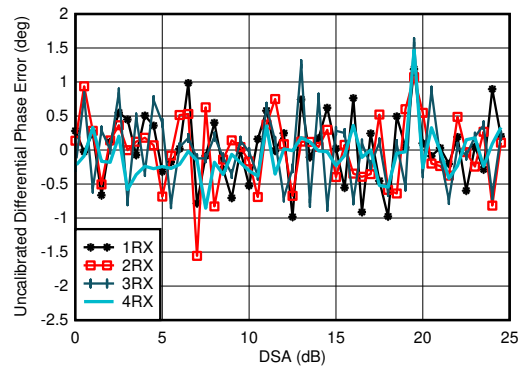
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 4.9 GHz matching

Integrated Amplitude Error = $P_{\text{IN}}(\text{DSA Setting}) - P_{\text{IN}}(\text{DSA Setting} = 0) + (\text{DSA Setting})$

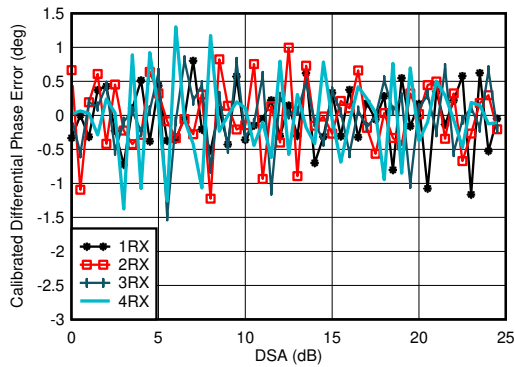
图 6-179. RX Calibrated Integrated Amplitude Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

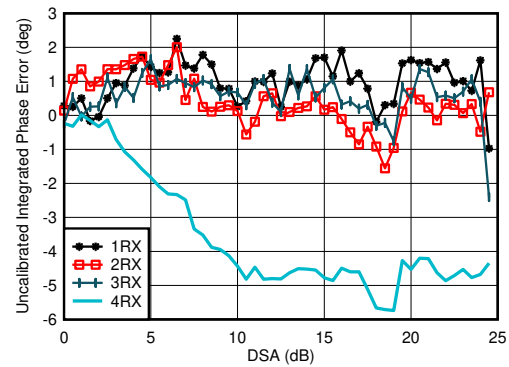
图 6-180. RX Uncalibrated Differential Phase Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

Differential Phase Error = $\text{Phase}_{\text{IN}}(\text{DSA Setting} - 1) - \text{Phase}_{\text{IN}}(\text{DSA Setting})$

图 6-181. RX Calibrated Differential Phase Error vs DSA Setting at 4.9 GHz



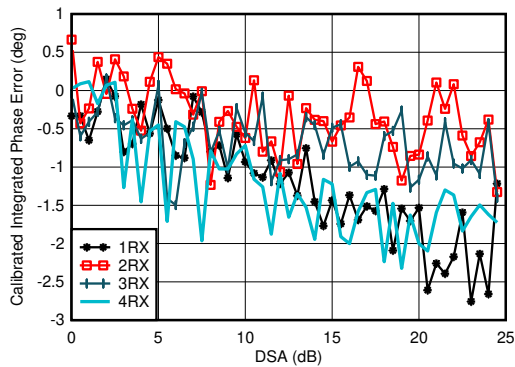
With 4.9 GHz matching

Integrated Phase Error = $\text{Phase}(\text{DSA Setting}) - \text{Phase}(\text{DSA Setting} = 0)$

图 6-182. RX Uncalibrated Integrated Phase Error vs DSA Setting at 4.9 GHz

6.11.6 RX Typical Characteristics 4.9GHz (continued)

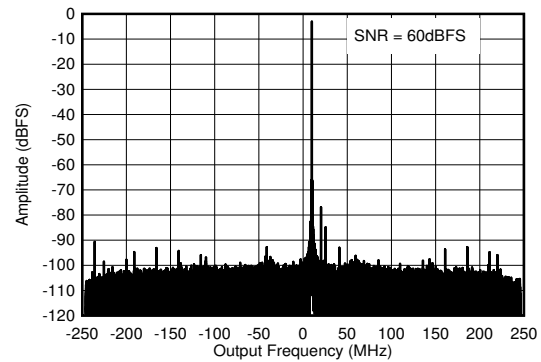
Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



With 4.9 GHz matching

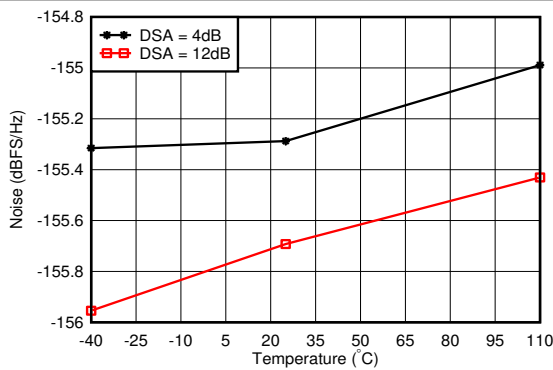
Integrated Phase Error = Phase(DSA Setting) - Phase(DSA Setting = 0)

图 6-183. RX Calibrated Integrated Phase Error vs DSA Setting at 4.9 GHz



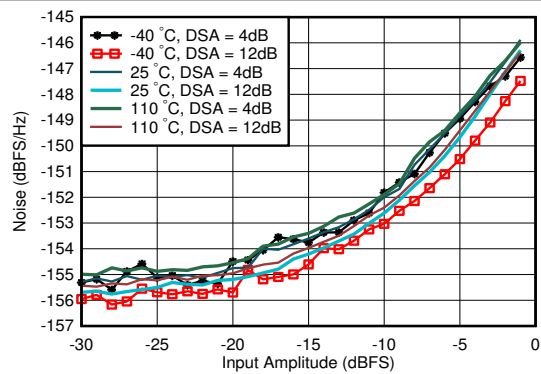
With 4.9 GHz matching, $f_{\text{IN}} = 4910\text{ MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$

图 6-184. RX Output FFT at 4.9 GHz



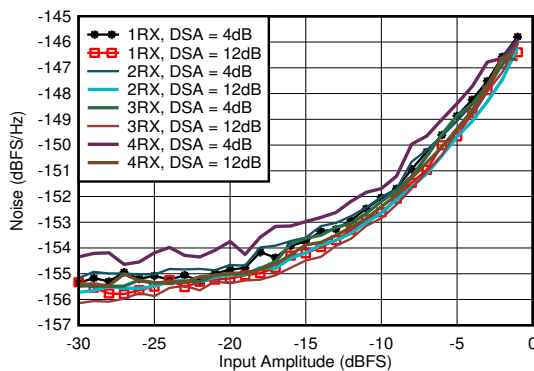
With 4.9 GHz matching, 12.5-MHz offset from tone

图 6-185. RX Noise Spectral Density vs Temperature at 4.9 GHz



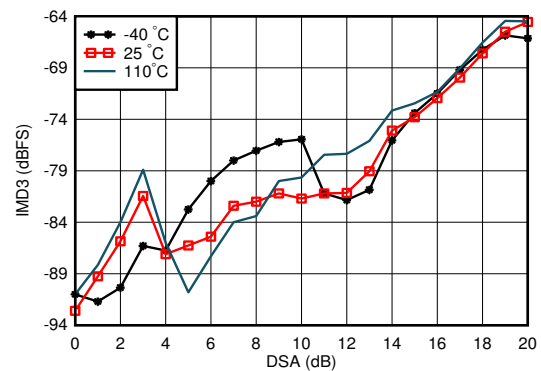
With 4.9 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 6-186. RX Noise Spectral Density vs Input Amplitude and Temperature at 4.9 GHz



With 4.9 GHz matching, 12.5-MHz offset from tone

图 6-187. RX Noise Spectral Density vs Input Amplitude and Channel at 4.9 GHz

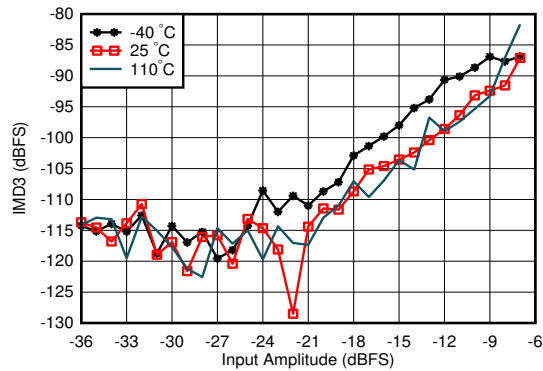


With 4.9 GHz matching, each tone -7 dBFS , tone spacing = 20 MHz

图 6-188. RX IMD3 vs DSA Setting and Temperature at 4.9 GHz

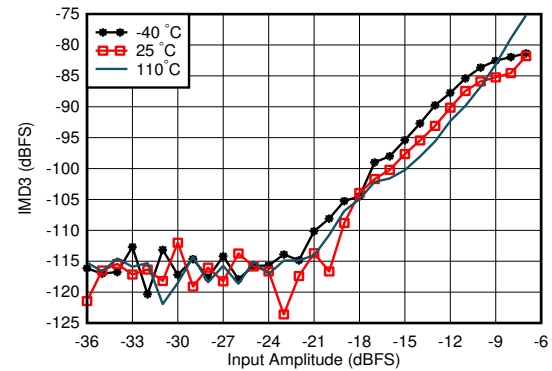
6.11.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



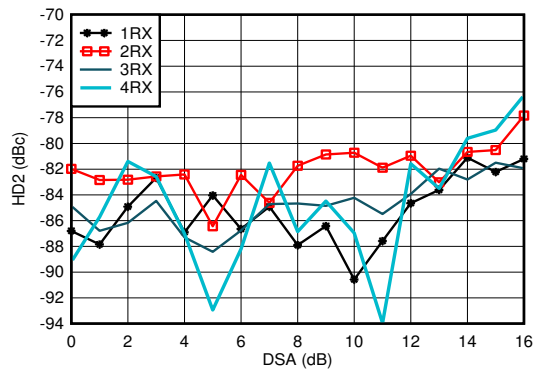
With 4.9 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 6-189. RX IMD3 vs Input Level and Temperature at 4.9 GHz



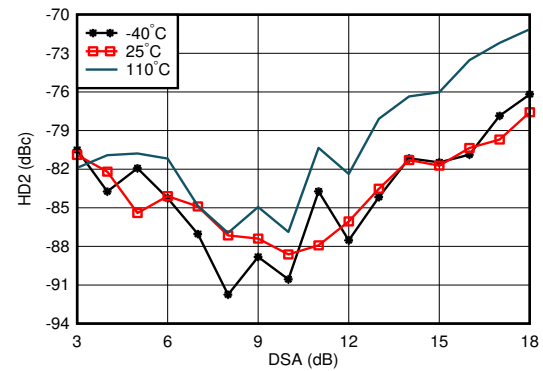
With 4.9 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 6-190. RX IMD3 vs Input Level and Temperature at 4.9 GHz



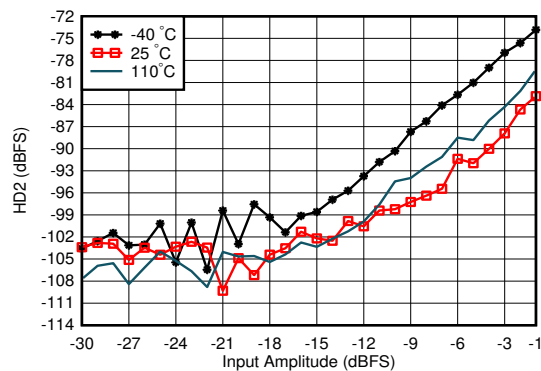
With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-191. RX HD2 vs DSA Setting and Channel at 4.9 GHz



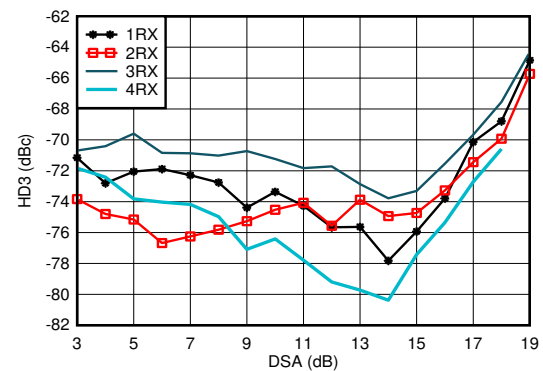
With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-192. RX HD2 vs DSA and Temperature at 4.9 GHz



With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 6-193. RX HD2 vs Input Level and Temperature at 4.9 GHz

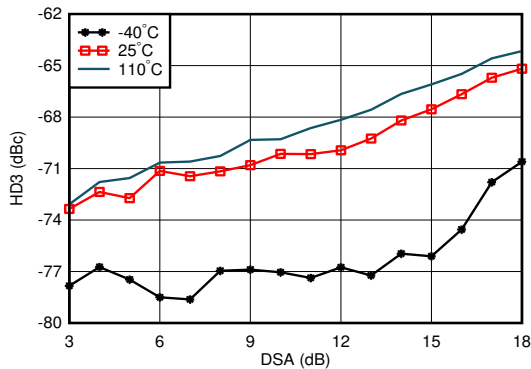


With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-194. RX HD3 vs DSA Setting and Channel at 4.9 GHz

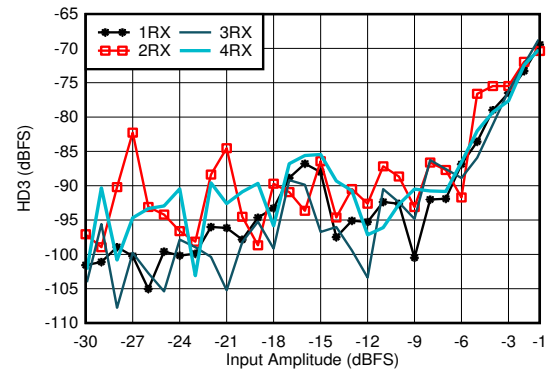
6.11.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3\text{ dBFS}$, DSA setting = 4 dB.



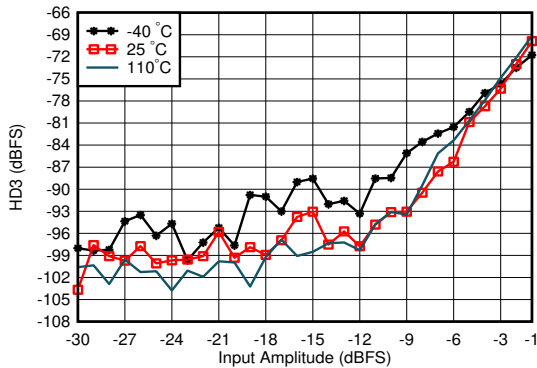
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-195. RX HD3 vs DSA Setting and Temperature at 4.9 GHz



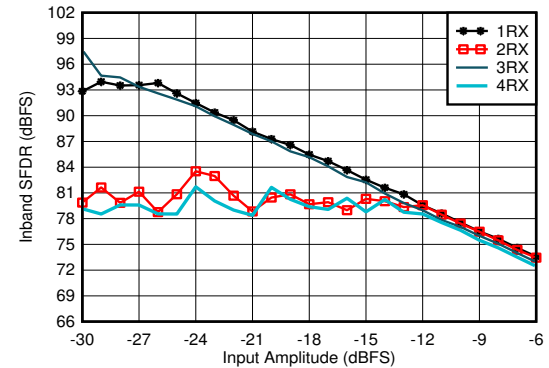
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-196. RX HD3 vs Input Level and Channel at 4.9 GHz



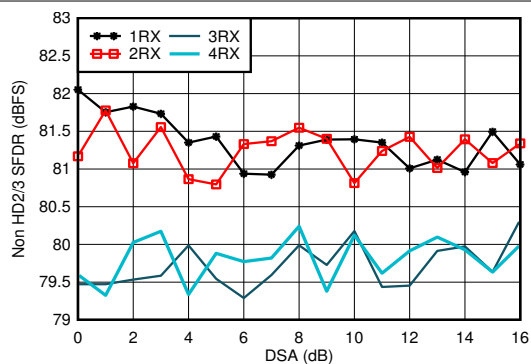
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 6-197. RX HD3 vs Input Level and Temperature at 4.9 GHz



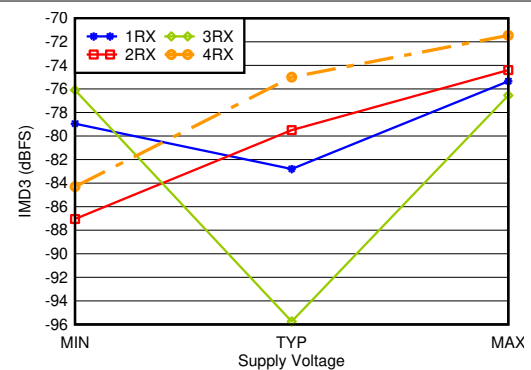
With 4.9 GHz matching, decimate by 3

图 6-198. RX In-Band SFDR ($\pm 400\text{ MHz}$) vs Input Amplitude and Channel at 4.9 GHz



With 4.9 GHz matching

图 6-199. RX Non-HD2/3 vs DSA Setting at 4.9 GHz

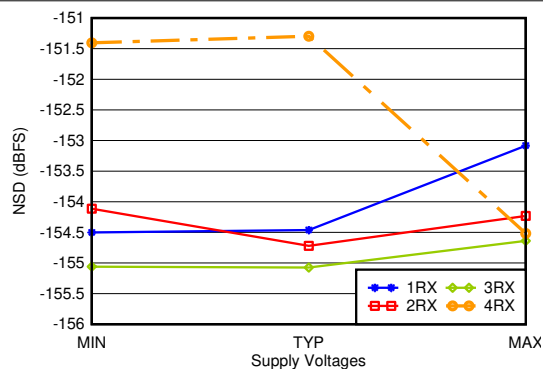


With 4.9 GHz matching, -7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-200. RX IMD3 vs Supply and Channel at 4.9 GHz

6.11.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$, ADC Sampling Rate = 2949.12 MHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with $f_{\text{REF}} = 491.52\text{MHz}$, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 4 dB.



With 4.9 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 6-201. RX Noise Spectral Density vs Supply and Channel at 4.9 GHz

6.11.7 RX Typical Characteristics 6.8GHz

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 3000MSPS, output sample rate = 1500MSPS (decimate by 2x), External clock mode, $A_{\text{IN}} = -3 \text{ dBFS}$, DSA setting = 3 dB.

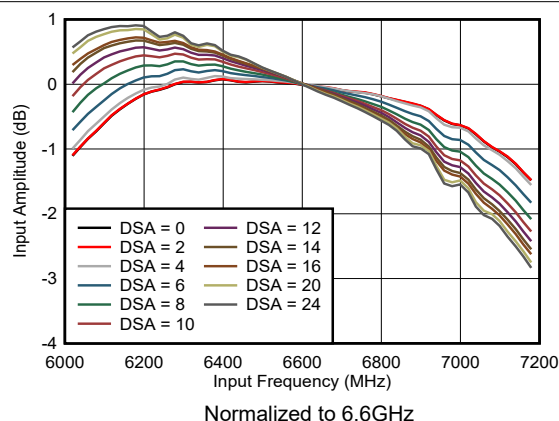


图 6-202. RX In-Band Gain Flatness

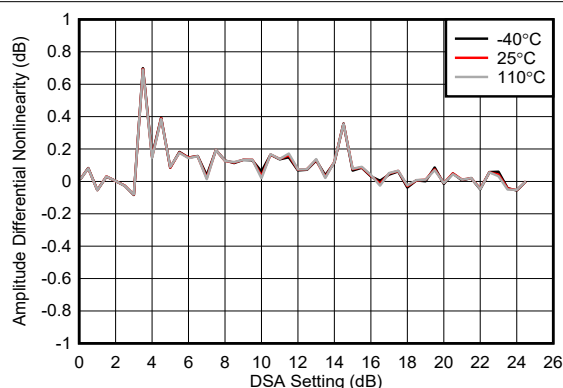


图 6-203. RX Uncalibrated Differential Amplitude Error at 6.851GHz

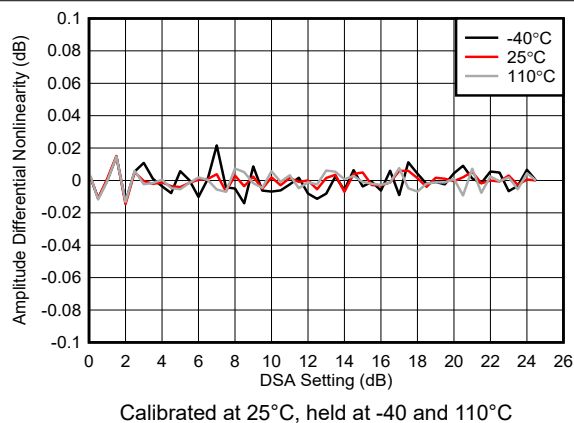


图 6-204. RX Calibrated Differential Amplitude Error at 6.851GHz

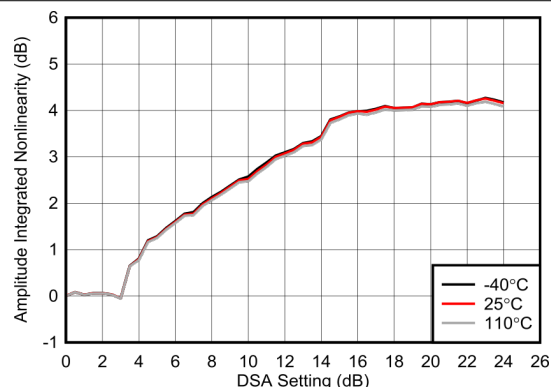
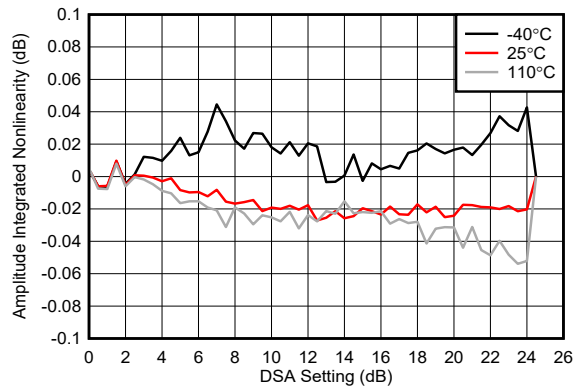


图 6-205. RX Uncalibrated Integrated Amplitude Error at 6.851GHz

6.11.7 RX Typical Characteristics 6.8GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 3000MSPS, output sample rate = 1500MSPS (decimate by 2x), External clock mode, $A_{IN} = -3\text{ dBFS}$, DSA setting = 3 dB.



Calibrated at 25°C, held at -40 and 110°C

图 6-206. RX Calibrated Integrated Amplitude Error at 6.851GHz

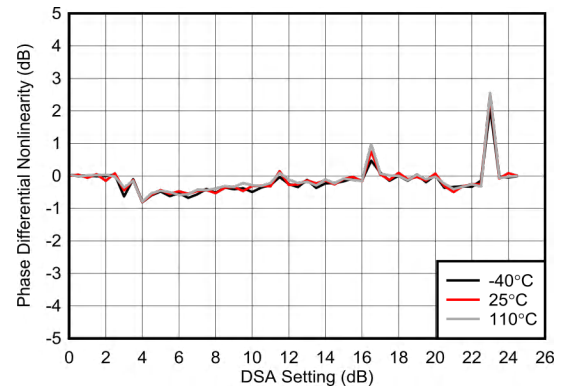
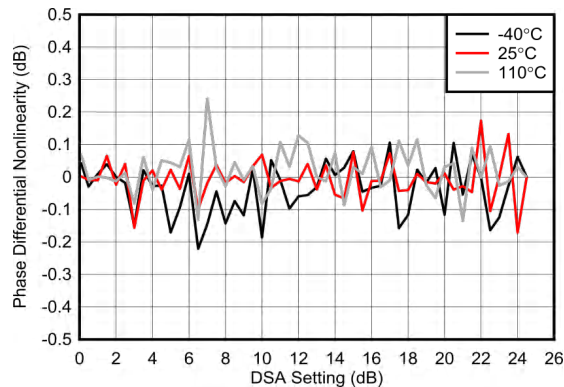


图 6-207. RX Uncalibrated Differential Phase Error at 6.851GHz



Calibrated at 25°C, held at -40 and 110°C

图 6-208. RX Calibrated Differential Phase Error at 6.851GHz

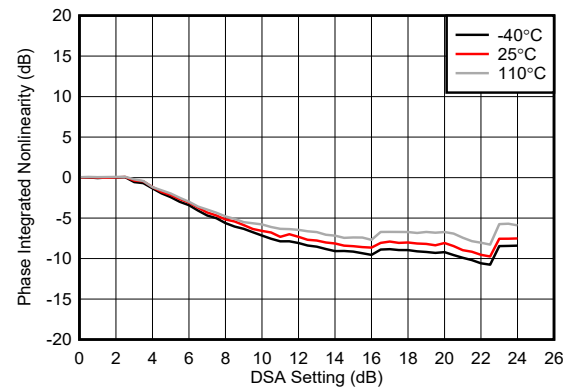
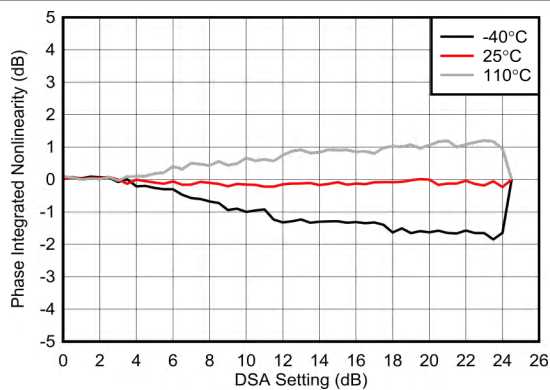
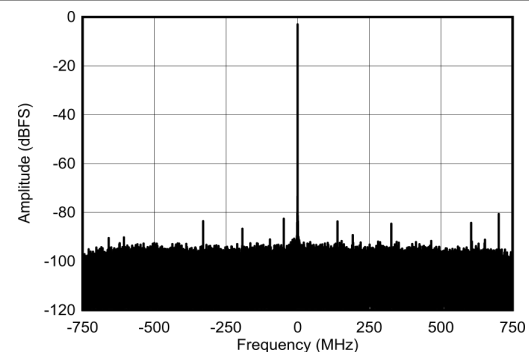


图 6-209. RX Uncalibrated Integrated Phase Error at 6.851GHz



Calibrated at 25°C, held at -40 and 110°C

图 6-210. RX Calibrated Integrated Phase Error at 6.851GHz



$F_{NCO} = 6.851\text{GHz}$, F_{IN} offset -130kHz

图 6-211. RX Output FFT at 6.851GHz and -3dBFS

6.11.7 RX Typical Characteristics 6.8GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 3000MSPS, output sample rate = 1500MSPS (decimate by 2x), External clock mode, $A_{IN} = -3\text{ dBFS}$, DSA setting = 3 dB.

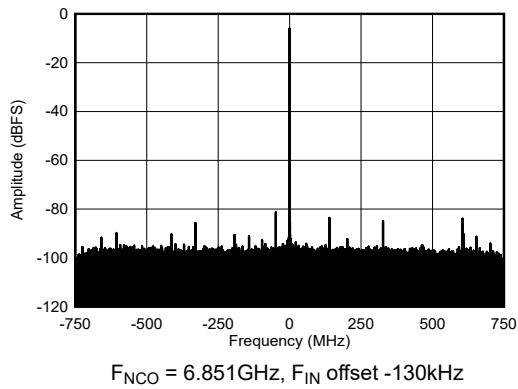


图 6-212. RX Output FFT at 6.851GHz and -6dBFS

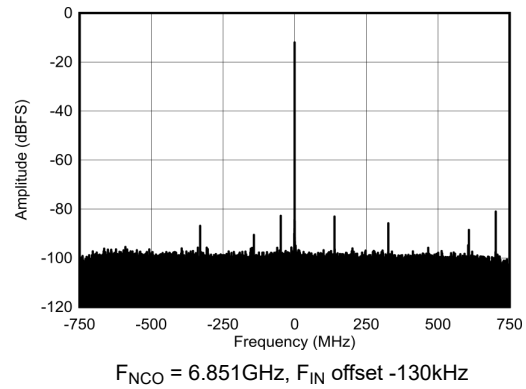


图 6-213. RX Output FFT at 6.851GHz and -12dBFS

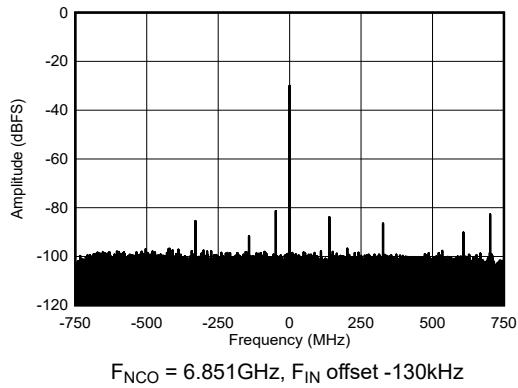


图 6-214. RX Output FFT at 6.851GHz and -30dBFS

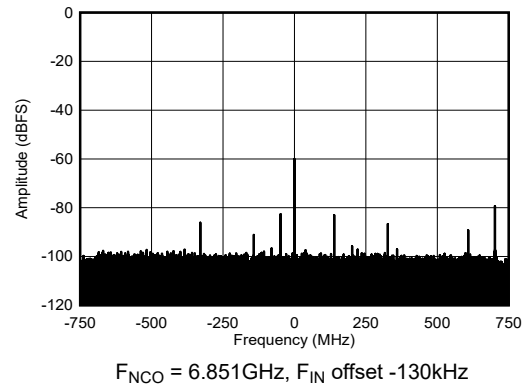


图 6-215. RX Output FFT at 6.851GHz and -60dBFS

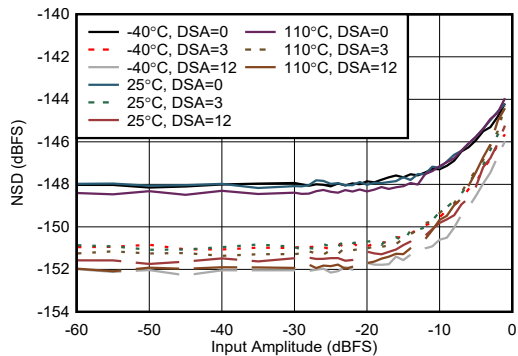


图 6-216. RX NSD vs Input Amplitude at 6.851GHz

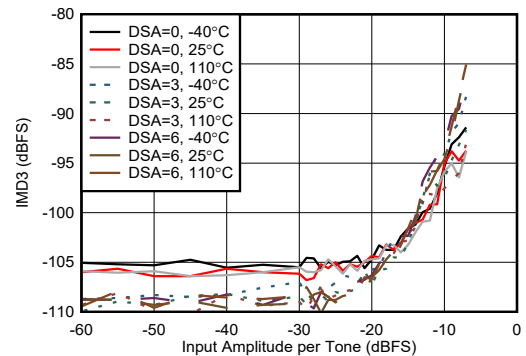


图 6-217. RX IMD3 vs Input Amplitude at 6.851GHz

6.11.7 RX Typical Characteristics 6.8GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 3000MSPS, output sample rate = 1500MSPS (decimate by 2x), External clock mode, $A_{IN} = -3\text{ dBFS}$, DSA setting = 3 dB.

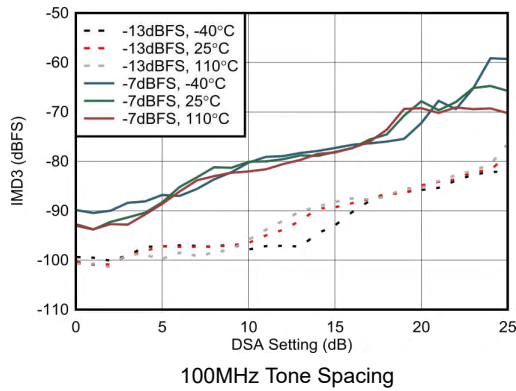


图 6-218. RX IMD3 vs DSA Setting at 6.851GHz

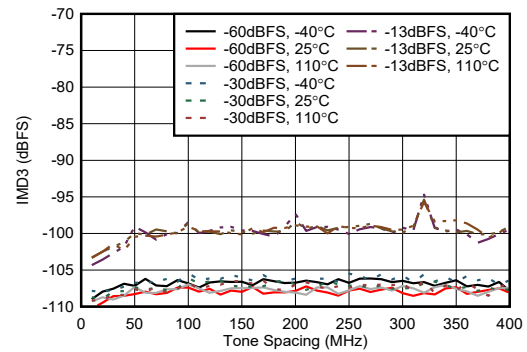


图 6-219. RX IMD3 vs Tone Spacing at 6.851GHz

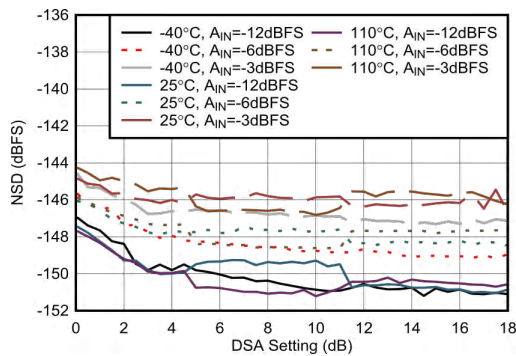


图 6-220. RX NSD vs DSA Setting at 6.851GHz

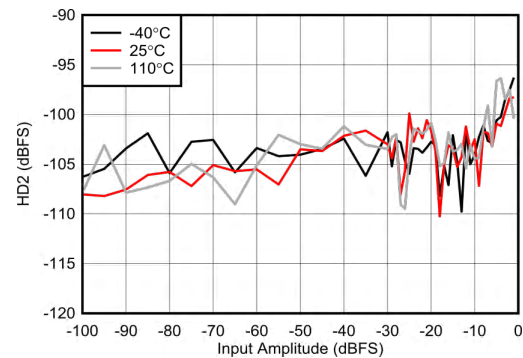


图 6-221. RX HD2 vs Input Amplitude at 6.851GHz

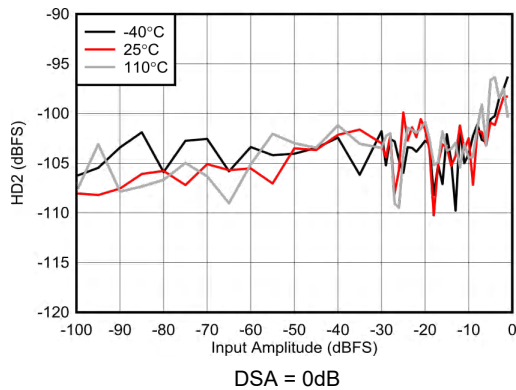


图 6-222. RX HD2 vs Input Amplitude at 6.851GHz

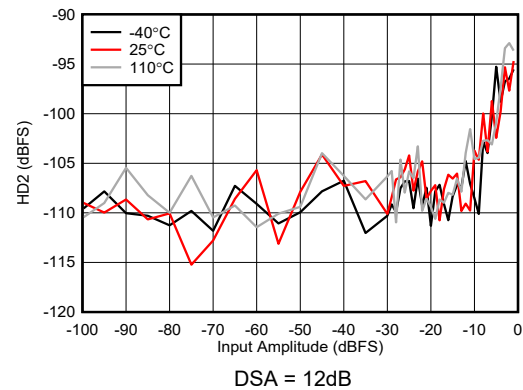


图 6-223. RX HD2 vs Input Amplitude at 6.851GHz

6.11.7 RX Typical Characteristics 6.8GHz (continued)

Typical values at $T_A = +25^\circ\text{C}$. Default conditions at 30MHz: ADC Sampling Rate = 3000MSPS, output sample rate = 1500MSPS (decimate by 2x), External clock mode, $A_{IN} = -3\text{ dBFS}$, DSA setting = 3 dB.

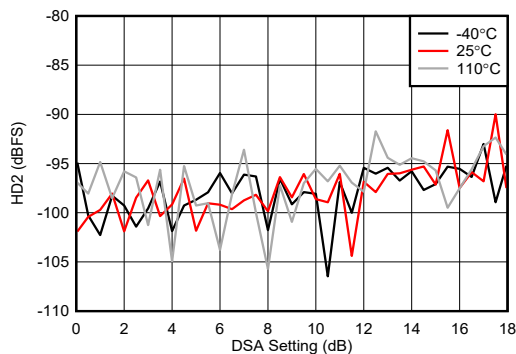


图 6-224. RX HD2 vs DSA Setting at 6.851GHz

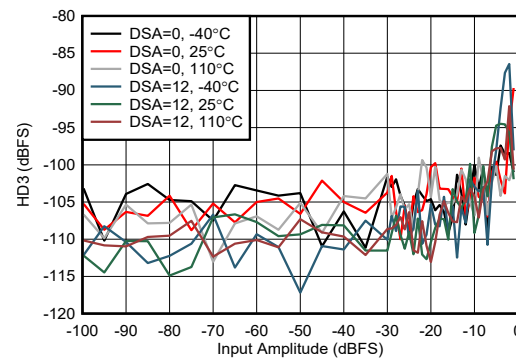


图 6-225. RX HD3 vs Input Amplitude at 6.851GHz

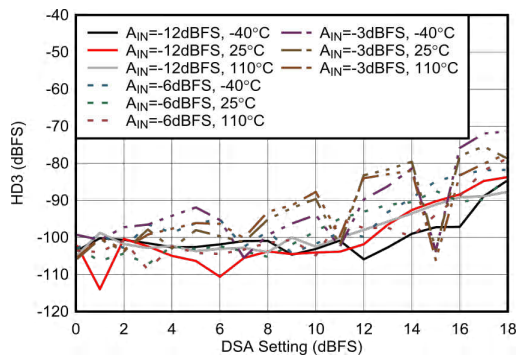
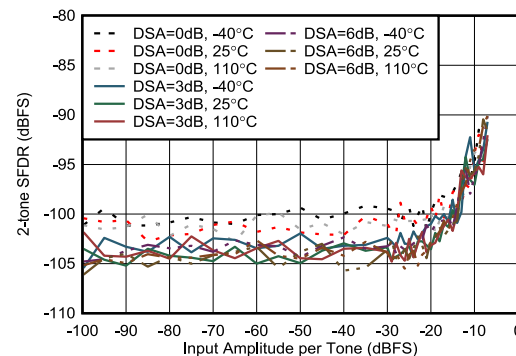


图 6-226. RX HD3 vs DSA Setting at 6.851GHz



100MHz tone spacing, excluding 3rd order distortion

图 6-227. RX 2-tone SFDR vs Input Amplitude at 6.85GHz

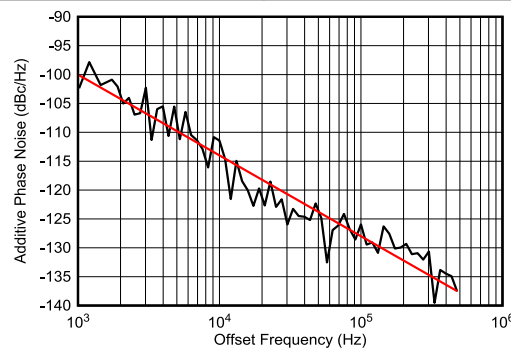
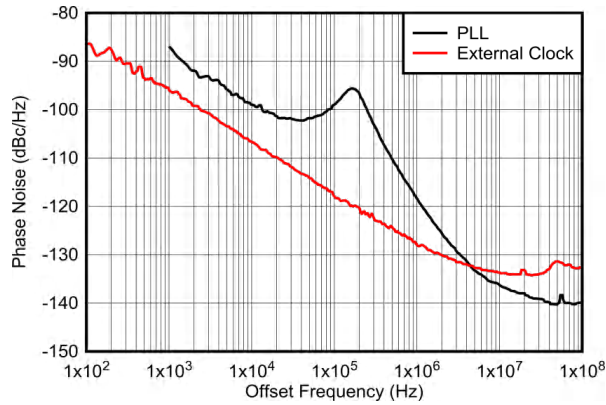


图 6-228. RX Additive Phase Noise at 6.85GHz

6.11.8 PLL and Clock Typical Characteristics

Typical values at $T_A = +25^\circ\text{C}$ with nominal supplies. Unless otherwise noted, $f_{\text{REF}} = 491.52 \text{ MHz}$, Phase noise measured at TX output



measured at TX output, normalized to 12GHz by $20 \cdot \log_{10}(12\text{GHz}/f_{\text{OUT}})$

图 6-229. Phase Noise vs Offset Frequency for PLL and External Clock at 12GHz

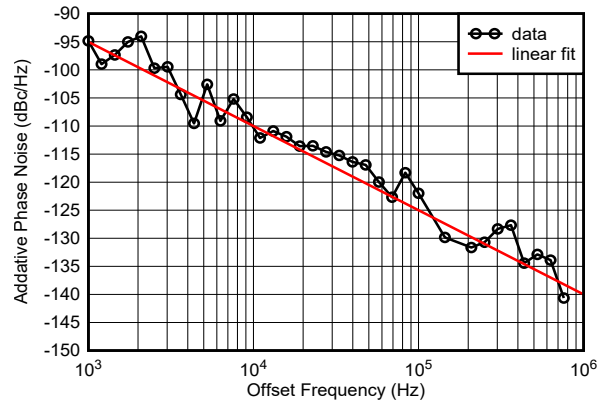
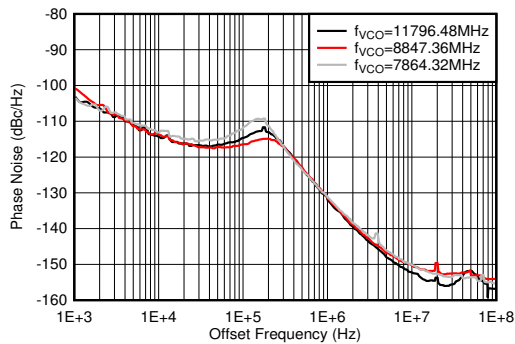
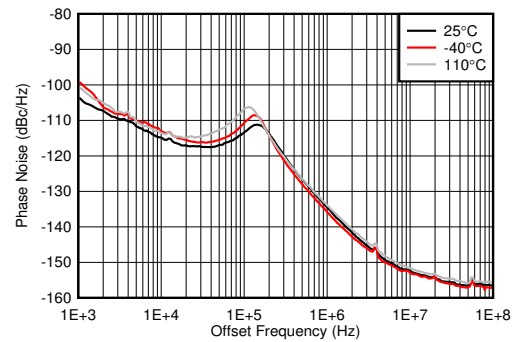


图 6-230. RX Additive Phase Noise at 9.61GHz



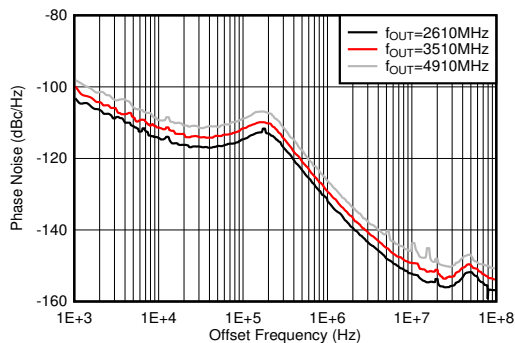
PLL enabled, $f_{\text{REF}} = 491.52\text{MSPS}$, measured at 2TXOUT

图 6-231. Phase Noise vs Offset Frequency and f_{VCO} at $f_{\text{OUT}} = 2610 \text{ MHz}$



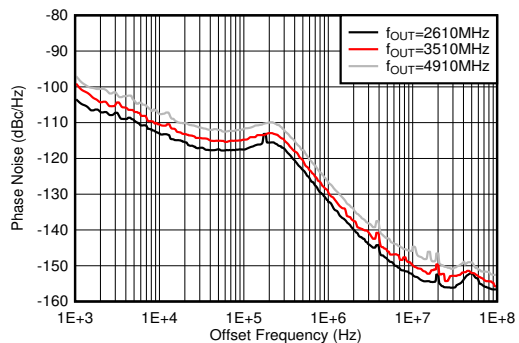
PLL enabled, $f_{\text{VCO}} = 11796.48 \text{ MHz}$, $f_{\text{REF}} = 491.52\text{MSPS}$, measured at 2TXOUT

图 6-232. Phase Noise for 12-GHz VCO vs Offset Frequency and Temperature at $f_{\text{OUT}} = 1910 \text{ MHz}$



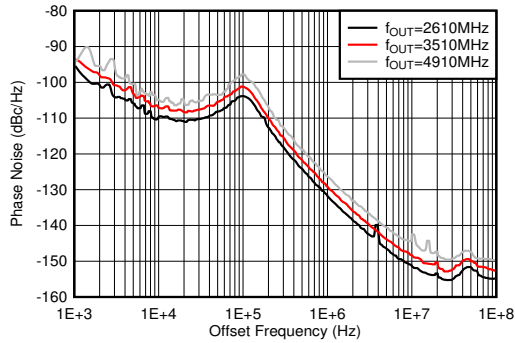
PLL enabled, $f_{\text{VCO}} = 11796.48 \text{ MHz}$, $f_{\text{REF}} = 491.52\text{MSPS}$, measured at 2TXOUT

图 6-233. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



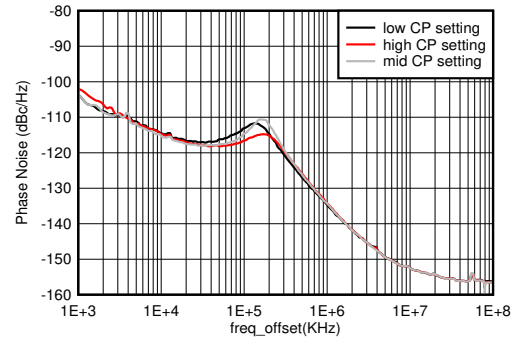
PLL enabled, $f_{\text{VCO}} = 11796.48 \text{ MHz}$, $f_{\text{REF}} = 491.52\text{MSPS}$, measured at 2TXOUT

图 6-234. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at -40°C



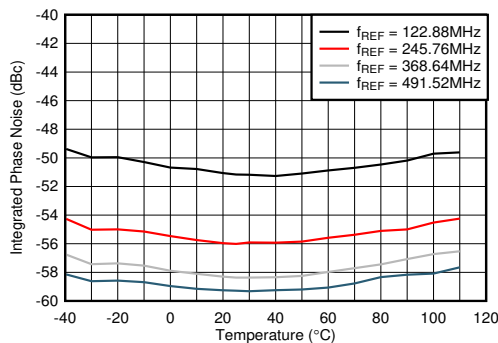
PLL enabled, $f_{VCO} = 11796.48$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-235. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at 110°C



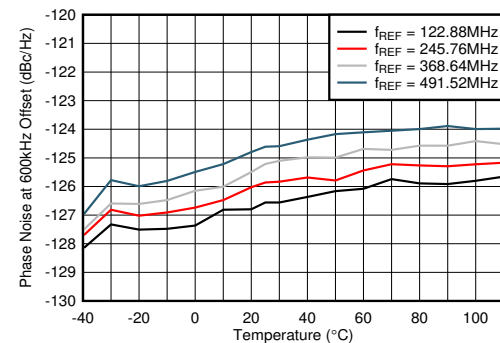
PLL enabled, $f_{VCO} = 11796.48$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-236. Phase Noise for 12-GHz VCO vs Offset Frequency and CP Setting at $f_{OUT} = 2.6$ GHz



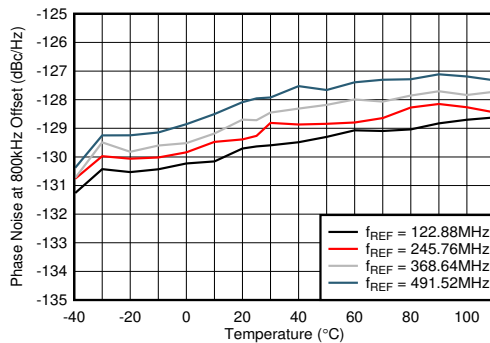
PLL enabled, $f_{VCO} = 11796.48$ MHz, 1-kHz to 100-MHz, single-sided integration bandwidth, measured at 2TXOUT

图 6-237. Integrated Phase Noise for 12-GHz VCO vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



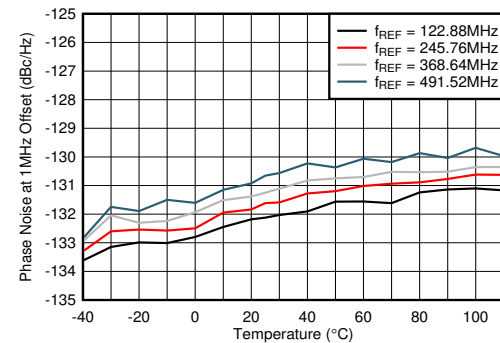
PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-238. Phase Noise for 12-GHz VCO at 600kHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



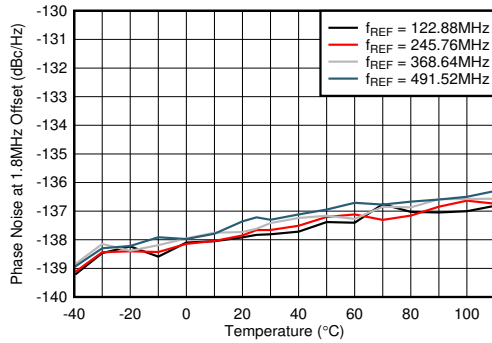
A. PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-239. Phase Noise for 12-GHz VCO at 800-kHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



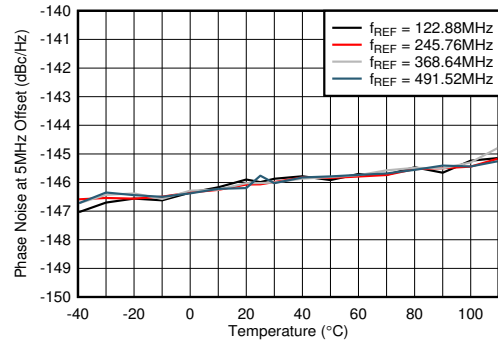
PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-240. Phase Noise for 12-GHz VCO at 1-MHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



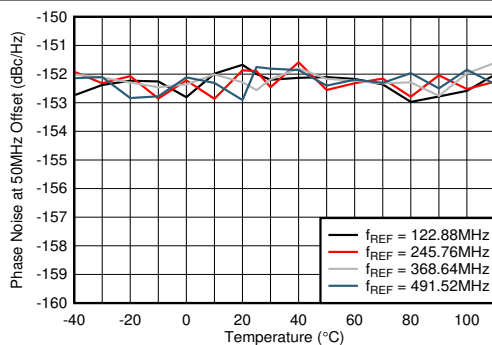
PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-241. Phase Noise for 12-GHz VCO at 1.8-MHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



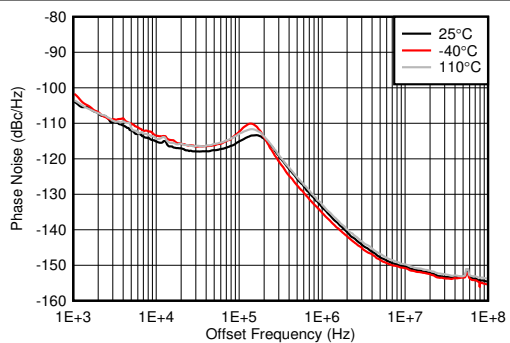
PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-242. Phase Noise for 12-GHz VCO at 5-MHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



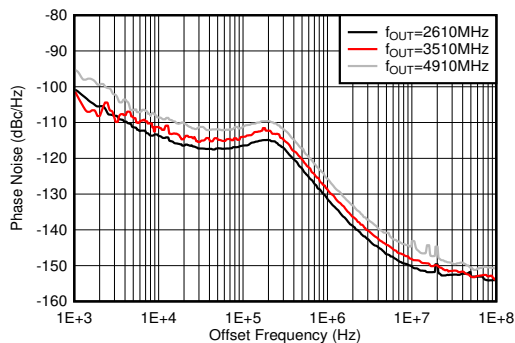
PLL enabled, $f_{VCO} = 11796.48$ MHz, measured at 2TXOUT

图 6-243. Phase Noise for 12-GHz VCO at 50-MHz Offset vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



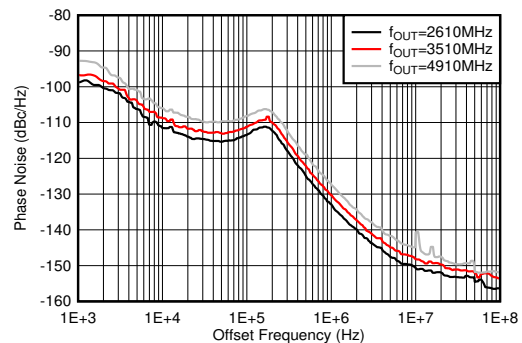
PLL enabled, $f_{VCO} = 9830.4$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-244. Phase Noise for 10-GHz VCO vs Offset Frequency and Temperature at $f_{OUT} = 1910$ MHz



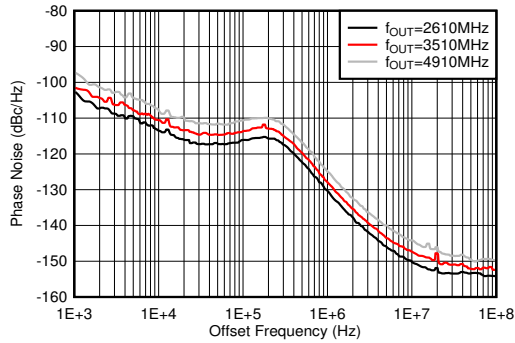
PLL enabled, $f_{VCO} = 9830.4$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-245. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



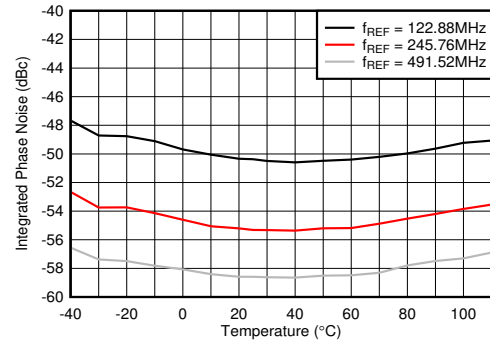
PLL enabled, $f_{VCO} = 9830.4$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-246. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at -40°C



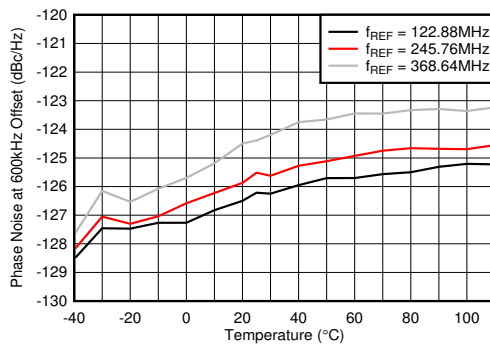
PLL enabled, $f_{VCO} = 9830.4$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-247. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at 110°C



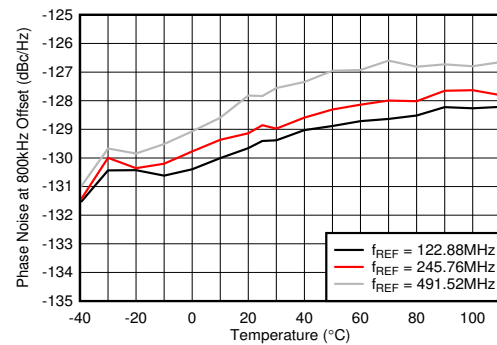
PLL enabled, $f_{VCO} = 9830.4$ MHz, 1-kHz to 100-MHz, single-sided integration bandwidth, measured at 2TXOUT

图 6-248. Integrated Phase Noise for 10-GHz VCO vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



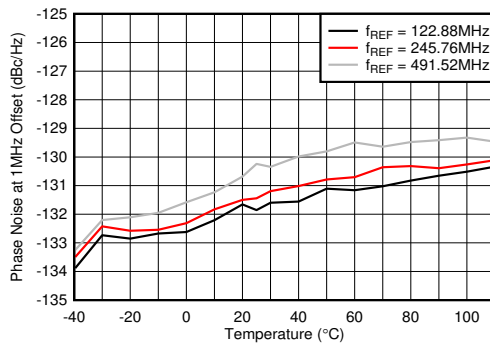
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-249. Phase Noise for 10-GHz VCO at 600 kHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



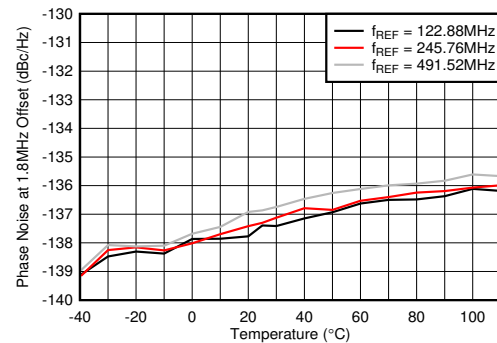
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-250. Phase Noise for 10-GHz VCO at 800 kHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



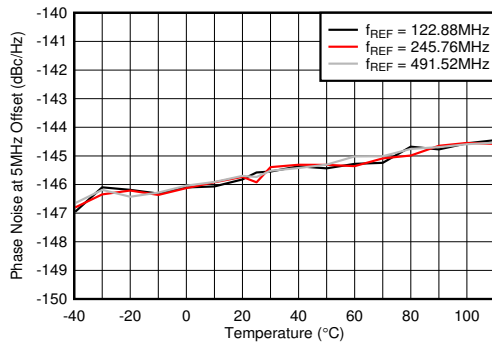
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-251. Phase Noise for 10-GHz VCO at 1 MHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



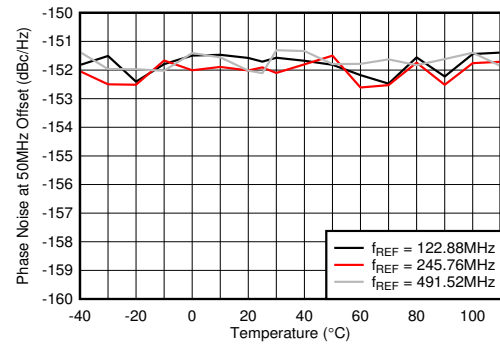
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-252. Phase Noise for 10-GHz VCO at 1.8 MHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



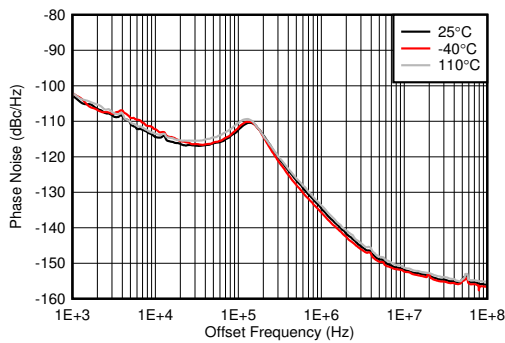
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-253. Phase Noise for 10-GHz VCO at 5 MHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



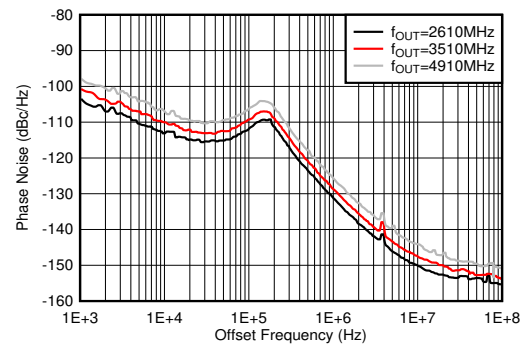
PLL enabled, $f_{VCO} = 9830.4$ MHz, measured at 2TXOUT

图 6-254. Phase Noise for 10-GHz VCO at 50 MHz vs Temperature and f_{REF} at $f_{OUT} = 2.6$ GHz



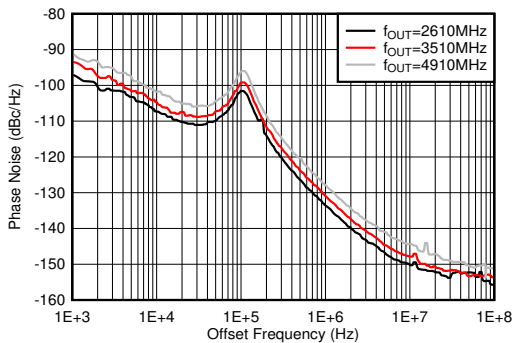
PLL enabled, $f_{VCO} = 8847.36$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-255. Phase Noise for 9-GHz VCO vs Offset Frequency and Temperature at $f_{OUT} = 1910$ MHz



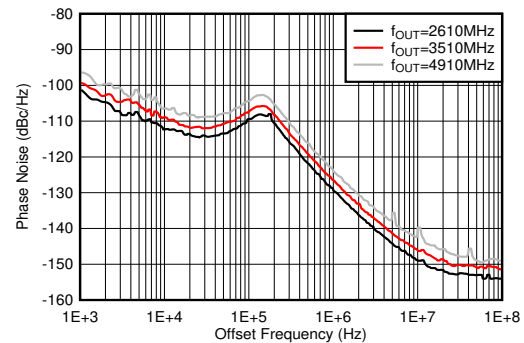
PLL enabled, $f_{VCO} = 8847.36$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-256. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



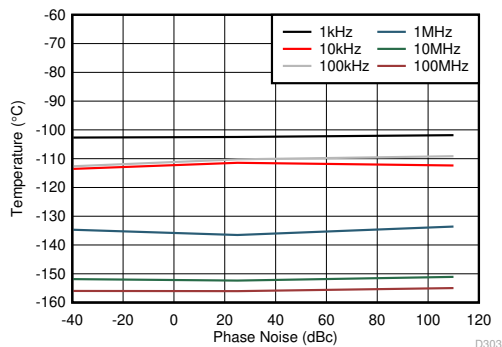
PLL enabled, $f_{VCO} = 8847.36$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-257. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at -40°C



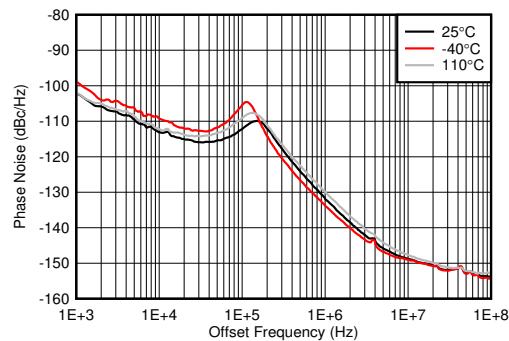
PLL enabled, $f_{VCO} = 8847.36$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-258. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at 110°C



PLL enabled, $f_{VCO} = 8847.36$ MHz, $f_{REF} = 491.52$ MSPS, minimum LPF BW, measured at 2TXOUT

图 6-259. Phase Noise for 9-GHz VCO vs Temperature Over Offset Frequency at $f_{OUT} = 2.6$ GHz



PLL enabled, $f_{VCO} = 7864.32$ MHz, $f_{REF} = 491.52$ MSPS, measured at 2TXOUT

图 6-260. Phase Noise for 8-GHz VCO vs Offset Frequency and Temperature at $f_{OUT} = 1910$ MHz

7 Device and Documentation Support

7.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

7.2 支持资源

TI E2E™ 支持论坛 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

7.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

7.4 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

7.5 术语表

TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

8 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
AFE7906IABJ	ACTIVE	FCBGA	ABJ	400	90	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 85	AFE7906I	Samples
AFE7906IALK	ACTIVE	FCBGA	ALK	400	90	Non-RoHS & Green	Call TI	Level-3-220C-168 HR	-40 to 85	AFE7906 SNPB	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

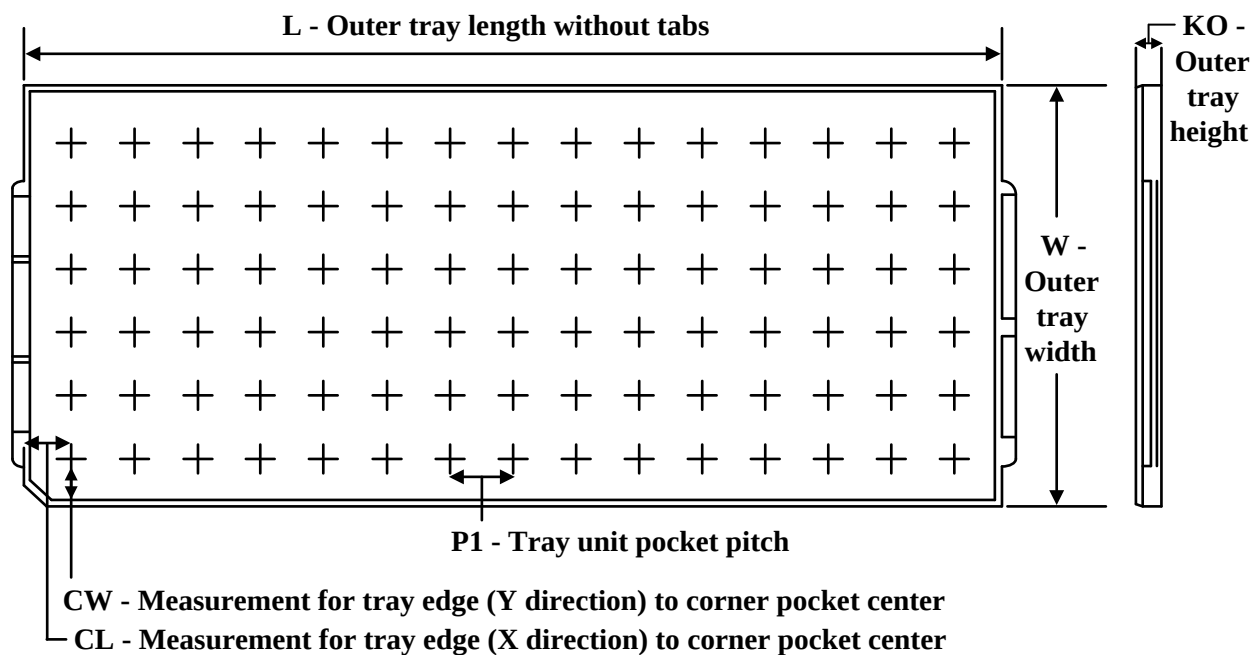
⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

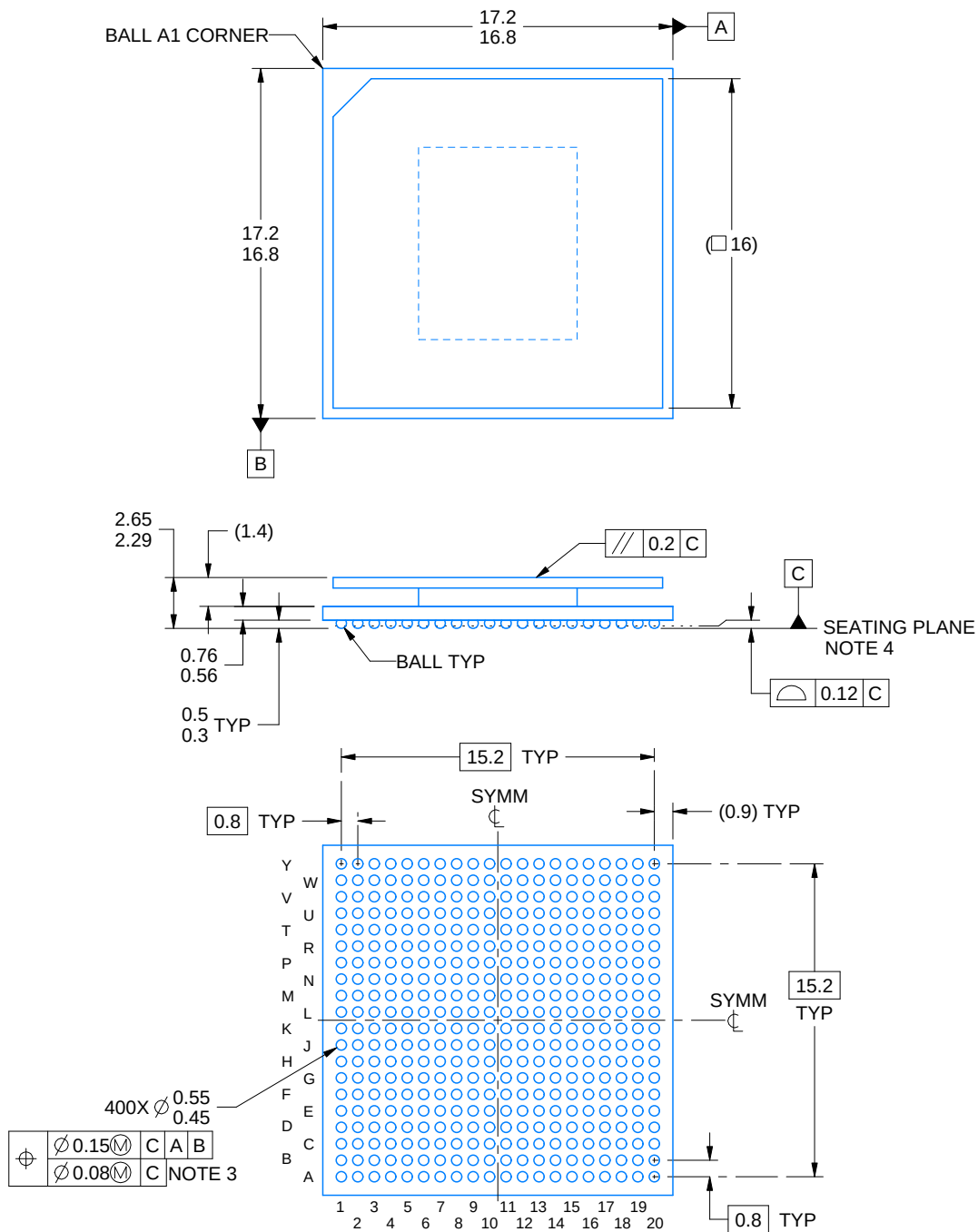
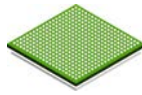
TRAY



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (μm)	P1 (mm)	CL (mm)	CW (mm)
AFE7906IABJ	ABJ	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7906IABJ	ABJ	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7906IALK	ALK	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7906IALK	ALK	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2



4221311/D 03/2023

NOTES:

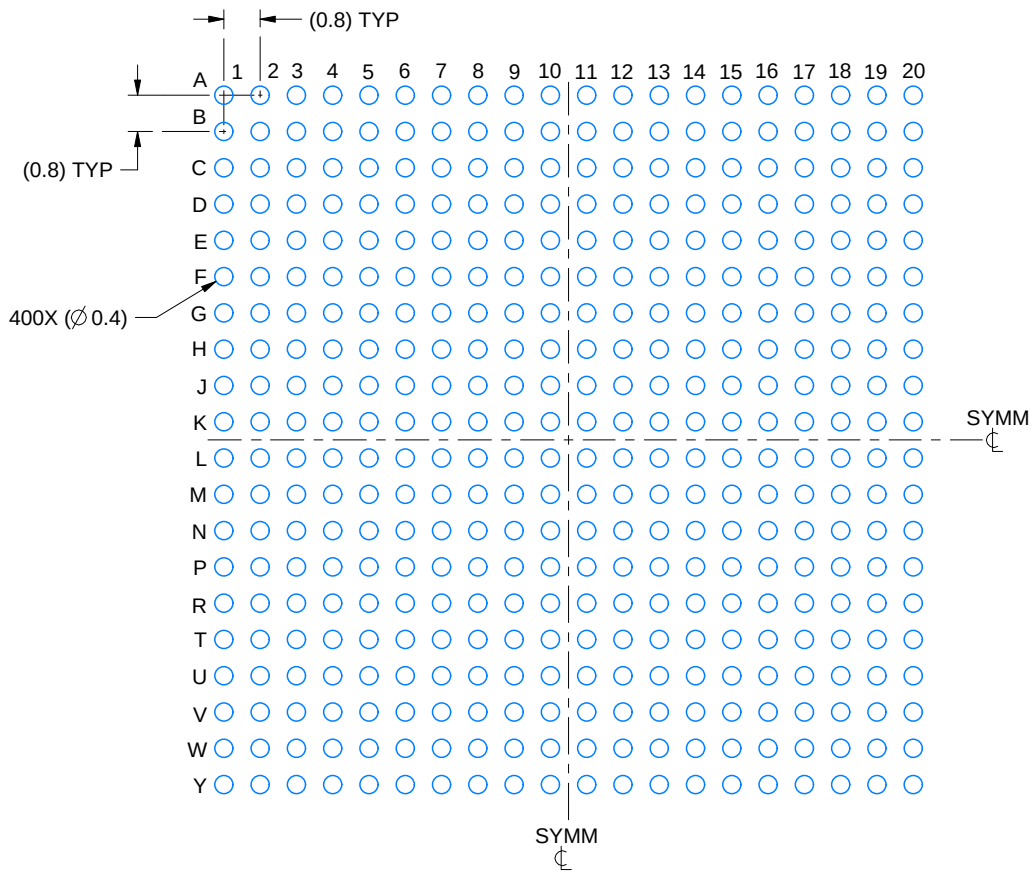
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Dimension is measured at the maximum solder ball diameter, parallel to primary datum C.
4. Primary datum C and seating plane are defined by the spherical crowns of the solder balls.
5. The lids are electrically floating (e.g. not tied to GND).

EXAMPLE BOARD LAYOUT

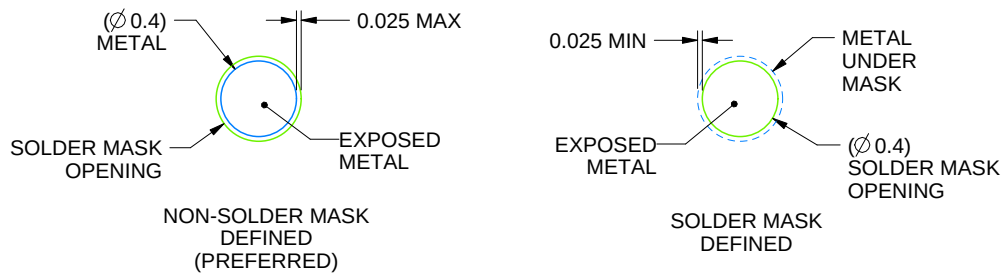
ABJ0400A

FCBGA - 2.65 mm max height

BALL GRID ARRAY



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



SOLDER MASK DETAILS
NOT TO SCALE

4221311/D 03/2023

NOTES: (continued)

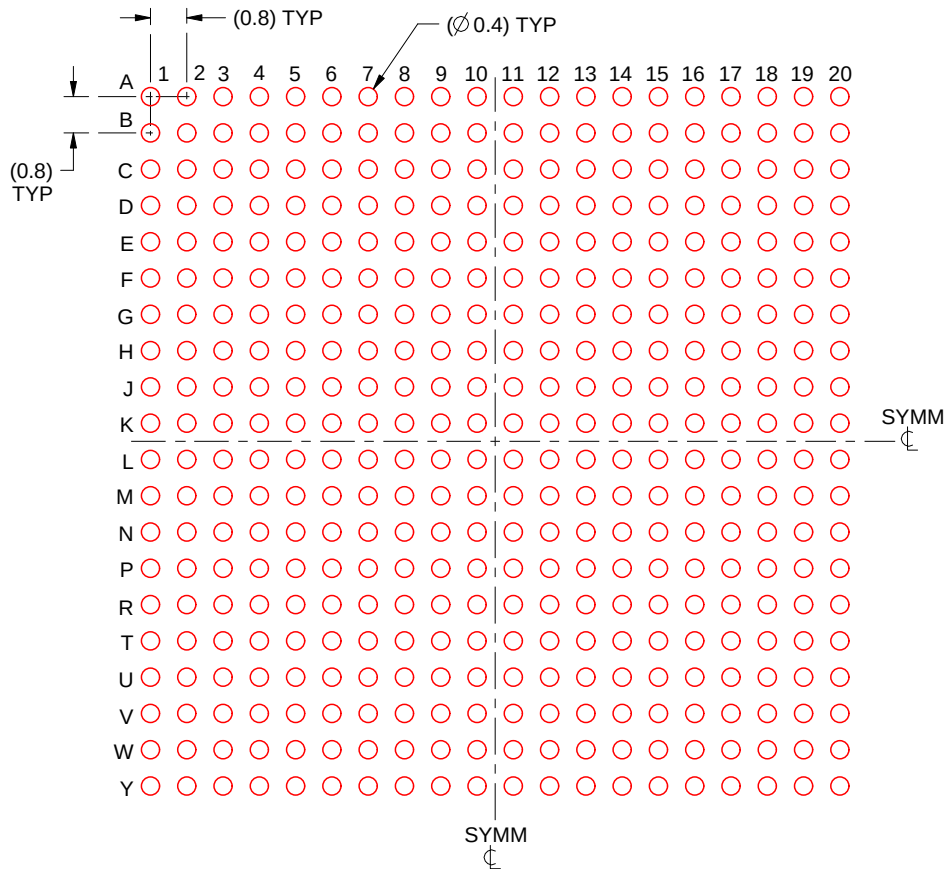
6. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SPRU811 (www.ti.com/lit/spru811).

EXAMPLE STENCIL DESIGN

ABJ0400A

FCBGA - 2.65 mm max height

BALL GRID ARRAY



SOLDER PASTE EXAMPLE
 BASED ON 0.15 mm THICK STENCIL
 SCALE:6X

4221311/D 03/2023

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

FCBGA - 2.65 mm max height

[illegible]

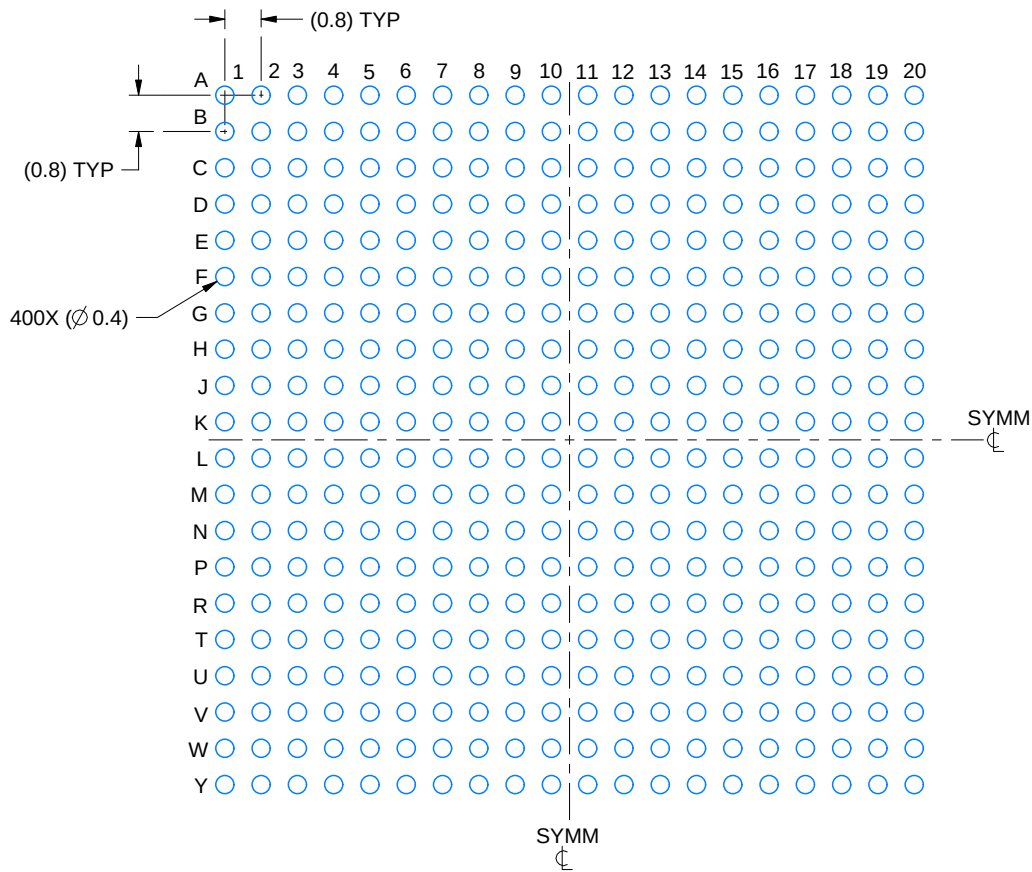
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Dimension is measured at the maximum solder ball diameter, parallel to primary datum C.
4. Primary datum C and seating plane are defined by the spherical crowns of the solder balls.
5. Pb-Free die bump and SnPb solder ball.
6. The lids are electrically floating (e.g. not tied to GND).

EXAMPLE BOARD LAYOUT

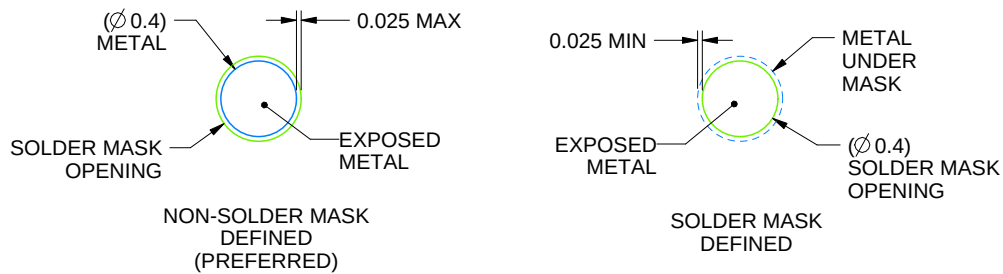
ALK0400A

FCBGA - 2.65 mm max height

BALL GRID ARRAY



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



SOLDER MASK DETAILS
NOT TO SCALE

4225930/C 03/2023

NOTES: (continued)

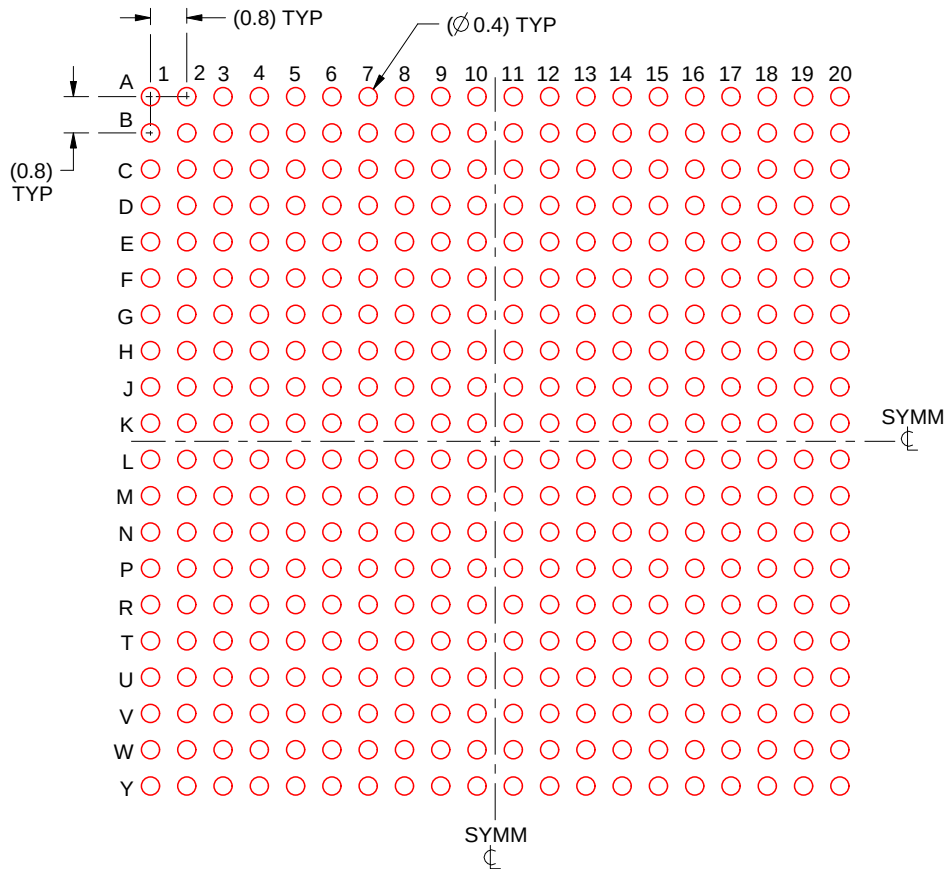
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SPRU811 (www.ti.com/lit/spru811).

EXAMPLE STENCIL DESIGN

ALK0400A

FCBGA - 2.65 mm max height

BALL GRID ARRAY



SOLDER PASTE EXAMPLE
 BASED ON 0.15 mm THICK STENCIL
 SCALE:6X

4225930/C 03/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

重要声明和免责声明

TI“按原样”提供技术和可靠性数据（包括数据表）、设计资源（包括参考设计）、应用或其他设计建议、网络工具、安全信息和其他资源，不保证没有瑕疵且不做任何明示或暗示的担保，包括但不限于对适销性、某特定用途方面的适用性或不侵犯任何第三方知识产权的暗示担保。

这些资源可供使用 TI 产品进行设计的熟练开发人员使用。您将自行承担以下全部责任：(1) 针对您的应用选择合适的 TI 产品，(2) 设计、验证并测试您的应用，(3) 确保您的应用满足相应标准以及任何其他功能安全、信息安全、监管或其他要求。

这些资源如有变更，恕不另行通知。TI 授权您仅可将这些资源用于研发本资源所述的 TI 产品的应用。严禁对这些资源进行其他复制或展示。您无权使用任何其他 TI 知识产权或任何第三方知识产权。您应全额赔偿因在这些资源的使用中对 TI 及其代表造成的任何索赔、损害、成本、损失和债务，TI 对此概不负责。

TI 提供的产品受 [TI 的销售条款](#) 或 [ti.com](#) 上其他适用条款/TI 产品随附的其他适用条款的约束。TI 提供这些资源并不会扩展或以其他方式更改 TI 针对 TI 产品发布的适用的担保或担保免责声明。

TI 反对并拒绝您可能提出的任何其他或不同的条款。

邮寄地址：Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2024，德州仪器 (TI) 公司